

18th INTERNATIONAL CONFERENCE ON NUCLEAR MICROPROBE TECHNOLOGY AND APPLICATIONS

11-16.09.2022

Ljubljana, Slovenia



BOOK of
ABSTRACTS

Title: Book of Abstracts, ICNMTA2022
Editors: Paula Pongrac, Pia Starič
Reviewer: Primož Pelicon, Esther Punzón Quijorna
Publisher: Jožef Stefan Institute
Logo Design: Pia Starič, Mitja Kelemen
Book of Abstract Design: Pia Starič
Place of Publication: Ljubljana, Slovenia
Year of Publication: 2022
Number of Editions: Electronic edition
Web site: <https://www.icnmta2022.org/en/default.asp>



International Advisory Committee

Philippe Barberet, France
David Jamieson, Australia
Aliz Simon, IAEA, Austria
Johnny F. Dias, Brazil
Hao Shen, China
Milko Jakšič, Croatia
Judith Reindl, Germany
Ettore Vittone, Italy
Teresa Pinheiro, Portugal
Katarina Vogel-Mikuš, Slovenia
M^a Dolores Ynsa, Spain
Rob Frost, Sweden
Roger Webb, United Kingdom
Melanie Bailey, United Kingdom
Gyorgy Vizkelethy, United States
Guanghua Du, China

Local Organizing Committee (Jožef Stefan Institute, Ljubljana, Slovenia):

Paula Pongrac (chair)
Primož Pelicon (co-chair)
Mitja Kelemen
Esther Punzón Quijorna
Klemen Bučar
Pia Starič
Primož Vavpetič
Žiga Barba
Kristina Isaković
Andrej Košiček
Matjaž Vencelj
Boštjan Jenčič
Mirjana Vasić
Mojca Gantar

Programme Committee

Richard Ortega, France
Victoria Corregidor, Portugal
Melanie Bailey, United Kingdom
Judith Reindl, Germany
Wataru Kada, Japan
Andrew A. Bettiol, Singapore
Iva Bogdanović-Radović, Croatia
David Jamieson, Australia
Jeroen van Kan, Singapore
Željko Pastuović, Australia

Kataložni zapis o publikaciji (CIP) pripravili v Narodni in univerzitetni knjižnici v Ljubljani
[COBISS.SI-ID 12225411](#)
ISBN 978-961-264-230-3 (PDF)

SPONSORS



RAYSPEC
X - RAY SPECTROSCOPY

 **Hakuto Co., Ltd.**

 **Canberra Packard** 

 **Instro** d.o.o.


Oxford Microbeams Ltd

Ionplus 
engineering scientific instruments

 **NATIONAL ELECTROSTATICS CORP.**

PFEIFFER  **VACUUM**



Mestna občina
Ljubljana



 **Jožef Stefan Institute**

PROGRAMME

11 SEPTEMBER, SUNDAY

18.00-21.00 Registration and Reception – IJS Lecture hall, Jamova cesta 39

SCIENTIFIC PROGRAMME

12 SEPTEMBER, MONDAY

IJS Lecture hall, Jamova cesta 39

08.00-09.00 Registration

09.00-09.15 Welcome Address

09.15-10.30 Session: Instrumentation I

09.15-09.45 Invited I: Dou Yanxin (1081)

09.45-10.00 Contributed I: Vladimir Palitsin (1022)

10.00-10.15 Contributed II: Gyula Nagy (1030)

10.15-10.30 Contributed III: Robert J. W. Frost (1010)

10.30-11.00 Coffee Break

11.00-12.30 Session: Environment and Cultural Heritage

11.00-11.30 Invited I: Lorenzo Guintini (1067)

11.30-11.45 Contributed I: Maria Dolores Ynsa (1019)

11.45-12.00 Contributed II: Marta Magalini (1056)

12.00-12.15 Conference Photo

12.15-13.30 Lunch

13.30-15.15 Session: Life Sciences

13.30-14.00 Invited I: Geoffrey W. Grime (1020)

14.00-14.30 Invited II: Tilo Reinert (1106)

14.30-14.45 Contributed I: Richard Ortega (1003)

14.45-15.00 Contributed II: Henrique Fonteles (1007)

15.00-15.15 Contributed III: Harry J. Whitlow (1044)

15.15-15.45 Coffee Break

15.45-17.00 Instrumentation II

15.45-16.15 Invited II: Victoria Corregidor (1090)

16.15-16.30 Contributed IV: Barney Doyle (1112)

16.30-16.45 Contributed V: Gary A. Glass (1098)

16.45-17.00 Contributed VI: Kristina Isaković (1048)

18.00-19.00 Visit Ljubljana (in front of Ljubljana Turistic Information Centre,
Adamič-Lundrovo nabrežje 2, Ljubljana)

19.00-20.00 Reception in a City Hall (Mestni trg 1, Ljubljana)

IJS Lecture hall, Jamova cesta 39

08.00-09.00 Registration

09.00-10.30 Session: Radiation Biology

- 09.00-09.30 Invited I: Tim Schneider (1111)
- 09.30-09.45 Contributed I: Sarah Rudgikeit (1008)
- 09.45-10.00 Contributed II: Pierre Beaudier (1031)
- 10.00-10.15 Contributed III: Teresa Pinheiro (1036)
- 10.15-10.30 Contributed IV: Ce-Belle Chen (1041)
- 10.30-11.00 Coffee Break

11.00-12.00 Session: MeV-SIMS

- 11.00-11.30 Invited I: Zdravko Siketić (1028)
- 11.30-11.45 Contributed I: Boštjan Jenčič (1102)
- 11.45-12.00 Contributed II: Toshio Seki (1105)
- 12.00-13.30 Lunch

13.30-14.30 Session: Quantum Technologies

- 13.30-14.00 Invited I: Andrew A. Bettiol (1110)
- 14.00-14.15 Contributed I: Paul Räche (1063)
- 14.15-14.30 Contributed II: Nicholas Collins (1072)
- 14.30-17.00 Posters I
- 18.30 Public Lecture: Geoffrey W. Grime (Ljubljana Town Hall)
- 20.00 IAC & PC meeting (Skuhna, Trubarjeva 56, Ljubljana)

IJS Lecture hall, Jamova cesta 39

08.00-09.00 Registration

09.00-10.30 Session: Multimodal Imaging

09.00-09.30 Invited I: Iva Bogdanovič Radovič (1100)

09.30-09.45 Contributed I: Melanie Bailey (1018)

09.45-10.00 Contributed II: Catia Costa (1001)

10.00-10.15 Contributed III: Ebrahim Golami Hatam (1026)

10.15-10.30 Contributed IV: Marjana Regvar (1082)

10.30-11.00 Coffee Break

11.00-12.30 Session: Detectors

11.00-11.30 Invited I: Marco Petasecca (1035)

11.30-11.45 Contributed I: Greta Andrini (1004)

11.45-12.00 Contributed II: Ettore Vittone (1032)

12.00-12.15 Contributed IV: Andreo Crnjac (1062)

12.30-13.30 Lunch

13.30- Excursion to Postojna Cave and Predjama Castle

IJS Lecture hall, Jamova cesta 39

09.00-10.30 Session: Instrumentation III

- 09.00-09.30 Invited I: Shigeo Matsuyama (1096)
09.30-09.45 Contributed VII: Georgios Provas (1087)
09.45-10.00 Contributed VIII: Hongjin Mou (1011)
10.00-10.15 Contributed IX: Iva Božičević Mihalić (1089)
10.15-10.30 Contributed X: Žiga Šmit (1045)
10.30-11.00 Coffee Break

11.00-12.30 Session: Space

- 11.00-11.30 Invited I: Jafar Shojaii (1047)
11.30-12.00 Invited II: Guanghua Du (1084)
12.00-12.15 Contributed I: Željko Pastuović (1038)
12.15-12.30 Contributed II: Stefania Peracchi (1075)
12.30-13.30 Lunch
13.30-15.00 Round Table I (Kolarjeva Lecture Room): Geoffrey W. Grime: Data Acquisition
Round Table II (IPS Lecture Room): Željko Pastuović: High Precision Irradiation, Single Ion Detection
15.00-17.30 Posters II
17.30- Conference Gala Dinner (Grad Otočec, Grajska cesta 2, Otočec)

IJS Lecture hall, Jamova cesta 39

09.00-10.30 Session: Micromodifications

- 09.00-09.30 Invited: Jeroen Van Kan (1113)
- 09.30-09.45 Contributed I: Gyorgy Vizkelethy (1027)
- 09.45-10.00 Contributed II: Hidetaka Hayashi (1034)
- 10.00-10.15 Contributed III: Anusmita Chakravorty (1068)
- 10.15-10.30 Contributed IV: Guangbo Mao (1092)
- 10.30-11.00 Coffee Break
- 11.00-11.30 Invited: Johnny F. Dias: Conference Summary and Highlights
- 11.30-11.45 Award Ceremony
- 11.45-12.00 Concluding remarks
- 14.00-16.00 Lab Visit

CONTENT

Programme for Monday, September 12	
Session 1: Instrumentation I	11
Session 2: Environment and Cultural Heritage	15
Session 3: Life Sciences	18
Session 4: Instrumentation II	23
Programme for Tuesday, September 13	
Session 1: Radiation Biology	27
Session 2: MeV-SIMS	32
Session 3: Quantum Technologies	35
Poster Session I	38
Public Lecture: Geoffrey W. Grime	65
Programme for Wednesday, September 14	
Session 1: Multimodal Imaging	64
Session 2: Detectors	71
Programme for Thursday, September 15	
Session 1: Instrumentation III	75
Session 2: Space	80
Poster Session II	84
Programme for Friday, September 16	
Session 1: Micromodifications	104
Sponsors	109

INSTRUMENTATION I

Chairs: Andrew A. Bettiol and Klemen Bučar

Invited talk

1081

The Singapore quadruplet: a focusing lens configuration for high resolution nuclear microscopyYanxin Dou^{1,2}, Thomas Osipowicz¹, Jeroen Anton van Kan¹¹ Centre for Ion Beam Applications, Department of Physics, National University of Singapore, Singapore² Singapore Nuclear Research and Safety Initiative, National University of Singapore, Singaporedouyanxinch@163.com

Beam optics of a focusing lens configuration plays a key role in determining the performance of a nuclear microscope system. However, only a few focusing lens configurations were shown to be capable to reach resolutions smaller than 200 nm [1-3]. Here, we propose a quadrupole lens configuration (namely the Singapore quadruplet) with high resolutions. Results of numerical studies of this beam optics designs are presented, using the FANM software [4], and a comparison of the Singapore quadruplet and other typical configurations is shown in this work. Preliminary experimental results of the Singapore quadruplet configuration are discussed, with a resolution of $80 \times 130 \text{ nm}^2$.

- [1] Watt F, Van Kan J A, Rajta I, et al. The National University of Singapore high energy ion nano-probe facility: Performance tests[J]. Nuclear Instruments and Methods in Physics Research Section B: Beam Interactions with Materials and Atoms, 2003, 210: 14-20.
- [2] Jamieson D N. New generation nuclear microprobe systems. Nuclear Instruments and Methods in Physics Research Section B: Beam Interactions with Materials and Atoms, 2001, 181(1-4): 1-11.
- [3] Spemann D, Reinert T, Vogt J, et al. Materials analysis and modification at LIPSION—Present state and future developments[J]. Nuclear Instruments and Methods in Physics Research Section B: Beam Interactions with Materials and Atoms, 2011, 269(20): 2175-2179.
- [4] Dou Y, van Kan J A. FANM: A software for focus and aberrations of nuclear microprobe[J]. Ultramicroscopy, 2021, 220: 113163.

1022

Recent developments on the micro-PIXE beamline at the University of Surrey Ion Beam Centre

Vladimir Palitsin¹, Catia Costa¹, Pierre Couture¹, Roger Webb¹, Geoffrey Grime¹

¹ *University of Surrey, Ion Beam Centre Guildford, United Kingdom*

v.palitsin@surrey.ac.uk

The microbeam line at the University of Surrey Ion Beam Centre has been a key resource supporting the analytical activities of the Centre for two decades. The beamline has recently been upgraded to provide significant enhancements in performance and ease of use. These include the use of a spaced quadrupole triplet configuration using object and collimator apertures mounted on motorised ladders and a high stability piezo-electric sample stage with rapid-access zero loading force sample holders.

The tantalum object apertures are fabricated using a combination of wire erosion and FIB polishing to provide a high-quality low scattering finish. The sample stage incorporates a vertical axis of rotation which will allow us to explore new characterisation methods such as topographic imaging using stereoscopic pairs, 3-D imaging using IBA-tomography and depth profiling using multiple-angle PIXE.

This presentation describes the new features. Illustrative results obtained using the new beamline will be presented.

1030

Present status of the Uppsala scanning nuclear microprobe

Gyula Nagy¹, Harry J. Whitlow², Daniel Primetzhofer^{1,2}

¹ Department of Physics and Astronomy, Uppsala University, Box 516, S-751 20 Uppsala, Sweden

² Tandem Laboratory, Uppsala University, Box 529, S-751 21 Uppsala, Sweden

gyula.nagy@physics.uu.se

In this presentation we give a status report about the Uppsala scanning nuclear microprobe, as well as an overview of some recent applications. As a prominent example, we demonstrated the capability of Elastic Backscattering Spectrometry (μ -EBS) to non-destructively depth-profile the elemental composition of intact MOF (Metal-Organic Framework) single crystals [1].

Besides the applications, we also give an overview about the status of the microprobe facility from a technical point of view. The Uppsala scanning nuclear microprobe, named SLIM-UP (Scanning Light Ion Microprobe in Uppsala), was originally installed in The Svedberg Laboratory, Uppsala University, during 1989/90 [2]. The main components of the facility, i.e. the object forming apertures, collimator apertures, magnetic deflection unit, probe forming quadrupole lenses and magnet driving power supplies were the first ones that were sold by Oxford Microbeams Ltd. Since then, the microprobe has undergone several minor and major modifications. The present configuration is a rebuild of the SLIM-UP, now attached to the 5 MV tandem pelletron accelerator (NEC) of the Tandem Laboratory, at the Ångström Laboratory, Uppsala University. We present a detailed description of the components, the most recent technical developments, as well as the most recent performance tests.



Figure 1: The Uppsala scanning nuclear microprobe.

[1] B. D. McCarthy et al., J. Am. Chem. Soc. 143 (2021) 18626-18634. doi: <https://doi.org/10.1021/jacs.1c08550>

[2] T. Sunde, J. Nyström, U. Lindh, NIM B 54 (1991) 80-83. doi: [https://doi.org/10.1016/0168-583X\(91\)95495-Y](https://doi.org/10.1016/0168-583X(91)95495-Y)

1010

A study of luminescent materials for application in the beam imaging system at the ESS

C. Thomas¹, R.J.W. Frost², R. Johansson¹, M. Hartl¹, K. Michel¹, H. Kocevar¹, M. Elfman², S. Joshi³, S. Björklund³

¹ Accelerator Division, European Spallation Source, Lund, Sweden

² Department of Physics, Lund University, Lund, Sweden

³ Department of Engineering Science, University West, Trollhättan, Sweden

robert.frost@nuclear.lu.se

Scintillating screens are frequently used in the diagnostic systems of particle accelerators [1]. The European Spallation Source [2], will incorporate a linear accelerator which will accelerate protons up to 2 GeV with an average power of 5 MW. The beam imaging system is therefore critical for the safe operation of the accelerator, ensuring the beam delivered to the target is always within its nominal envelope. As part of the development of the beam imaging system [3] luminescent screens have been fabricated from Al₂O₃:Cr and YAG:Ce; these materials being common to the diagnostic systems of other high-energy accelerators [4]. In order to evaluate the lifetime of the luminescent screens, and thus qualify them for production, the screens will be irradiated at the Nuclear Applications Laboratory, Lund University. Irradiation will be performed using a 3 MV Pelletron accelerator, with a proton beam of 2.5 MeV energy and a current of 1 μA. The objective of the irradiation is to measure the lifetime of the luminescence as function of the proton dose measured with the total charge received by the samples.

[1] B. Walasek-Höhne and G. Kube, Scintillating screen applications in beam diagnostics, Proceedings of DIPAC2011, Hamburg, Germany, 2011, pp. 533–557.

[2] Source European Spallation Source ERIC, Box 176, SE-221 00, Lund, Sweden. <https://europeanspallationsource.se>.

[3] M.G. Ibison, C.P. Welsch, E. Adli, H. Gjersdal, G. Christoforo, T. Shea, C. Thomas and D. Naeem, Development of a beam imaging system for the European spallation source tuning dump, Nuclear Instruments and Methods in Physics Research Section A 950 (2020), 162790. doi:10.1016/j.nima.2019.162790.

[4] K. Renuka, W. Ensinger, C. Andre, F. Becker, P. Forck, R. Haseitl, A. Reiter and B. Walasek-Höhne, Transverse beam profile monitoring using scintillation screens for high energy ion beams, Proceedings of BIW2012, Newport News, VA USA, 2012, pp. 183–185.

ENVIRONMENT AND CULTURAL HERITAGE

Chairs: Gastón García López and Žiga Šmit

Invited talk

1067

Status of the MACHINA project, the Movable Accelerator for Cultural Heritage In-situ Non-destructive Analysis

Francesco Taccetti^{1,2}, [Lorenzo Giuntini](mailto:giuntini@fi.infn.it)^{1,2}, Lisa Castelli¹, Giulia Calzolari¹, Massimo Chiari¹, Caroline Czelusniak¹, Mariaelena Fedi¹, Mirko Massi¹, Pier Andrea Mandò^{1,2}, e Mathot³, Giovanni Anelli³, Alexej Grudiev³, Alessandra Lombardi³, Eric Montesinos³, Maurizio Vretenar³

¹ *Istituto Nazionale di Fisica Nucleare, Sezione di Firenze, 50019 Sesto Fiorentino, Italy*

² *Department of Physics and Astrophysics, University of Florence, 50019 Sesto Fiorentino, Italy*

³ *CERN–European Organization for Nuclear Research, CH-1211 Geneva 23, Switzerland*

giuntini@fi.infn.it

As it is well known, over the years, we have seen an ever-growing request need for in-situ compositional analyses in the field of Cultural Heritage. Ion Beam Analyses constitute a set of powerful techniques able to provide rich insight into samples. They are most often based on the use of MeV ion beams produced by a particle accelerator. This has limited the number of applications of IBA techniques to Cultural Heritage (CH) problems because, in the vast majority of the cases, artworks are hard to move to accelerator laboratories and no transportable accelerator has been developed so far.

To overcome this limitation, the Italian National Institute for Nuclear Physics (INFN) and the European Organization for Nuclear Research (CERN) have jointly started the MACHINA (Movable Accelerator for Cultural Heritage In-situ Non-destructive Analyses) project for the development of a transportable accelerator system.

The MACHINA project, started at the beginning of 2018 is now in its final stage and first test applications are scheduled for the end of this year, notwithstanding the COVID-19 pandemic and all the connected problems.

After a brief overview of the MACHINA project, we will discuss its evolution from the beginning to present, pointing out problems and results. Expected future activities will close the presentation.

1019

Micro-PIXE analysis of metal archaeological pieces of Torre Monreal necropolis

Silvia Viñals¹, Maria Dolores Ynsa¹, Andres Redondo¹, Rita Pestana², Berta Balduz³, Victoria Corregidor⁴, Joaquin Barrio⁵

¹ *Universidad Autónoma de Madrid Centro de Microanálisis de Materiales Madrid-Spain*

² *Universidade de Lisboa Departamento de Física Lisboa-Portugal*

³ *Gobierno de Navarra Institución Príncipe de Viana Pamplona-Spain*

⁴ *Universidade de Lisboa Centro de Ciências e Tecnologias Nucleares Lisboa-Portugal*

⁵ *Universidad Autónoma de Madrid SECYR. Dpto. Prehistoria y Arqueología Madrid-Spain*

m.ynsa@uam.es

In 2019, the Torre Monreal necropolis was discovered in the urban centre of Tudela, in the north of Spain (Navarra). This Islamic necropolis has a great amount of graves with rich funeral's dowrys, therefore it is of a high archaeological and historical interest. In this work, in order to determine the elemental concentration, different objects, mainly metallic pieces, such as rings, earrings, necklaces, belt buckles, etc. have been analysed by Particle Induced X-ray Emission (PIXE) using the external microbeam line at CMAM (Centro de Microanálisis de Materiales in Madrid). Most of the metallic objects with a gilded look exhibit Au concentrations higher than 50 %, Ag and Hg levels close to 20 %, and low or trace concentrations of other elements such as Cu or Fe. The glass settings of the rings were also analysed. The elemental contents of these pieces have been compared with the other Islamic piece concentrations corresponding to the same historic period, XIII – XIV century, such as those from Calatrava la Vieja collection.

1056

Improving the protocol for provenance determination of lapis lazuli with new analyses on samples from Myanmar

Laura Guidorzi¹, Marta Magalini², Alessandro Re², Alessandro Lo Giudice², Fulvio Fantino³, Alessandro Borghi⁴, Gloria Vaggelli⁵, Matteo Campostrini⁶, Valentino Rigato⁶, Quentin Lemasson⁷, Laurent Pichon⁷, Claire Pacheco⁷, Brice Moignard⁷

¹ INFN - sezione di Torino Physics Torino-Italy

³ University of Torino Physics Torino-Italy ² Independent researcher / Torino-Italy

⁴ University of Torino Earth Sciences Torino-Italy

⁵ CNR - Istituto di Geoscienze e Georisorse / Torino-Italy

⁶ INFN-LNL / Padova-Italy

⁷ Centre de Recherche et de Restauration des Musées de France / Paris-France

marta.magalini@unito.it

Although the historical source for lapis lazuli used in antiquity is commonly known to be the Badakhshan Province (Afghanistan), other hypotheses have been suggested and their confirmation on a scientific basis could be of uttermost importance for the knowledge of ancient trade routes. In the last years, our group have proposed and successfully applied to lapis lazuli objects a protocol to identify the provenance of the raw material by means of a micro-analytical non-invasive methodology [1]. The analytical protocol is mainly based on a comparison of the physico-chemical properties of rocks of known provenance with archaeological finds and historical objects, obtained by means of Ion Beam Analysis (IBA) techniques. In particular, micro-PIXE and micro-ionoluminescence (IL) were used to detect trace elements and characteristic luminescence of some rock-forming minerals in lapis lazuli, specifically diopside, wollastonite and pyrite. The micro-scale of the beam is needed for the micrometric size of the crystals under investigation. The protocol includes so far Afghan, Tajik, Siberian and Chilean provenances.

12 lapis lazuli rock samples were recently acquired in situ from Myanmar. Prepared as semi-thin sections (ca. 100 μm), they have been primarily characterized via petrographic and SEM-EDX analyses [2]. The samples have been now investigated with IBA and measurements were carried out on 28 diopside and 7 pyrite crystals. The analyses have been performed both in vacuum at INFN-LNL (Legnaro, Padova, Italy) with 2 MeV protons and with extracted beam at NewAGLAE (Paris, France) using 3 MeV protons. Moreover, calcite and K-feldspar have been recently taken into consideration as new mineral phases to improve the discrimination among Afghan, Tajik and Myanmar provenances.

Micro-IBA investigations allowed to determine similarities and differences of Myanmar samples with respect to other provenances. An updated analytical protocol is proposed to include all five lapis lazuli origins.

[1] Lo Giudice, A. et al. (2017) Protocol for lapis lazuli provenance determination: evidence for an Afghan origin of the stones used for ancient carved artefacts kept at the Egyptian Museum of Florence (Italy). *Archaeological and Anthropological Sciences* 9:637-651. doi: 10.1007/s12520-016-0430-0

[2] Vaggelli G. et al. (2019) Improvements to the analytical protocol of lapis lazuli provenance: First study on Myanmar rock samples. *European Physical Journal Plus* 134:104. doi: 10.1140/epjp/i2019-12523-4

LIFE SCIENCES

Chairs: Katarina Vogel-Mikuš and Philippe Barberet

Invited talk I

1020

The identification and quantitation of metal atoms in proteins using microPIXE: a critical evaluationGeoffrey Grime¹, Elspeth Garman²¹ *University of Surrey, Ion Beam Centre, Guildford, United Kingdom*² *University of Oxford, Department of Biochemistry, Oxford, United Kingdom*g.grime@surrey.ac.uk

Around 30% of all known protein molecules contain a small number of metal atoms as part their structure which are often crucial to the biological function of the molecule. Identifying and quantifying these is not possible using commonly available analysis tools and there is a growing awareness that a majority of the metal atoms in the over 30,000 metalloprotein structures deposited in the Protein Data Bank [1] are misidentified, with major consequences for the interpretation of protein function and mechanism [2,3]. In the 1990s the authors developed a method for the identification and quantification of metals in proteins by combining micro-PIXE and RBS. This has been used to solve many problems in structural biology and has recently been extended to provide high throughput capability [3].

In this contribution we will present some recent results illustrating the power of this method to answer biological questions. We will also give an overview of the methodology and provide a critical evaluation of accuracy, precision and detection limit. Our evaluation will provide guidance on optimisation of sample preparation and analysis conditions for these measurements.

[1] H.M. Berman, K. Henrick, H. Nakamura Announcing the worldwide Protein Data Bank *Nature Structural Biology* 10 (12) (2003) 980

[2] E.F. Garman, G.W. Grime, Elemental analysis of proteins by microPIXE, *Progress in Biophysics and Molecular Biology* 89/2, (2005) 173

[3] G.W. Grime, O.B. Zeldin, M.E. Snell, E.D. Lowe, J.F. Hunt, G.T. Montelione, L. Tong, E.H. Snell, E.F. Garman. High-throughput PIXE as an essential quantitative assay for accurate metalloprotein structural analysis; development and application. *J. Am. Chem. Soc.*, 142 (2020) 185

1106

MicroPIXE and the Iron in the Brain

Tilo Reinert^{1,2}, Malte Brammerloh¹, Carsten Jäger¹, Jan Meijer³, Primož Vavpetič⁴, Primož Pelicon⁴, Nikolaus Weiskopf¹, Markus Morawski², Evgeniya Kirilina¹

¹ Max Planck Institute for Human Cognitive and Brain Sciences, Dept. of Neurophysics, Leipzig, Germany

² University of Leipzig, Paul Flechsig Institute of Brain Research, Leipzig, Germany

³ University of Leipzig, Felix Bloch Institute for Solid State Physics, Leipzig, Germany

⁴ Jožef Stefan Institute, Dept. of Low and Medium Energy Physics, Ljubljana, Slovenia

treinert@cbs.mpg.de

Iron in the brain is still the iron in the fire for a large part of the neuroscience community. One knows for what it is good for: Cellular energy metabolism, axonal myelination, or neurotransmitter synthesis. On the other hand, iron has also its bad side: If the cellular physiological processes can no longer safely handle iron, it will produce oxidative stress and a continuous iron overload condition may lead to neurodegeneration. Therefore, the challenge is to develop methods to analyze and quantify the distribution of iron in the brain, from the sub-cellular to the regional scale and of course all in 3D and in vivo to understand, diagnose and fight neurodegenerative diseases. Here is where microPIXE and MRI (magnetic resonance imaging) come together. MicroPIXE serves as ground-truth method for MRI-based iron-sensitive imaging and iron quantification. However, due to low data acquisition rates, microPIXE has longtime suffered from low sample throughput, which in turn reduces the statistical power of the analytical results. Additionally, the in situ analysis of neurons and glia cells in brain sections is affected by the partial volume effect or overlapping cells.

Based on a study on the iron distribution in the human substantia nigra, this presentation will discuss the pitfalls and uncertainties of the quantification of brain iron by microPIXE, the advantage of large efficiency X-ray detection systems and demonstrate how microPIXE contributes to the development of a biophysical model that allows the assessment of the iron content and neuronal density in the substantia nigra from MRI relaxation rates.

1003

How PIXE analysis of infant formulas contributed to the re-establishment of a WHO drinking water guideline for manganese

Erika J. Mitchell¹, Seth H. Frisbie², Stephane Roudeau³, Asuncion Carmona³, [Richard Ortega](mailto:richard.ortega@u-bordeaux.fr)³

¹ *Better Life Laboratories, Incorporated, East Calais, VT, USA*

² *Department of Chemistry and Biochemistry, Norwich University, Northfield, VT, USA*

³ *University of Bordeaux, CNRS, LP2I Bordeaux, UMR 5797, F-33170 Gradignan, France*

richard.ortega@u-bordeaux.fr

A large body of recent research clearly shows that excess manganese (Mn) exposure is associated with neurological disorders in young children. This includes impaired cognitive development, lower IQ or intelligence scores, increased risk of attention deficit hyperactivity disorder (ADHD), and other cognitive and behavior problems. In response, the World Health Organization (WHO) recently established a guideline for Mn in drinking water to protect infants from excess Mn in reconstituted infant formula [1, 2], based in part on our work [3-5].

We measured the concentrations of Mn in 44 infant formulas and young child nutritional beverages from the United States (US) and France markets using PIXE (Particle Induced X-ray Emission). Micro-PIXE analyses were performed at LP2iB using a 3 MeV proton beam to quantify Mn. Rutherford backscattering spectrometry (RBS) was carried out simultaneously to quantify the sample matrix. Our results suggest that these products contain up to 1,000 times the Mn concentration of breast milk and sometimes exceed internationally recognized tolerable intakes for Mn exposure. Moreover, an additional risk comes from the Mn in the drinking water that is used to reconstitute infant formula. It is very likely that many children from many countries have a great and avoidable risk of neurological impairment from ingesting these products.

The WHO re-established its discontinued guideline for Mn in drinking water in March 2022, with a provisional guideline value of 80 µg/L for total Mn 'to be protective against neurological effects in the most sensitive subpopulation – bottle-fed infants – and consequently the general population' [1]. This new provisional guideline value is a very important first step to ensure public health, especially for infants, who are sensitive to neurodevelopmental harm from exposure to excess Mn. The next step is to directly regulate the Mn content of infant formulas which to date is not subject to recommended maximum values.

[1] World Health Organization. Guidelines for drinking-water quality: Fourth edition incorporating the first and second addenda, WHO, 2022.

[2] Manganese in drinking-water. Background document for development of WHO Guidelines for drinking-water quality. WHO/HEP/ECH/WSH/2021.5, 2021.

[3] Frisbie S.H., Mitchell E.J., Roudeau S., Domart F., Carmona A., Ortega R. (2019) Manganese levels in infant formula and young child nutritional beverages in the United States and France: comparison to breast milk and regulations. *PLoS ONE*, 14(11): e0223636. doi: 10.1371/journal.pone.0223636

[4] Mitchell E.J., Frisbie S.H., Roudeau S., Carmona A., Ortega R. (2020) Estimating daily intakes of manganese due to breast milk, infant formulas, or young child nutritional beverages in the United States and France: Comparison to sufficiency and toxicity thresholds. *Journal of Trace Elements in Medicine and Biology*, 62, 126607. doi: 10.1016/j.jtemb.2020.126607

[5] Mitchell E.J., Frisbie S.H., Roudeau S., Carmona A., Ortega R. (2021) How much manganese is safe for infants? A review of the scientific basis of intake guidelines and regulations relevant to the manganese content of infant formulas. *Journal of Trace Elements in Medicine and Biology*, 65, 126710. doi: 10.1016/j.jtemb.2020.126710

1007

Imaging and Analysis of Human Glioblastoma U87 Cells Treated with Cisplatin by μ -PIXE

Henrique Fonteles¹, Pedro Luis Grande¹, Johnny Ferraz Dias¹, Deiverti Bauer¹, Julia Marcolion², Karine Begnini², Guido Lenz²

¹ Ion Implantation Laboratory, UFRGS, Porto Alegre, Brazil

² Cell Signaling Laboratory, UFRGS, Porto Alegre, Brazil

fonteleshenrique@gmail.com

The study of chemotherapy drug's properties plays a vital role in the development of new cancer-related treatments and the improvement of those currently in use. Cisplatin ($\text{Pt}(\text{NH}_3)_2\text{Cl}_2$) and other platinum-based drugs are widely used medications that treat several different cancers, including, but not limited to, ovarian, testicular, and neck, among others [1].

The present work investigated the interaction of cisplatin with human glioblastoma U87 cells. Cells were treated with cisplatin at a concentration of 10, 20, and 100 μM for 24h. The analysis was done using the μ -PIXE technique, with a 2.2 MeV proton beam of $1.2 \times 1.2 \mu\text{m}^2$ spot size, which gives us elemental information about the sample and allows us to create 2D maps with micrometric spatial resolution. By measuring the chlorine and platinum signals, we were able to identify individual cells in the sample and detect which ones had a greater cisplatin uptake, respectively. The study of the drug's uptake is crucial for understanding the mechanisms of resistance that are involved in the cisplatin interaction with cancer cells. Moreover, we noticed that the 100 μM sample had a high iron signal correlating with the platinum signal, which was not present at lower treatment concentrations. This result could be a piece of evidence for ferroptosis, i.e. a type of iron-dependant cell death completely independent from regular apoptosis. Recent studies have already shown that cisplatin can induce ferroptosis in high treatment concentrations [2].

All experiments were conducted at the Ion Implantation Laboratory with a 3MV Tandem accelerator. This work also highlighted the versatility of the μ -PIXE technique and how it can be used to perform interdisciplinary analysis.

[1] Galanski M. (2006). Recent developments in the field of anticancer platinum complexes. Recent patents on anti-cancer drug discovery, 1(2), 285–295. doi: 10.2174/157489206777442287

[2] Guo, J., Xu, B., Han, Q., Zhou, H., Xia, Y., Gong, C., Dai, X., Li, Z., & Wu, G. (2018). Ferroptosis: A Novel Anti-tumor Action for Cisplatin. Cancer research and treatment, 50(2), 445–460. doi: 10.4143/crt.2016.57

1044

Measurement of Ca sequestration molarities in simian nasal mucosa with a MeV ion microprobeHarry J. Whitlow¹, Nicholas Henderson², Richard Greco², Naresh Deoli³, Karen M. Smith⁴, Karen Morgan⁵, François Villinger⁵¹ *University of Oslo Department of Physics Oslo-Norway*² *University of Louisiana at Lafayette Louisiana Accelerator Center Lafayette-*³ *Columbia University, Center for Radiological Research New York-United States*⁴ *University of Louisiana at Lafayette Department of Biology Lafayette-*⁵ *University of Louisiana at Lafayette New Iberia Research Center New Iberia-United States*h.j.whitlow@fys.uio.no

Ca²⁺ ions are important intracellular molecular signals in many biological processes, e.g. apoptosis, muscle fibre contraction, neurotransmitter release, cell proliferation, and immune responses. Ca²⁺ triggers these responses by interactions with calcium binding proteins, after its regulated entry to the cytoplasm. It is therefore of interest to be able to microscopically analyse the molarity of Ca and other heavy element concentrations in tissues as an indicator of normal and disease states. Particle Induced X-ray Emission (PIXE) measurements provide quantitative data in terms of the mass content of an element as a function of the dry mass of the sample. It is non-trivial to relate this to the physiological meaningful unit of the molarity of the element in question in living (wet) tissue. This is because of anatomical differences and different shrinkage during dehydration give rise to significant thickness variations over the sample area. Here we developed procedures to determine the molarity of heavy elements in wet tissue based on simultaneous off-axis Scanning Transmission Ion Microscopy (STIM), PIXE and Rutherford Backscattering Spectrometry (RBS) to measure the local target thickness and major element composition. Incorporating these parameters considerably reduced the spread of lesser life elements (S, P, Cl, K, Ca, Fe, etc.) [Whitlow 2021] between tissue regions in the samples. This new approach was applied to study mucosa tissues which play an important barrier role in the immune defence by secretion of mucous which performs lubricative, hydration, cleaning as well as acting as a selective permeable layer for absorption of gases and nutrients. Mucus is produced as granules within goblet cells with H⁺ and Ca²⁺ concentrations are signals that trigger the exocytotic release of mucus from granules. Sections of nasal mucosa tissue from a control and a subject infected with simian immunodeficiency virus (SIV) revealed localised sequestration of Ca in the epithelial tissues with concentration in the 10-30 mmol/L range in the later subject.

INSTRUMENTATION II

Chairs: Johnny F. Dias and István Rajta

Invited talk II

1090

Nuclear microprobe in materials for solar cells devices

Victoria Corregidor^{1,2}, Luís Alves^{1,2}, Pedro Salomé³, Jenifer Teixeira³, M. Alexandra Barreiros⁴¹ C2TN, Centro de Ciências e Tecnologias Nucleares² Departamento de Engenharia e Ciências Nucleares, Instituto Superior Técnico, Universidade de Lisboa³ International Iberian Nanotechnology Laboratory, Braga 4715-330, Portugal⁴ Laboratório Nacional de Energia e Geologia, UME, Estrada do Paço do Lumiar, 22, Lisboa 1649-038, Portugalvictoria.corregidor@tecnico.ulisboa.pt

In spite of the large improvements on the fabrication of solar cell devices with very high energy conversion efficiencies, still a better understanding is needed on the relation between structure and device performance. This work is focused on the results obtained by a nuclear microprobe in combination with ion beam analysis (IBA) techniques on the characterization of different materials used as absorber layers in solar cells devices, such as CdTe, nanocrystalline porous TiO₂ films as photoanode, organo-metal halide perovskites, and Cu(In,Ga)Se₂.

Such different materials were characterized with the nuclear microprobe in Lisbon, adapting the experimental conditions (particles and energy) to the specific challenges of each material. The final aim was to help understanding the limitations of the devices under study and then propose changes in the manufacturing conditions for obtaining optimum performance.

Both, a 2 MeV H⁺ and He⁺ focused beams were used to characterize CdTe nano-structured layers on Bi₂Te₃ seeds. Results showed the importance of the seeds for the later successful growth of the nanowires [1].

In the case of dye synthesized solar cells, one of the challenges was to evaluate the total dye adsorbed on the TiO₂ film and its distribution. The IBA techniques were essential to study the distribution of Ru organometallic dye in the photoanode of about 2 μm thick [2].

IBA techniques, mainly PIXE and RBS, allowed establishing the dependence of band gap variation of the perovskite films with the changes in the perovskite chemical composition (FA_{0.83}Cs_{0.17}Pb(I(1-x)Br_x)₃) upon the crystallization process [3].

The nuclear microprobe and IBA techniques were also important tools to characterize the promising Cu(In,Ga)Se₂ (CIGS) solar cells, by detecting in-depth inhomogeneities in final devices which act as regions for their performance limitations [4].

Characterization challenges continue as cell structures are becoming more complex, for example: reducing the thickness of the absorber layer, or adding very thin passivation layers between the back contact and the absorber layer. Possible solutions and limitations will be shown and discussed.

[1] V. Corregidor, L.C. Alves, N. Franco, M.A. Barreiros, N.V. Sochinskii, E. Alves (2013) CdTe nano-structures for photovoltaic devices, Nucl. Instruments and Methods B, 306: 218-221, Doi: 10.1016/j.nimb.2012.11.051.

[2] M.A. Barreiros, V. Corregidor, L.C. Alves, F. Guimarães, J. Mascarenhas, E. Torres, M.J. Brites (2015) Assessment of dye distribution in sensitized solar cells by microprobe techniques, Nuclear Instruments and Methods B., 348: 255-259, doi: 10.1016/j.nimb.2014.11.041.

[3] M.J. Brites, M. A. Barreiros, V. Corregidor, L. C. Alves, J. V. Pinto, M. J. Mendes, E. Fortunato, R. Martins, J. Mascarenhas (2019) Ultrafast Low-Temperature Crystallization of Solar Cell Graded Formamidinium-Cesium Mixed-Cation Lead Mixed-Halide Perovskites Using a Reproducible Microwave-Based Process, ACS Applied Energy Materials, 2: 1844-1853. Doi: 10.1021/acsaem.8b02005

[4] V. Corregidor, M. A. Barreiros, P.M. P. Salomé, L. C. Alves, In-Depth Inhomogeneities in CIGS Solar Cells: Identifying Regions for Performance Limitations by PIXE and EBS (2021) The Journal of Physical Chemistry C, 125: 16155-16165.

1112

Microbeam RBS of Ion Tracks Caused by Single Event Burnout of HV GaN DiodesBarney L. Doyle and Albert Colon*Sandia National Laboratories, Albuquerque, NM, USA 87185*bldoyle@sandia.gov

In high-voltage power devices, wide bandgap (WBG) semiconductors such as gallium nitride (GaN) and silicon carbide (SiC) offer significantly improved electrical performance compared to silicon. While most commercial devices utilizing WBG semiconductors involve SiC, GaN has certain advantages over SiC, such as a substantively higher critical electric field (3.3 MV/cm compared to 2.4 MV/cm). In addition, there is evidence that GaN devices are more resilient to select radiation damage modes due to the higher critical electric field, stronger molecular bonds, and other intrinsic material properties and device design practices. Radiation resilience is attractive to engineers designing circuits that must operate reliably in radiation environments. In particular, Single Event Burnout (SEB), characterized by unrecoverable damage, is of concern for devices operating at high voltages. The authors of this work studied SEB in vertical GaN PN diodes fabricated at Sandia using 7.5 and 30 MeV C ions from the Tandem Pelletron in the Ion Beam Laboratory.

These diodes have a 1 micron Au anode followed by 0.4 microns of heavily doped p-type GaN followed by 10 microns of lightly doped n-type GaN and finally a heavily doped n-type substrate and bottom metallization. For an SEB to occur, 1) the ions need to penetrate all the way to the substrate, 2) the ions must provide sufficient ionization, and 3) the bias on the diode must be greater than a threshold value. In our case, SEB occurred for the 30 MeV C ion, which ranged out in the substrate on a diode bias voltage of 857V, but the 7.5 MeV C ion, with insufficient range, could not induce an SEB event. On the diodes suffering SEB, a crater also formed around the region where the C strike occurred, removing part of the Au anode.

An experiment that timed the SEB event determined that the very first ion that hits in the anode region of the diode produces the SEB. The authors investigated whether the location of the ion impact could be determined and whether it could be validated that it was indeed just a single ion. Using 3D RBS on the 3 MV Pelletron at the IBL, a 2.5 MeV proton beam focused to ~5 microns was scanned across the crater blemish made during the SEB event. Single tracks were revealed in side view as a slight increase in the RBS signal in a straight line, 5 microns wide going >10 microns deep into the GaN on several of the diodes with the largest SEB craters. The authors suggest this increase is due to the decomposition of the GaN along the track into Ga + N₂. The N₂ migrates away, and the resulting track is 100% Ga and therefore has ~2x the RBS signal as GaN. The radii of such tracks are much smaller than the 5 micron microbeam resolution and that is why there was only a slight increase in the RBS signal that was observed.

Sandia National Laboratories is managed and operated by NTESS under DOE NNSA contract DE-NA0003525.

1098

Status of Ion Microprobe activities at the University of North Texas

Todd A. Byers, Cory Nook, Darshpreet Kaur Saini, Charles Bowen, Bibhudutta Rout*, and Gary A. Glass*

Ion Beam Laboratory, Department of Physics, University of North Texas, Denton, Texas 76203, USA

*bibhu@unt.edu, gary.glass@unt.edu

We are currently operating a high throughput ion beam focusing system utilizing two pairs of magnetic quadrupole doublets lenses separated at a distance of 85 cm. The system is being built in a microprobe beamline with Louisiana magnetic separated doublet (LMD) lens associated with a 3MV single-ended (NEC, 9SH) accelerator. The focusing system has an orthomorphic demagnification of $\sim 100 \times 100$ for a working distance of 18 cm, regularly achieving an optimal spatial resolution of 0.5 μm with a beam current of 50 pA.

We will be presenting experimental results demonstrating the capabilities of the system and its applications in biomedical and environmental samples.

1048

Upgrade of the external beamline at the Microanalytical center of Jožef Stefan Institute

Kristina Isaković^{1,2}, Marko Petric², Zdravko Rupnik², Ava Rajh², Žiga Šmit³, Primož Pelicon², Mitja Kelemen^{1,2}, Matej Vereš², Paula Pongrac^{2,4}, Primož Vavpetič², Matjaž Kavčič²

¹ *Jožef Stefan International Postgraduate School, Ljubljana, Slovenia*

² *Jožef Stefan Institute, 1000 Ljubljana, Slovenia*

³ *Faculty of Mathematics and Physics, University of Ljubljana, Ljubljana, Slovenia*

⁴ *Biotechnical Faculty, University of Ljubljana, Ljubljana, Slovenia*

kristina.isakovic@ijs.si

Recently, the existing external beamline at the Microanalytical center was upgraded to extend the capabilities of the set-up from point measurements with a broad ($\sim 1 \text{ mm}^2$) proton beam [1] to a 2D lateral in-air PIXE mapping across a surface area of $\sim 1 \times 1 \text{ cm}^2$ with sub $100 \text{ }\mu\text{m}$ lateral resolution. In order to focus the beam, a doublet of magnetic quadrupole lenses was installed at the beamline. Additionally, the exit nozzle was redesigned to house an ultra thin 200 nm Si_3N_4 foil and minimize the sample-exit window working distance. The characterization of beam size is presented together with the first application on longitudinal section of a whole thick wheat grain [2].

Additional upgrade is the installation of a new parallel beam wavelength dispersive spectrometer. The spectrometer combines polycapillary x-ray lens for efficient x-ray collection and diffraction on a flat crystal analyzer to reach high energy resolution. The spectrometer is designed for tender x-ray energy range (2-6 keV) so it is enclosed within a He bag to eliminate in-air x-ray absorption. Here we report the results of first characterization measurements yielding basic properties of the new setup.

RADIATION BIOLOGY

Chairs: Judith Reindl and François Vianna-Legros

Invited talk

1111

Treating tumours with small ion beams: mini- and microbeam radiation therapyTim Schneider*Institut Curie, France*tim.schneider@curie.fr

Despite major advances over the last decades, the dose tolerance of normal tissue continues to be a central problem in radiation therapy, limiting for example the effective treatment of radioresistant tumours. An innovative new approach to overcome this problem is the irradiation with very narrow beams that are spaced apart to create a so-called spatial fractionation of the dose. This creates a pattern of alternating high dose and low dose regions which has been shown to drastically improve the tolerance of normal tissue.

Depending on the dimensions and arrangement of the beams, several techniques are distinguished; here, the focus will lie on minibeam radiation therapy (MBRT, beam sizes from 0.1 to 1 mm) and microbeam radiation therapy (MRT, beam sizes from 25 to 100 μm). Both MBRT and MRT have already demonstrated their tissue sparing potential with experiments showing that doses of 100-1000 Gy can be tolerated when delivered in the right configuration. This makes it possible to safely escalate the dose in the tumour which in turn can offer a more effective treatment. In this context, preclinical MBRT and MRT studies found tumour control rates that are comparable or even superior to those achieved with conventional radiotherapy.

The goal of this presentation is to give a general overview of MBRT and MRT by introducing physical and radiobiological core concepts and by discussing the mechanisms underlying the normal tissue sparing and treatment efficacy observed for both techniques. Moreover, challenges concerning a clinical translation will be addressed and the latest experimental results and technical advances will be presented.

1008

Long term imaging of cells after targeted irradiation of mitochondria

Sarah Rudigkeit, Dietrich W.M. Walsh, Nicole Matejka, Matthias Sammer, Benjamin Schwarz, Günther Dollinger, Judith Reindl

Universität der Bundeswehr München, Institute for Applied Physics and Measurement Technology, Neubiberg, Germany

sarah.rudigkeit@unibw.de

Mitochondria are the “power plants” of the cell and cover 30 - 40 % of the cytoplasmic volume in HeLa cells. Therefore, they are the main organelles for the survival of the cell. It is known, that mitochondria depolarize after targeted irradiation of them, but it is still unclear how this influences the cell. So, the aim of this work is to investigate which effects have the depolarization of mitochondria after targeted irradiation on the cells behavior, especially the cell survival. We performed targeted irradiation with carbon ions at the ion microprobe SNAKE (Super conducting Nanoprobe for Applied Nuclear (Kern) physics Experiments) at the 14 MV tandem accelerator in Garching near Munich, with a beam spot size of $\sim 1 \mu\text{m}$. With this setup it is possible to target mitochondria, which were fluorescently stained, with a defined number of 55 MeV Carbon ions (LET = $365 \text{ keV}/\mu\text{m}^2$ at the cells). In a first study we targeted the mitochondria of single cells with 5,120 Carbon ions (equivalent to a dose of about $100 \text{ Gy}/\mu\text{m}^2$ on the cytoplasm) [1] and observed mitochondrial depolarization. Now we were able to further follow the irradiated cells for 3.5 days to score single cell survival using a phase contrast microscope (20x objective, PH2) together with a special Tokai Hit stage top incubator. While the number of the irradiated cells stayed constant during the observation, the unirradiated control group showed an exponential growth. An additional particle track detector test revealed that 3 % parasitic ions hit the cells up to $500 \mu\text{m}$ away from the targets. This approximately yields a dose up to 4.5 Gy per nucleus. Subsequent improvements to beam preparation reduces the dose to a half and the impact on cell survival has to be tested in future experiments.

[1] D.W.M. Walsh et al. (2017) Live cell imaging of mitochondria following targeted irradiation in situ reveals rapid and highly localized loss of membrane potential, Sci Rep. 7, 46684, doi: <https://doi.org/10.1038/srep46684>

1031

Combining In Situ Detection and Quantification of Metal Oxide Nanoparticles using Nuclear Microprobe Analysis with Complex Biological Analysis Techniques to reveal nano-induced ion homeostasis alterations on *Caenorhabditis elegans* intestine

Pierre Beaudier¹, Laurent Plawinski¹, Guillaume Devès¹, Denis Dupuy², Philippe Barberet³, Hervé Seznec¹

¹ CNRS LP2iB Gradignan-France

² INSERM ARNA Pessac

³ Univ. Bordeaux LP2iB Gradigna

beaudier@lp2ib.in2p3.fr

Metal oxide nanoparticles (NPs) are used in a wide array of industrial applications including direct human uses such as solar creams, cosmetic products, plastics, etc. These uses lead to the circulation of important amounts of NPs, thus posing potential risks to the environment and to health when they cross the physiological barrier, are ingested or inhaled. As such, there is a need to quantify and characterize the fate of these NPs for in vivo biological organisms as well as the mechanisms involved in the internalization and toxicity processes. A particular focus will be made on the impact of titanium dioxide nanoparticles (TiO₂ NPs) on cellular ion homeostasis as they represent one of the most widely used type of NPs.

Previously, we illustrated that μ -PIXE (AIFIRA facility, LP2iB) can quantify NPs internalization¹ and how it influences in vitro the endogenous cellular content variation of some specific ions such as Ca²⁺. It was determined that these variations can be correlated to an endoplasmic reticulum stress-dependent toxicity^{2,3}.

Now, we present our last observations related to in situ and in vivo analyses conducted on *Caenorhabditis elegans* exposed to TiO₂ NPs. μ -PIXE was found to be suitable for both accurate description of chemical structure of multicellular systems and for the detection of NPs. μ -PIXE revealed that the calcium and potassium homeostasis were deeply modified in the proximal intestinal cells despite an absence of NPs internalization. In addition to physico-chemical characterization using μ -PIXE, we use flow cytometry (reporter assay) and third generation sequencing (direct-RNA Transcriptome analysis) to confront the results and understand how ingested but non-internalized NPs could create stress-dependent toxicity and lead to adverse effect on nematode development and homeostasis.

- [1] Muggioli G, Simon M, Lampe N, Devès G, Barberet P, Michelet C, Delville MH, Seznec H. In Situ Detection and Single Cell Quantification of Metal Oxide Nanoparticles Using Nuclear Microprobe Analysis. *J Vis Exp*. 2018 Feb 3;(132):55041. doi: 10.3791/55041. PMID: 29443063; PMCID: PMC5912329.
- [2] Simon M, Saez G, Muggioli G, Lavenas M, Le Trequesser Q, Michelet C, Devès G, Barberet P, Chevet E, Dupuy D, Delville MH, Seznec H. In situ quantification of diverse titanium dioxide nanoparticles unveils selective endoplasmic reticulum stress-dependent toxicity. *Nanotoxicology*. 2017 Feb;11(1):134-145. doi: 10.1080/17435390.2017.1278803. PMID: 28044465.
- [3] Simon M, Barberet P, Delville MH, Moretto P, Seznec H. Titanium dioxide nanoparticles induced intracellular calcium homeostasis modification in primary human keratinocytes. Towards an in vitro explanation of titanium dioxide nanoparticles toxicity. *Nanotoxicology*. 2011 Jun;5(2):125-39. doi: 10.3109/17435390.2010.502979. Epub 2010 Jul 15. PMID: 21425910.

1036

Increasing the efficacy of proton radiation in tumour cells by exploiting the $^{11}\text{B}(p,\alpha)\alpha\alpha$ reaction with metallacarboranes

T. Pinheiro^{1,2}, S. Di Maria^{1,3}, L.C. Alves^{1,3}, V. Corregidor, J. Cruz^{4,5}, C. Vinãs⁶, F. Teixidor⁶, F. Marques^{1,3}

¹ Departamento de Engenharia e Ciências Nucleares, Instituto Superior Técnico, Universidade de Lisboa, Lisboa, Portugal

² IBB, Instituto de Bioengenharia e Biociências

³ C²TN, Centro de Ciências e Tecnologia Nuclear

⁴ NOVA School of Science and Technology, NOVA University Lisbon, Campus Caparica, 2829-516 Caparica, Portugal

⁵ LIBPhys—Laboratory of Instrumentation, Biomedical Engineering and Radiation Physics, 2829-516 Caparica, Portugal

⁶ Institut de Ciència de Materials de Barcelona, Consejo Superior de Investigaciones Científicas, Campus Universitat Autònoma de Barcelona, 08193 Bellaterra, Spain

teresa.pinheiro@tecnico.ulisboa.pt

In the fight against cancer, proton therapy can offer an attractive alternative to conventional photon-based radiotherapy. However, there is a need to improve the efficacy of protons by enhancing the relative biological effectiveness (RBE). Metallacarboranes, which are boron (B) rich compounds, are promising as radiosensitizers for proton therapy when using the well-known $^{11}\text{B}(p,\alpha)$ fusion reaction. This reaction has a main resonance at 675keV, a high cross section (~ 1 barn), and the three α -particles emitted at the point of reaction have a broad spectrum with a predominant energy of 4MeV [1]. The combined effect of proton energy close to the Bragg peak and α particles range within typical cell dimensions is expected to escalate cell-killing upon compounds's accumulation in tumour cells.

The external beam facility at IST microprobe was used to irradiate cell monolayers, using a 2MeV proton beam with a flux of approximately 10^8 protons/cm² s and an appropriate sequence of attenuators (Mylar foils, air and water with thicknesses determined/calculated using the SRIM code) in order to reach the resonance energy of the $^{11}\text{B}(p,\alpha)\alpha\alpha$ fusion reaction at the cell layer. Human glioblastoma and breast cancer cells were used in the experiments as cell models. Cells were treated with the compounds for 24h, irradiated and the irradiation effects assessed. A successful validation step with a Monte Carlo (MC) model (MCNP6.1 code) was achieved by comparing several MC and experimental parameters, such as divergence of the beam, energy spectrum, the variation of the Bragg peak depending on the point of reaction and the variation of the maximum dose.

The MC simulations point out for a dose enhancement resulting from α -particle emission, which is in part compatible with the increase of cell-killing effects obtained after irradiation. Work is in progress to extend the MC model to more detailed and accurate simulations that will give a full account of the dose variation in cells.

[1] Spraker MC, Ahmed MD, Blackston MA (2012) The $^{11}\text{B}(p,\alpha)^8\text{Be} \rightarrow \alpha + \alpha$ and the $^{11}\text{B}(\alpha,\alpha)^{11}\text{B}$ reactions at Energies Below 5.4 MeV. J Fusion Energ 31:357–367. Doi: 10.1007/s10894-011-9473-5

1041

Complementary radiobiology beam lines for high linear energy transfer (LET) proton beam cellular studies at the Centre for Ion Beam Applications (CIBA), National University of Singapore

Ce-Belle Chen, Zhaohong Mi, Chengyuan Yang, Saumitra Vajandar, Lakshmi Jayakumar, Tze Yen Chua, Minqin Ren, Ginhao Yuen, Frank Watt, Thomas Osipowicz, Andrew Bettiol

Centre for Ion Beam Applications, Department of Physics, National University of Singapore, Singapore

phyche@nus.edu.sg

Proton beam therapy (PBT) is an advanced radiation modality in cancer treatment with enhanced precision in tumour targeting that minimises damage to healthy tissue. Three new PBT centres in Singapore, at different stages of planning and completion, are to capitalise on these benefits in view of an ageing population with rising cancer projections. Globally, the cancer burden is projected at 28 million in 2040, almost 50 % increase from 2020 cancer cases. Recent innovations in cell biology potentially stimulate new discovery pathways in PBT research. At CIBA, we have constructed two complementary facilities dedicated to live cell radiobiology research: a high resolution focussed proton beam line and a large-scale cell irradiation end station utilising broad proton beams. The focussed proton beam line has a sub-500 nm in-cell spot size enabling precise and selective cell irradiation, with quantitative dosimetry, because protons can be counted individually. Simultaneously, live-cell fluorescence imaging and selective subcellular targeting functionality are available. The second system, designed for large scale cell irradiation, was constructed to deliver uniform proton doses to up to four million monolayer cells in a matter of minutes. With many standard cell biology techniques requiring hundreds of thousands to millions of cells, this large scale cell irradiation system expands the potential for multiple cell biology assays and downstream applications, including high-throughput screening platforms for drug discovery programs, next generation sequencing and proteomics. Our 3.5 MeV single ended accelerator delivers protons at energies not far below the Bragg peak, so that LET values above 10 keV/micron in cells are available. These two complementary systems enable a plethora of cell biology studies directly using clinically-relevant high LET protons, additionally precluding extraneous absorber or water phantom requirements.

MeV-SIMS

Chairs: Melanie Bailey and Primož Vavpetič

Invited talk

1028

Recent advances in MeV SIMS at the Ruđer Bošković Institute

Zdravko Siketić¹, Marko Barac^{1,2}, Marko Brajković¹, Iva Bogdanović Radović¹, Matea Krmpotić¹, Marijana Popović Hadžija¹

¹ Ruđer Bošković Institute, Zagreb, Croatia

² Jožef Stefan International Postgraduate School, Ljubljana, Slovenia

zsiketic@irb.hr

MeV SIMS is a variation of the standard technique TOF SIMS, in which primary ions with energies of ~MeV/amu, accelerated by a particle accelerator, are used for ion desorption. The basis of the MeV SIMS technique lies in the fact that electronic stopping is much more pronounced in this energy range than nuclear stopping. The energy introduced into the electronic system by the MeV ion is transferred to the host atoms via electron-phonon interactions, forming a cylindrical high-temperature region along the ion path. Electron sputtering of the inorganic material, and the fragmentation of the organic material, take place in the high-density infratrack region of the ion track. On the other hand, intact molecular ions are ejected from the so-called lower energy density ultratrack region where the coupling between the excitation energy and the internal vibrational modes of the organic molecules is weak. In this way, a higher yield of molecular secondary ions with lower fragmentation is obtained than in the conventional SIMS, which is performed with keV ions. This makes a MeV SIMS ideal for chemical imaging of organic molecules with masses up to 2000 Da.

Over the past decade intensive development and application of the MeV SIMS has been done at the Ruđer Bošković Institute (RBI). Recent results on the application of MeV SIMS in the analysis of forensic samples, such as the determination of the deposition order of crossing lines of different writing tools, will be presented. In addition to the standard MeV SIMS imaging setup at RBI, based on the focused ion beam, the newly developed MeV SIMS imaging system, based on the collimated beam will be shown. Thanks to the flexibility of target scanning system (instead of the ion beam scanning), objects with larger dimensions can be imaged. The performance of the new system will be demonstrated by imaging a thin section of the mouse brain and imaging a fingerprint with a lateral resolution of ~10 μm . Last but not least, we will show the idea of using primary ions with energies in the range of 100 keV - 5 MeV for SIMS, where both inorganic species and larger biomolecules can be desorbed from the sample simultaneously due to similar contributions of nuclear and electronic stopping power (possibility of hybrid sample analysis). The ability to image hybrid organic/inorganic samples will be demonstrated on a target with lateral distribution of Cr and leucine. In addition, the ability of LE MeV SIMS to perform depth profiling in a dual beam mode with an Ar gun was investigated. LE MeV SIMS depth profiling of a Cr-ITO bilayer sample in a dual beam mode will be shown.

1102

Detection of metastable ions at MeV-SIMS

Boštjan Jenčič, Žiga Barba, Mirjana Vasić, Mitja Kelemen, Primož Vavpetič, Primož Pelicon

Jožef Stefan Institute, Ljubljana, Slovenia

bostjan.jencic@ijs.si

Primary ions within the MeV range domain exhibit promising characteristics for sufficient detection of large biomolecules by means of sputtering via electronic excitations [1]. Within the work, we present the recent development of the corresponding MeV-SIMS Mass Spectrometry Imaging technique at Jožef Stefan Institute. Although MeV-SIMS yielded encouraging results in the past, the method still lacked several technological features and routine availability. Recently, a new bimodal mass spectrometer has been added to the experimental setup, allowing detection of secondary ions in linear, as well as reflectron modes. The reflectron part of the spectrometer is also equipped with an up to -10 kV post acceleration discrete dynode detector, which further increases detection efficiency of large biomolecules. Additionally, finer vacuum within the spectrometer allows higher transmission of secondary particles, thus revealing new information of technique's unique sensitivity and its physical limit.

By means of such spectrometer, we can detect and characterize metastable ions, i.e. ions, which fragment during their drift within the mass spectrometer. We measure the quantity of such fragmentation as a function of the primary ion energy, and asses fragmentation pathways of amino acid arginine.

[1] Y. Nakata, Y. Honda, S. Ninomiya, T. Seki, T. Aoki and J. Matsuo, "Yield enhancement of molecular ions with MeV ion-induced electronic excitation," *Applied Surface Science*, vol. 255, pp. 1591-1594, 2008.

1105

Ambient MeV-SIMS Measurement of Negative Electrode Surface of Lithium Ion BatteryToshio Seki¹ and Jiro Matsuo²¹ Department of Nuclear Engineering, Kyoto University, Gokasyo, Uji, 611-0011 Kyoto, Japan² Quantum Science and Engineering Center, Kyoto University, Gokasyo, Uji, 611-0011 Kyoto, Japanseki.toshio.7r@kyoto-u.ac.jp

The Li-ion battery (LIB) has become a widely used product, particularly in small devices such as laptops and smartphones. However, the reactions taking place in rechargeable batteries are not completely understood. A solid electrolyte interphase (SEI) is formed mainly at the interface between the LIB negative electrode (anode) and the electrolyte during charging. SEI is a reductive decomposition product of electrolyte molecules (solvent, additive, and anion) and is a mixture of inorganic and organic substances. SEI has a significant effect on LIB performance and safety. To observe such an interface reaction in situ/during operation, a suitable technology for molecular analysis of SEI in the presence of liquid is required. Such an analytical system must be able to operate at ambient conditions because liquid materials in electrochemical batteries evaporate easily in a vacuum. In addition, because the target materials on electrodes are mixtures of inorganic and organic substances, not only elemental analysis, but also chemical state analysis with a high interface sensitivity is required.

Secondary ion mass spectrometry (SIMS) is a method with high surface sensitivity, which allows both elemental and molecular analysis. MeV-SIMS uses heavy ion beams with energy in the MeV range, and samples can be measured under ambient conditions because of the high transmission capability of these ions at low vacuum pressure. The evaporation of liquid materials is suppressed in He at atmospheric pressure, and samples containing liquid can be measured using the MeV-SIMS technique without drying. In this paper, MeV-SIMS measurements of negative electrode LIB after charging / discharging were performed at atmospheric pressure.

The measured samples were negative electrode of LIB after 40 cycles of charging / discharging at 4.8 V. Both charge and discharge times are 30 minutes. The negative electrode was prepared by applying a solution of graphite and PVDF (PolyVinylidene DiFluoride) (graphite: PVDF = 95: 5) in NMP (N-methylpyrrolidone) on Cu. The electrolyte of LIB is EC containing LiPF₆ (1000mM). The SIMS spectrum was obtained at measurement time of 100 seconds. Additions of Li to EC cluster and additions of Li to compounds of EC with LiPF₆ ([3EC+LiPF₆+Li]⁺, [4EC+LiPF₆+Li]⁺, [4EC+LiPF₆+LiF+Li]⁺, and [4EC+ 2LiPF₆+LiF+Li]⁺) were detected with high sensitivity from EC containing LiPF₆. It is clear from the nozzle-sample distance dependence of the peak intensity that these ions of Li additions are secondary ions from the sample surface. Additions of Li to compounds of EC with NMP and LiPF₆ ([2EC+NMP+Li]⁺, [2EC+NMP+LiPF₆+Li]⁺, [3EC+NMP+LiPF₆+LiF+Li]⁺, and [3EC+NMP+ 2LiPF₆+LiF+Li]⁺) were also detected from the surface of the negative electrode. Since these ions contain NMP, which is a negative electrode material, it is considered that MeV-SIMS succeeded in measuring the negative electrode surface.

QUANTUM TECHNOLOGIES

Chairs: Ettore Vittone and Jafar Shojai

Invited talk

1110**Wide bandgap semiconductors for quantum applications**Andrew A. Bettiol

Centre for Ion Beam Applications, Department of Physics, National University of Singapore, 2 Science Dr 3, Singapore 117551

a.bettiol@nus.edu.sg

Quantum photonics is an emerging field of photonics whereby light (single photons) is used for quantum computation, communication and sensing technologies. One of the key enablers for these new technologies are colour centres. Colour centres are isolated defects in crystals that can emit single photons and that have spin properties that can be exploited for quantum technologies. Two semiconductor materials that hold enormous potential for such technologies are Diamond and Boron Nitride (BN). Both of these materials are wide band gap semiconductors and have been demonstrated to possess the desirable properties for quantum technologies. These include colour centres with high brightness, low photo-bleaching and room-temperature optically accessible spins. Colour centres can sometime occur naturally in semiconductors and are introduced during the growth process. This is clearly not desirable as they will occur randomly throughout the material making it difficult to exploit their properties for quantum applications. Ion implantation is an important technology that can be used to generate colour centres with a high degree of spatial precision. In this presentation an overview of the generation of colour centres in diamond and hBN using a mega-electron volt nuclear microprobe will be discussed. Some examples of single photon emitters and magnetic sensing will be presented.

1063

Deterministic single ion implantation and defect engineering studies using a focused beam of highly charged ions

Paul Räche¹, Simon Robson², Alexander M. Jakob², David N. Jamieson², Jan Meijer³, Daniel Spemann¹

¹ Leibniz Institute of Surface Engineering (IOM) Tools Leipzig-Germany

² ARC Centre for Quantum Computation and Communication Technology, School of Physics, University of Melbourne School of Physics Melbourne-Australia

³ Universität Leipzig Applied Quantum Systems Leipzig-Germany

paul.raecke@iom-leipzig.de

Deterministic single ion implantation will be a key to enable novel solid state-based quantum technologies based on impurities or defect-centres in silicon, diamond or other materials. The single ion implanter used here was constructed by combining a commercially available focused ion beam (FIB) machine with an electron beam ion source (EBIS), which selectively produces ions of low and high charge states of various species, such as noble gases, hydrogen, nitrogen and soon phosphorous, with nanoscale focus (acceleration potential 6 to 15 kV).

A recent addition to the setup includes an ion beam induced charge (IBIC) system, which was developed for ultra-low noise keV single ion detection [1]. By scanning the focused low energy ion beam across specially configured single ion detectors and spatially mapping the IBIC response, unprecedented studies of the three-dimensional near-surface (<100 nm) electrical landscape were performed, showing uniform near 100% charge collection over a large area in the newest detector generation. This setup thus offers a fabrication platform for scalable qubit arrays using mask-free deterministic ion implantation [2].

In parallel, a single ion pre-detection scheme based on image charge detection is developed to be implemented in the future. A new detector prototype designed and constructed in Leipzig is cryogenically cooled and combines the signals of four detector segments, substantially increasing the signal-to-noise ratio. As a result, single ion bunches containing down to 80 elementary charges were detected. Remaining challenges and potential for further improvement of the sensitivity towards single ion detection are discussed [3].

While highly charged ions are necessary for the proposed single ion image charge detection scheme, choosing different charge states furthermore enables to conveniently vary the implantation energy from less than 10 up to several hundred keV, which is remarkable using such a compact setup. This is beneficial for systematic defect engineering studies in any material, as we exemplify by direct writing of vacancies in different depths for NV-centre creation in diamond [4].

[1] Jakob AM et al (2021) Deterministic Shallow Dopant Implantation in Silicon with Detection Confidence Upper-Bound to 99.85% by Ion–Solid Interactions, Adv. Mat. 34, 2103235, <https://doi.org/10.1002/adma.202103235>

[2] Robson SG et al (2022) Near-Surface Electrical Characterisation of Silicon Electronic Devices Using Focused keV Ions. <https://doi.org/10.48550/arXiv.2201.11339>

[3] Räche P, Meijer, J, Spemann, D (2022) Image charge detection of ion bunches using a segmented, cryogenic detector. J. Appl. Phys. 131, 204502, <https://doi.org/10.1063/5.0096094>

[4] Räche P et al (2021) Vacancy diffusion and nitrogen-vacancy center formation near the diamond surface Appl. Phys. Lett. 118, 204003, <https://doi.org/10.1063/5.0046031>

1072

Overcoming Surface Recombination for Diamond Single Ion Detectors

Nicholas Collins¹, Alexander Jakob¹, Simon Robson¹, Shao Qi Lim¹, Boqing Liu², Brett Johnson³, Jeffery MacCallum¹, David Jamieson¹

¹ *University of Melbourne School of Physics Melbourne-Australia*

² *Australian National University School of Engineering, College of Science and Computer Science Canberra-Australia*

³ *RMIT University School of Engineering Melbourne-Australia*

ncollins2@student.unimelb.edu.au

Diamond colour centres have the potential to be integrated into a monolithic device that employs the colour centre to store and transmit quantum information as well as to act as quantum sensors [1]. Production of a large-scale device requires addressing the challenge of engineering ordered arrays of near-surface colour centres [2,3] in diamond substrates. Deterministic ion implantation employing the Ion Beam Induced Charge (IBIC) single ion detection method detects the charge of free electron-hole pairs induced by a single ion impact in the diamond substrate to register the implantation event. Here we address the challenge of adapting this method from its successful applications in silicon [4] to diamond. We have fabricated on-diamond electrodes that can be biased to produce strong internal fields and minimise leakage current required for high fidelity single ion signals for typically sub-20 keV ions needed for near-surface implants. A difficult challenge was to suppress surface charge recombination at the diamond surface which would otherwise allow most of the induced charge to recombine. Our method, employing a thin conductive electrode addresses this challenge and gives close to 100% charge collection efficiency for sub-20 keV ions and high-fidelity deterministic implantation despite the lower ionisation rate in diamond with its much wider band-gap compared to silicon. We use IBIC spectroscopy to demonstrate the charge collection efficiency in our new efficient detector architectures which is a significant advance over previous generations of devices.

[1] Doherty, Marcus W., et al. "The nitrogen-vacancy colour centre in diamond." *Physics Reports* 528.1 (2013): 1-45.

[2] Nemoto, Kae, et al. "Photonic quantum networks formed from NV- centers." *Scientific reports* 6.1 (2016): 1-12.

[3] Pezzagna, S., et al. "Creation efficiency of nitrogen-vacancy centres in diamond." *New Journal of Physics* 12.6 (2010): 065017.

[4] Jakob, Alexander M., et al. "Deterministic Shallow Dopant Implantation in Silicon with Detection Confidence Upper-Bound to 99.85% by Ion-Solid Interactions." *Advanced Materials* 34.3 (2022): 2103235.

1009

ACCURACY OF 3D QUANTITATIVE IMAGING OF MICROSCOPIC SAMPLES EVALUATED BY GEANT4 SIMULATION

Zhuxin Li¹, Claire Michelet¹, Sébastien Incerti¹, Philippe Barberet¹, Hao Shen², Shimei Wang², Daniel Beasley³, Hervé Sez nec¹

¹ CNRS/University of Bordeaux, CENBG/LP2I Bordeaux, Bordeaux, France

² Fudan University, Key Laboratory of Nuclear Physics and Ion beam Application, Shanghai, China

³ King School of Biomedical Engineering and Imaging Sciences, London, United Kingdom

barberet@cenbg.in2p3.fr

Proton micro-tomography is a powerful tool for three-dimensional (3D) imaging of microscopic samples. Two techniques are implemented: i) STIM (Scanning Transmission Ion Microscopy) to obtain the 3D structure of the sample; ii) PIXE (Particle-Induced X-ray Emission) to obtain the distribution of chemical elements [1]. The obvious first benefit of 3D imaging is to locate chemical elements within the analysed volume, without cutting the sample. Beyond spatial distribution, a major issue is quantitative imaging, i.e. accurate calculation of mass density (in g/cm³) in the reconstructed images. For PIXE tomography, signal attenuation is a concern, because it leads to an underestimation of the element content. It is due to two physical phenomena: variations of X-ray production cross-sections and X-ray absorption within the material. A correction has been implemented in the tomographic reconstruction process in order to take into account these phenomena. In the present study, our purpose is to quantify in a direct way the accuracy of the obtained tomographic images. For this, we used as a benchmark the Geant4 toolkit (<http://geant4.org>), which is the most widely used open source code in the world for simulation of particle-matter interaction.

A Geant4 simulation code of PIXE and STIM tomography experiments has been developed, in such a way to minimize execution time and memory space. The simulated data sets are used to quantify the accuracy of the reconstructed tomographic images. Geant4 constitutes a useful benchmark as it brings important advantages: i) it is independent of the inversion method used for the reconstruction; ii) one or more physical processes (X-ray absorption, proton energy loss) can be numerically turned off, giving access to data that cannot be obtained in real experiments [2].

Several examples will be presented, such as *Caenorhabditis elegans* microorganism and microsphere targets used for inertial fusion experiments [3]. An accuracy $\leq 4\%$ was obtained for the mass density of phosphorus, which was the most attenuated element, compared to a about 40% discrepancy without correction. A comparison between results obtained from different reconstruction codes (TomoRebuild, DISRA and JPIXET [4]) will be also presented.

- [1] Michelet C et al (2015) Development and applications of STIM- and PIXE-tomography: A review. Nucl. Instr. Meth. B 363:55-60. doi: 10.1016/j.nimb.2015.08.070
- [2] Michelet C et al (2022) A Geant4 simulation of X-ray emission for three-dimensional proton imaging of microscopic samples. Physica Medica 94:85-93. doi: 10.1016/j.ejmp.2021.12.002
- [3] Wang S. et al (2022) Application of silicon drift detector in PIXE tomography system of Fudan University. Nucl. Instr. Meth. B 512:108-113. doi: 10.1016/j.nimb.2021.12.010
- [4] Beasley DG et al (2013) Fast simulation of proton induced X-ray emission tomography using CUDA. Nucl. Instr. Meth. B 306:109-112. doi: 10.1016/j.nimb.2012.12.053

1023

Cold plasma treatment of buckwheat grain decreases water contact angle and husk Ca and Mn concentrations

Pia Starič^{1,2}, Primož Vavpetič¹, Katarina Vogel-Mikuš^{1,2}, Paula Pongrac^{1,2}, Ita Junkar¹

¹ Jožef Stefan Institute, Ljubljana, Slovenia

² Biotechnical Faculty, University of Ljubljana, Ljubljana, Slovenia

pia.staric@ijs.si

Common buckwheat (*Fagopyrum esculentum*) is an increasingly popular crop whose grain is rich in high-quality proteins, fibres, lipids, essential minerals, vitamins and antioxidants. Because it is gluten-free it is an excellent grain alternative to cereal grain in diets of gluten-intolerant people and people with celiac disease [1], [2]. Furthermore, it is a crop that is relatively easy to grow as it requires no abundant fertilizers or pesticides for optimal growth and yield [3].

The use of cold or non-thermal plasma (CP) technology in agriculture is a promising environmentally-friendly way to decontaminate grain and to improve germination, yield, and/or stress resistance in crops. Thus, this novel approach could improve the production and storage of grain, such as buckwheat [4].

We investigated the impact of CP treatment on pericarp morphology of buckwheat grain with scanning electron microscopy and localization of elements in grain tissues (pericarp, aleurone, endosperm, and cotyledons) with micro-proton-induced X-ray emission spectroscopy. In addition, water contact angle was evaluated.

The CP treatment caused no visible changes on the buckwheat grain surface, but a decrease in water contact angle was detected in CP-treated grain. CP-treated grain germinated slower than untreated grain, without effects on the total number of germinated grains. The concentration of calcium (Ca) and manganese (Mn) in the outer layer of the grain (pericarp) was lower in CP-treated grain compared to untreated ones. A trend of lower concentration of potassium (K) in cotyledons and pericarp of CP-treated grain compared to untreated grain was observed, but it was not statistically significant presumably due to large variability in K concentrations present.

This work was supported by Slovenian Research Agency (ARRS): Young research grants (Pia Starič), program groups (P2-0082, P1-0112 and P1-0212) and project V4-2001.

- [1] A. Ivankov et al., "Changes in Agricultural Performance of Common Buckwheat Induced by Seed Treatment with Cold Plasma and Electromagnetic Field," *Appl. Sci.* 2021, Vol. 11, Page 4391, vol. 11, no. 10, p. 4391, May 2021
- [2] P. Pongrac, K. Vogel-Mikuš, M. Regvar, P. Vavpetič, P. Pelicon, and I. Kreft, "Improved lateral discrimination in screening the elemental composition of buckwheat grain by micro-PIXE," *J. Agric. Food Chem.*, vol. 59, no. 4, pp. 1275–1280, Feb. 2011
- [3] Popović, V., Sikora, V., Berenji, J., Glamočlija, Đ., Marić, V. (2013a): Effect of agroecological factors on buckwheat yield in conventional and organic cropping systems, Institute of PKB Agroekonomik, Belgrade, vol. 19(1-2), pp. 155-165
- [4] L. K. Randeniya and G. J. J. B. de Groot, "Non-Thermal Plasma Treatment of Agricultural Seeds for Stimulation of Germination, Removal of Surface Contamination and Other Benefits: A Review," *Plasma Process. Polym.*, vol. 12, no. 7, pp. 608–623, Jul. 2015

1046

Effect of *Xylella fastidiosa* infection on tissue-specific localisation of elements in almond and grapevine leaves

Neja Bizjak¹, Paula Pongrac^{1,2}, Tanja Dreo³, Mitja Kelemen², Primož Vavpetič², Primož Pelicon², Katarina Vogel-Mikuš^{1,2}, Charlotte Poschenrieder⁴, Jaime Vadell⁵, Catalina Cabot⁵

¹ Biotechnical Faculty, University of Ljubljana, Ljubljana, Slovenia

² Jožef Stefan Institute, Ljubljana, Slovenia;

³ National Institute of Biology, Ljubljana, Slovenia;

⁴ Universitat Autònoma de Barcelona, Bellaterra, Barcelona, Spain;

⁵ Universitat de les Illes Balears, Palma (Illes Balears), Spain

neja.bizjak14@gmail.com

Xylella fastidiosa (*Xf*) is a slow growing, xylem limited, vector-transmitted and gram-negative bacterium first described by Wells *et al.* in 1987 [1]. The pathogen can infect more than 80 plant species and genera. Large economical damage is observed in the Americas from where the bacterium originates [2], namely in grapevine, citrus and almond [1,3]. Since its first detection in Europe, in southern Italy [4] it has destroyed millions of olives and negatively affected almonds in Spain. In terms of effects *Xf*-infection has on mineral nutrition of plants, higher concentration of Ca and Mg, but lower concentrations of K have been reported for *Xf*-infected grapevine leaves compared to healthy leaves [5]. There is no information on tissue-specific redistribution of elements due to *Xf*-infection, thus the aim of our study was to evaluate redistribution of elements in *Xf*-infected and healthy leaves of two almond cultivars (Glorieta and Masbovera), and in grapevine (Cabernet Sauvignon) grown on calcareous or red soil. Leaf cross sections were prepared as described previously [6] or necrotic spots on leaves (of unknown origin) were excised and tissue-specific element analysis was performed using micro-PIXE at Jožef Stefan Institute. Spectra were fitted, and distribution maps were generated in GeoPIXE software [7]. There were cultivar-dependent differences in concentration of S, Cl, Ca, and K in specific tissues in *Xf*-infected and healthy almond leaves. Necrotic spots on the almond leaves were encircled with Si and Fe, centrally there was an enrichment of P and S and exclusion of Cl and K. In grapevine, results depended on the soil and significant differences in P and S concentrations in different leaf tissues when comparing *Xf*-infected leaves with healthy leaves were observed. This is the first report on the use of micro-PIXE in *Xf*-infected crop leaves.

Acknowledgement: The RADIATE project (HORIZON2020, Grant 824096), the Slovenian Research Agency (P1-0112, P1-0212, P4-0165, N1-0105, J4-3091) and technical assistance of Špela Prijatelj Novak and Neža Turnšek (both NIB).

[1] J.M. Wells, *et al.*, *Int. J. Syst. Bacteriol.* 37 (1987) 136–143. [2] L. Nunney, *et al.*, *PLoS One.* 9 (2014) e112463. [3] P. Baldi, N. La Porta, *Front. Plant Sci.* 8 (2017) 944 [4] M. Saponari, *et al.*, *J. Plant Pathol.* 95 (2013) 668. [5] P.H. Goodwin, J.E. DeVay, C.P. Meredith, *Physiol. Mol. Plant Pathol.* 32 (1988) 17–32. [6] K. Vogel-Mikuš, P. Pongrac, P. Pelicon, *Int. J. PIXE.* 24 (2014) 217–233. [7] C.G. Ryan, *Int. J. Imaging Syst. Technol.* 11 (2000) 219–230.

1064

Tissue-specific distribution of elements in date palm

Paula Pongrac^{1,2}, Sina Fischer³, Konrad Neugebauer⁴, Lawrie Brown⁴, Mitja Kelemen², Primož Vavpetič², Primož Pelicon², Katarina Vogel-Mikuš^{1,2}, Philip White⁴

¹ Biotechnical Faculty, University of Ljubljana, Ljubljana, Slovenia

² Jožef Stefan Institute, Ljubljana, Slovenia

³ Future Food Beacon of Excellence and the School of Biosciences, University of Nottingham, UK

⁴ The James Hutton Institute, Dundee, UK

paula.pongrac@ijs.si; paula.pongrac@bf.uni-lj.si

Date palm (*Phoenix dactylifera* L.) is an economically important perennial crop of (semi)arid areas. Although date palms are thought to be salt-tolerant, (extreme) salinity can result in economic losses [1]. In this study, seedlings of date palm cultivars Khalas and Sultana were watered with NaCl for eight weeks. At harvest, the root tip, root base, stem and bottom part of the leaf were excised, cross sections were prepared [2] and tissue-specific elemental analysis was performed using micro-particle induced-X-ray emission (micro-PIXE) at Jožef Stefan Institute [3]. Spectra were fitted, and distribution maps were generated using GeoPIXE software [4]. Bulk concentrations of elements were determined in plant parts using inductively-coupled plasma mass spectrometry after acid digestion of dried samples. Sodium and Cl concentrations were the largest in root tips, followed by the root base, stem and leaves. Tissue-specific allocation of Na could be determined for root tips only, where Na was accumulated in the cortex; elsewhere Na was distributed evenly. By contrast, Cl was found in the cell layer surrounding cortex and also in the vascular bundle in root tips, while in the root base, stems and leaves, Cl was accumulated in extraordinarily large cells and in tissue surrounding the vascular bundle (**Fig. 1**). Of the other elements detected with micro-PIXE, namely Si, P, S, K, Ca, Mn, Fe and Zn, the most remarkable distribution was observed for Si, which was found as Si phytoliths, which surround vascular bundles on adaxial and abaxial sides of leaves and flank Cl-rich cells (**Fig. 1**). These Si phytoliths have been described in detail previously [5], but their distribution has now been determined in all plant parts and at tissue level. Phosphorus was allocated to the vascular bundles (**Fig. 1**). Further work is underway to resolve expression of genes involved in response to NaCl treatments in these two date palm cultivars.

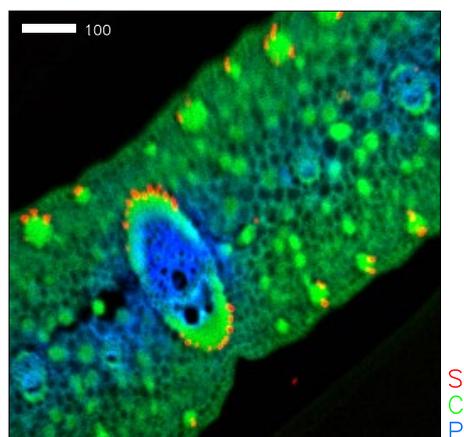


Figure 1 Distribution of Si, Cl and P in a representative cross-section of date palm leaf. Scale bar is in μm .

Acknowledgements: The study was supported by the RADIATE project HORIZON 2020, Grant Agreement 824096) and by the Slovenian Research Agency (P1-0112, P1-0212, N1-0105, J4-3091).

- [1] B. Du, et al., P, *New Phytol.* 229 (2021) 3318–3329.
- [2] K. Vogel-Mikuš, P. Pongrac, P. Pelicon, *Int. J. PIXE.* 24 (2014) 217–233.
- [3] P. Pelicon, et al., *Nucl. Instrum. Methods Phys. Res. B* 332 (2014) 229–233.
- [4] C.G. Ryan, *Int. J. Imaging Syst. Technol.* 11 (2000) 219–230.
- [5] B. Bokor, et al., *Front. Plant Sci.* 10 (2019) 1–17.

1065

Tissue-specific concentration of zinc in grain of two Slovenian proso millet (*Panicum miliaceum* L.) landraces

Eva Müller¹, Marko Flajšman¹, Mitja Kelemen², Primož Vavpetič², Primož Pelicon², Katarina Vogel-Mikuš^{1,2}, Darja Kocjan-Ačko¹, Paula Pongrac^{1,2}

¹ Biotechnical Faculty, University of Ljubljana, Ljubljana, Slovenia

² Jožef Stefan Institute, Ljubljana, Slovenia

evamueller13@gmail.com

Zinc (Zn) is one of the essential elements in humans, where it plays a crucial role in over 300 enzyme processes, in the transcription and expression of genes [1], and in protein complexes responsible for correcting DNA damage [2]. Tissue development, mineralization of bones, the workings of the immune system and thyroid function are only a few processes in animals that depend on sufficient levels of Zn. Therefore, its deficiency can lead to a plethora of health problems, ranging from low blood pressure and diarrhea to the more severe immune deficiency and stunted development [3]. While severe deficiency is rare, the WHO estimates that on a daily basis, around 2 billion people do not consume enough Zn. The estimate is higher in developing countries, where it rises to about 73% of the population [4]. One of the crucial and easiest ways to add Zn into diets is through the use of Zn-enriched crops. Proso millet (*Panicum miliaceum* L.) offers itself as a promising candidate, as it has many favoured nutritional (boasts high protein content [5] and is gluten-free) and agronomic traits (extremely low water requirements, which render it drought tolerant [6], and low nutrient requirements, which enable it to grow in poor soils with minimal agronomic input [7]). However, genomic resources and other relevant information about proso millet are still limited, and the variability in Zn-use efficiency has not yet been evaluated. We cultivated six Slovenian landraces of proso millet along with one Slovene autochthonous cultivar, Sonček [8] to determine the concentration of Zn in different tissues (roots, leaves and grain) at two developmental stages (flowering and at grain maturity). After evaluating the bulk Zn concentration using X-ray fluorescence, we selected the two extremes in grain Zn concentration for detailed grain tissue-specific analysis using micro-particle-induced X-ray emission at the Jožef Stefan Institute, Slovenia. Results confirm the bulk differences in Zn grain concentration and assign the differences to specific grain tissues.

Acknowledgement: The study was supported by the Slovenian Research Agency (P1-0112, P1-0212, N1-0105 and J4-3091).

[1] Tipton IH, Cook MJ (1963). Health Physics 9, 2:103–145.

[2] Ho E, Ames BN (2002). PNAS 99, 26:16770–16775.

[3] Deshpande J, Joshi M, Giri P (2013). International Journal of Medical Science and Public Health 2, 1:1-6.

[4] Caulfield LE, Black RE, 2004. World Health Organization 287-279.

[5] Saha D, Gowda MC, Arya L, Verma M, Bansal KC (2016). Crit Rev Plant Sci 35: 56-79.

[6] Baltensperger DD (1996). Foxtail and proso millet. In: Janick J, editor. Progress in New Crops. Alexandria, VA, USA: ASHS. Press, pp. 182-190.

[7] Sabir P, Ashraf M, Akram NA (2011). J Agron Crop Sci 197: 340-347.

[8] Flajšman M, Štajner N, Kocjan Ačko D (2019). Turk J Botany 43:185–195.

1085

Tissue-specific calcium and magnesium allocation explains differences in bulk concentration in leaves of one-year-old seedlings of two olive (*Olea europea* L.) cultivars

Paula Pongrac^{1,2}, Mitja Kelemen², Katarina Vogel-Mikuš^{1,2}, Primož Vavpetič², Primož Pelicon², Paula Žurga³, [Nikolina Vidović⁴](mailto:nikolina@iptpo.hr), Marija Polić Pasković⁴, Smiljana Goreta Ban^{4,5}, Igor Lukić^{4,5}, Igor Pasković⁴

¹ Biotechnical Faculty, University of Ljubljana, Ljubljana, Slovenia

² Jožef Stefan Institute, Ljubljana, Slovenia

³ Teaching Institute of Public Health Primorsko-Goranska County, Rijeka, Croatia

⁴ Department of Agriculture and Nutrition, Institute of Agriculture and Tourism, Poreč, Croatia

⁵ Centre of Excellence for Biodiversity and Molecular Plant Breeding, Zagreb, Croatia

nikolina@iptpo.hr

Olive (*Olea europea* L.) leaves have recently been endorsed as a valuable by-product in cosmetic and pharmaceutical industries or in preparation of health-promoting beverages. Knowledge on the mineral composition of olive leaves is still scarce, while tissue-specific allocation of minerals within leaves has not been studied up to date. In this study, micro-particle induced X-ray emission (micro-PIXE) was used to identify and quantify minerals in different leaf tissues of two olive cultivars, Leccino and Istarska bjelica. In addition, leaf bulk mineral analyses were performed. One-year-old seedlings grown in pots were investigated to ensure the differences observed were cultivar-dependent only. Leaves of the Istarska bjelica cultivar had larger bulk concentrations of potassium (K), sodium (Na), molybdenum (Mo) and boron (B), but smaller concentrations of calcium (Ca) and magnesium (Mg) than leaves of the Leccino cultivar. Tissue-specific investigation revealed that larger concentration of Ca in epidermis and in leaf blade tissues (secondary veins, palisade and spongy mesophyll) contributed to the larger leaf bulk Ca concentration in the Leccino cultivar. For Mg, all leaf tissues, except the bundle sheath cells and consequently the main vascular bundle, contributed to the larger bulk Mg concentration in the Leccino cultivar compared to leaves of the Istarska bjelica cultivar. Potassium was not predominant in any of the leaf tissues examined. Results indicate that Ca and Mg sinks in specific leaf tissues are stronger in the Leccino than in the Istarska bjelica cultivar. Element profiles of three leaf tissues (i.e. clusters) were captured using multivariate statistics. The first cluster, rich in K, discerned the spongy mesophyll and the xylem from other tissues. In the second cluster, chlorine, K and Ca predominated and such profile was found in epidermis, bundle sheath cells and supportive tissue of the main vein. The third cluster, rich in Mg, phosphorus, sulphur and K was characteristic for palisade mesophyll. This report offers basic understanding of tissue-specific allocation of minerals in leaves of olive, economically the most important fruit tree in the Mediterranean. In addition, it could serve as a basis for detailed studies into the effects of (foliar) fertilisers in olive leaves and for elucidation of dynamics and differential extraction of minerals from olive leaves during beverage preparation.

1094

Uptake and tissue-specific localization of arsenic in roots and nodules in peanut

Eliana Bianucci^{1,2}, Paula Pongrac^{3,4}, Katarina Hrovat³, Katarina Vogel-Mikuš^{3,4}, Primož Pelicon⁴, Mitja Kelemen⁴, Primož Vavpetič⁴, Ana Furlan¹, Charlotte Poschenrieder²

¹ Institute of Agrobiotechnological Research (INIAB-CONICET)- FCEFQyN – National University of Río Cuarto, Argentina

² Department of Animal Biology, Vegetal and Ecology, Autonomus University of Barcelona, Barcelona, Spain

³ Biotechnical Faculty, University of Ljubljana, Slovenia

⁴ Jožef Stefan Institute, Ljubljana, Slovenia

hrovatkatarina4@gmail.com

Arsenic (As) is toxic to plants and animals. Flooding of agricultural land with As-rich groundwater increases the risk of As mobility in the food chain and has become a significant threat. One such situation is with peanut (*Arachis hypogaea* L.), an agriculturally valuable crop in Córdoba province in Argentina, where i) several cropping areas contain high concentration of As and ii) occasional flooding episodes increase As-containing groundwater level [1]. Both circumstances could lead to a reduction on peanut yield and increase the possibility of seed contamination with As. Arsenate (As(V); AsO₄³⁻), a form of As, is particularly problematic, because it is chemically similar to the plant-available form of essential phosphorus (PO₄³⁻). Therefore, when arsenate reaches the rhizosphere, it is inadvertently taken up by the roots, transported within the plant and may enter edible seeds. Moreover, exposure to As and flooding can negatively affect the uptake of essential elements and could cause redistribution of these elements within the plant. The aim of this work was to study the uptake and distribution of As in different parts of peanut and to determine the tissue-specific localization of As in roots and nodules under non-flooded and flooded conditions. Nodule formation was induced by inoculation with the beneficial bacterium *Bradyrhizobium* sp. SEMIA6144 and plants were grown under controlled conditions for 45 days and exposed to the four treatments (Control, As, flooding and As&flooding). Using X-ray fluorescence total concentration of elements were determined. The highest concentration of As was detected in roots, followed by nodules, while the concentration of As detected in stems and leaves was significantly lower. Using quantitative micro-particle-induced X-ray emission (Jožef Stefan Institute, Slovenia), allocation of As was determined at the tissue level in cross-sections of roots and nodules. Spectra were fitted, and quantitative distribution maps were generated using GeoPIXE software [2]. The detailed analysis of the localization and distribution of As in different parts and tissues of peanut plants will provide an insight into tissue-specific disturbances caused by As and flooding in this agriculturally important crop.

Acknowledgement: The study was supported by the RADIATE project (HORIZON2020, Grant 824096) and the Slovenian Research Agency (P1-0112, P1-0212, N1-0105 and J4-3091).

[1] J.M. Peralta, C.N. Travaglia, M.C. Romero-Puertas, A. Furlan, S. Castro, E. Bianucci, *Chemosphere*. 259 (2020) 127410.

[2] C.G. Ryan, *Int. J. Imaging Syst. Technol.* 11 (2000) 219–230.

1055

Micro-PIXE analysis for the provenance investigation of ancient pottery from Locri Epizephiri (Italy)

Marta Magalini^{1,2}, Laura Guidorzi², Alessandro Re^{1,2}, Alessandro Lo Giudice^{1,2}, Monica Gulmini³, Patrizia Davit³, Diego Elia⁴, Matteo Campostrini⁵, Valentino Rigato⁵

¹ Dipartimento di Fisica, Università di Torino, Via Giuria 1, Torino, Italy

² INFN - Sezione di Torino, Via Giuria 1, Torino, Italy

³ Dipartimento di Chimica, Università di Torino, via Pietro Giuria 7, 10125 Torino, Italy

⁴ Dipartimento di Studi Storici, Università di Torino, Via S. Ottavio 20, 10124 Torino, Italy

⁵ INFN, Laboratori Nazionali di Legnaro, Legnaro (Padova), Italy.

marta.magalini@unito.it

Black slip ware and red figure pottery were produced in Southern Italian workshops during the 6th to the 4th century BCE according to a Greek technological process [1]. The vases and fragments of red-figured pottery found at Locri Epizephiri (Southern Italy) has been under study for over 10 years at the University of Torino to investigate not only their production technology but also their provenance. The initial attribution to Attic or Southern Italian (mainly Locrian or Sicilian) workshops on grounds of stylistic criteria [2] was later supported by archaeometric studies by means of Scanning Electron Microscopy coupled with Energy Dispersive X-ray spectroscopy and Induced Couple Plasma Optical Emission Spectrometry [3]. These techniques revealed that the concentrations of major and minor elements in the clay body allow the discrimination between the Greek and the Italian origin. Now, the study aims at distinguishing the Calabrian from the Sicilian production by investigating the composition of the very thin vitrified gloss (some 20 μm) on the pottery shards, chasing for possible provenance markers among the trace elements of the black coating. The quantitative analysis of this very small target was performed by exploiting the micro-PIXE technique, that guarantees high sensitivity and spatial resolution and a non-destructive approach.

The 16 pottery samples (6 Attic, 6 Locrian and 4 Sicilian) analysed in this work were small shards prepared as cross sections. Micro-PIXE measurements were performed in vacuum at INFN-LNL (Legnaro, Padova, Italy) with 2 MeV protons. For each sample, three to five 50 μm lines were acquired along the coating layer to take into account its possible inhomogeneity. Two sets of ceramic standard samples that simulate different ancient production technologies, such as different firing conditions, were also employed for calibration.

The methodology of the PIXE investigation on red-figured pottery found at Locri Epizephiri and the preliminary results of the analysis will be presented. The trace elements found in the slip could be used to distinguish the Calabrian from the Sicilian production and to test the hypothesis that different workshops used raw materials from different sources to obtain the vitrified slip.

[1] Mirti P. et al., Technology of production of red figure pottery from Attic and southern Italian workshops, *Analytical and bioanalytical chemistry*, 380 (2004) 712-718.

[2] Elia D., Ph.D. thesis, University of Messina, Italy, 2001.

[3] Mirti P. et al., The Provenance of Red Figure Vases From Locri Epizephiri (Southern Italy): New Evidence by Chemical Analysis, *Archaeometry* 46 (2004) 183-200

1059

Mineral Glazed beads: similar composition but different colourAna Luísa Sebastião¹, I. Mendes da Silva², Luís Alves^{1,3}, Rosa Marques^{1,3}, Victoria Corregidor^{1,3}¹ C2TN, Centro de Ciências e Tecnologias Nucleares² ERA Arqueologia S.A., Calçada de Santa Catarina, 9C, 1495-705 Cruz Quebrada – Dafundo, Portugal³ Departamento de Engenharia e Ciências Nucleares, Instituto Superior Técnico, Universidade de Lisboa, Lisboa, Portugalvictoria.corregidor@tecnico.ulisboa.pt

The beads (five) under study have similar shapes and sizes and different colors, from pale orange to dark blue/black. They were found during a recent archaeological survey performed on an ancient vessel (Boa Vista 5), in Lisbon. They are representative of the beads found, chronologically attributed to the period between the last quarter of the 18th century and the beginning of the 19th century. The main objective of this work is the chemical and mineralogical characterization of the beads, by means of non-destructive techniques.

PIXE technique reveals the presence of Si as a major element and it was also possible to identify Fe, K, Ca, S, and Cl elements in all the beads, and no significant concentration differences were found in order to explain the different beads colors.

The ionluminescence signal recorded from the beads when irradiated with a 2 MeV proton beam using the external beam setup available in Lisbon shows a similar spectra shape for all of them, and it was not possible to identify the presence of impurities responsible for the different colors of the samples.

Complementary techniques, such as X-ray diffractron (XRD), were used to understand the origin of the color of these discovered beads.

1060

The use of IBA techniques to study iron gall inks. What more can we get?Victoria Corregidor^{1,2}, Margarida Nunes³, Teresa Ferreria^{3,4}, A. Claro⁵, Luís Alves^{1,2}¹ C2TN, Centro de Ciências e Tecnologias Nucleares² Departamento de Engenharia e Ciências Nucleares, Instituto Superior Técnico, Universidade de Lisboa³ HERCULES Laboratory, University of Évora, Largo Marquês de Marialva 8, Évora, Portugal⁴ Chemistry Department, Science and Technology School, University of Évora, Rua Romão Ramalho 59, Évora, Portugal.⁵ CHAM, NOVA School of Social Sciences and Humanities, Lisboa, Portugalvictoria.corregidor@tecnico.ulisboa.pt

The use of IBA techniques, mainly PIXE and RBS, for the study of cultural heritage objects is increasing, mainly due to the efforts during the last decades in the diffusion of these techniques in international conferences, and the participation in several European programs with supported transnational access.

Among the cultural heritage objects, manuscripts written with iron gall inks have been investigated mainly with PIXE due to the high sensitivity to the elements present in the inks in trace concentrations [1].

On the other hand, the use of portable and/or handheld XRF analyzers to characterize these inks is also increasing, due to the relatively easy use and accessibility.

The advantages of PIXE, such as the high sensitivity and the possibility of element quantification, are clear and further enhanced when the possibility of obtaining 2D maps composition is added [2].

Furthermore, the depth penetration of the ink can be obtained if RBS spectra are also considered during the analysis combined with the use of protons or alpha particles beams to obtain better depth resolution for surface and sub-surface analysis.

In this work, results obtained from the characterization of a document from the 17th century, written with different iron gall inks will be presented. Different techniques were used, including IBA and XRF. The information obtained from them will be compared and discussed, providing an overview of what more can the IBA techniques give, considering for example the number of points/pages to be analysed in a short time.

[1] L. Giuntini, F. Lucarelli, P.A. Mandò, W. Hooper, P.H. Barker (1995) Galileo's writings: chronology by PIXE, Nucl Instruments Methods Phys Res Sect B Beam Interact with Mater Atom, 95:389-392. doi: 10.1016/0168-583X(94)00538-9.

[2] V. Corregidor, R. Viegas, L.M. Ferreira, L.C.Alves (2019). Study of Iron Gall Inks, Ingredients and Paper Composition Using Non-Destructive Techniques. Heritage 2:2691-2703. Doi: 10.3390/heritage2040166

1070

Ion beam induced luminescence analysis of europium complexes in styrene-divinylbenzene co-polymer coated spherical silica by proton and argon ion beams irradiation

Masaumi Nakahara¹, Sou Watanabe¹, Masayuki Takeuchi¹, Takahiro Yuyama², Tomohisa Ishizaka², Yasuyuki Ishii², Ryohei Yamagata², Naoto Yamada³, Masashi Koka³, Wataru Kada⁴, Naoto Hagura⁵

¹ Japan Atomic Energy Agency Nuclear Cycle Engineering Laboratories Ibaraki-Japan

² National Institutes for Quantum Science and Technology -

³ Beam Operation Co., Ltd. -

⁴ Gunma University -

⁵ Tokyo City University

nakahara.masaumi@jaea.go.jp

In a nuclear fuel reprocessing, it is proposed that not only U and Pu but also minor actinides (MAs) such as Np, Am, and Cm are recovered for reduction in the volume and potential radiotoxicity of high level liquid wastes, and the study for recovery of MAs has been conducted in the worldwide. Among MAs, an extraction chromatography has been proposed to recover trivalent MAs, Am and Cm, in Japan. An extractant for trivalent MAs recovery is impregnated styrene-divinylbenzene co-polymer coated silica particles, and it is used as adsorbent. The adsorbent is packed into a column, and high level liquid waste is pumped through columns to recover MAs. It is important to understand the structure of complexes in the adsorbent to recover MAs efficiently. Ion beam induced luminescence (IBIL) analysis of complexes in the adsorbent is investigated as one of methods of evaluating the structure of complexes. In the experiments, various adsorbents extracting Eu were prepared with extractants for MAs recovery. Non-radioactive Eu was selected as simulated material of Am because Eu is easy to be detected the luminescence and the extraction behavior of Eu is similar to that of Am. The IBIL spectra of Eu complexes in the adsorbent were measured using two different ion beams, 3 MeV proton in the light-ion micro beam line connected to 3-MV single-ended accelerator and 107 MeV Ar⁸⁺ with the beam line for large-area uniform irradiation at the azimuthally varying field (AVF) cyclotron facility, in Takasaki Ion Accelerators for Advanced Radiation Application (TIARA), National Institutes for Quantum Science and Technology (QST). In this study, the structure of Eu complexes in various adsorbents was evaluated based on the IBIL spectra. It was confirmed that the spectral shape of Eu complexes in the adsorbents varied depending on the kinds of extractants. The detailed research results will be reported in our presentation.

1074

Mo(IV) and Pd(II) ion recovery mechanism onto baker's yeast from nitric acid medium

Kenta Hasegawa¹, [Sou Watanabe](mailto:watanabe.sou@jaea.go.jp)¹, Yoichi Arai¹, Masayuki Watanabe¹, Haruaki Matsuura², Naoto Hagura², Masashi Koka³, Yasuyuki Ishii⁴, Yasuhiro Konishi⁵

¹ Japan Atomic Energy Agency

² Tokyo City University

³ Beam Operation Co., Ltd.

⁴ National Institutes for Quantum and Radiological Science and Technology

⁵ Osaka Metropolitan University

watanabe.sou@jaea.go.jp

Extraction chromatography is a promising technology for minor actinide (MA(III): Am and Cm) recovery from high level liquid waste generated in the reprocessing of spent nuclear fuel. Our group is proposing a two steps column operation process flow, and MA(III) recovery performance was demonstrated on simulated waste liquid containing Am. Although MA(III) was successfully recovered by the technology, accumulation of Mo(IV) and Pd(II) in the 2nd column was confirmed and improvement in the process is required for repeated use of the column. One of the promising improvements is selective adsorption of these metal ions from feed solution for the column. We have already found that addition of another column between two columns can achieve the improvement [1]. However, the improvement requires additional equipment and expensive reagents, and more simple and inexpensive process is desirable. Currently, we are focusing on baker's yeasts for their excellent metal ions adsorption characteristics [2], easy handling and low prices. In order to optimize adsorption performance and operation procedures as the reprocessing technology, adsorption mechanism has to be precisely investigated. In this study, adsorption performance of Mo(IV) and Pd(II) from nitric acid, functional groups on the surface of the baker's yeast, coordination structure around the ions, mapping of the ions on the yeasts are investigated by batch-wise adsorption experiments, FT-IR, EXAFS and micro-PIXE analyses, respectively.

Dry baker's yeast was put into 2 M nitric acid solution containing Mo(IV) and Pd(II), and the yeast was separated from the solution by centrifugation. Mo and Pd K edge EXAFS measurements on the yeast were carried out at BL11S2 beamline of AichiSR, Japan. The micro-PIXE analysis was carried out at a light-ion microbeam line connected to a 3-MV single-ended accelerator in TIARA of QST, Japan.

Mo(IV) and Pd(II) concentrations in the solution decreased after the batch-wise operation. Characteristic X-ray of Mo and Pd were observed in the PIXE spectra and two-dimensional PIXE images showed that Mo and Pd uniformly distributed on surface of the yeast. FT-IR showed various functional groups exist on surface of the yeast and those might contribute to the adsorption. Currently, quantitative EXAFS analysis based on the FT-IR analysis are underway.

[1] Abe R, Nagoshi K, Arai T, Watanabe S, Sano Y, Matsuura H, Takagi H, Shimizu N, Koka M, Sato T (2017) Microscopic analyses of complexes formed in adsorbent for Mo and Zr separation chromatography. Nucl Instruments Methods Phys Res Sect B Beam Interact with Mater Atoms 404:173-178. doi: 10.1016/j.nimb.2017.02.082

[2] Saito N, Fujimori R, Yoshimura T, Tanaka H, Kondoh A, Nomura T, Konishi Y (2020) Microbial recovery of palladium by baker's yeast through bioreductive deposition and biosorption. Hydrometallurgy 196:105413. doi: 10.1016/j.hydromet.2020.105413

1077

Evaluation of remaining spent extraction solvent in vermiculite after leaching test by PIXE analysis

Yoichi Arai¹, Sou Watanabe¹, Kenta Hasegawa¹, Nobuo Okamura¹, Masayuki Watanabe¹, Keisuke Takeda², Hiroki Fukumoto², Tomohiro Agou², Naoto Hagura³, Takehiko Tsukahara⁴

¹ Japan Atomic Energy Agency Nuclear Fuel Cycle Engineering Laboratories Tokai-Mura-Japan

² Ibaraki University Materials Science and Engineering Hitachi-Shi-Japan

³ Tokyo City University Nuclear Safety Engineering, Faculty of Science and Engineering Kawasaki-Shi-

⁴ Tokyo Institute of Technology Laboratory for Zero-Carbon Energy Meguro-Ku-Japan

arai.yoichi@jaea.go.jp

Spent PUREX solvent, which mainly consists of tributyl phosphate (TBP) and normal dodecane, is generated by solvent extraction of Plutonium and Uranium in the spent nuclear fuel reprocessing. The spent solvent should be appropriately treated for its safety disposal or storage. Although reprocessing plant has liquid treatment systems, some nuclear facilities such as laboratories do not have the treatment system.

One of the treatment options for storage of the spent solvent is adsorption of the liquid into vermiculite. The organic liquid is considered to be trapped between layers of the vermiculite. Our previous experiments on the adsorption of spent solvent into the vermiculite have shown that some parts of loaded solvent gradually leaked out from the vermiculite.

In order to investigate the adsorption mechanism and capacity, elution behavior of the loaded solvent into organic diluents such as hexane or acetone was evaluated. A part of the loaded solvent was easily leaked into the diluent, while some solvent remained inside the particle even after the leaching test. The different behavior might be attributed to different adsorption mechanism, and amount of the remaining solvent can be considered as adsorption capacity for safety storage of the solvent.

In this study, the adsorption capacity of the vermiculite was evaluated through amount of remaining solvent after washing with diluents. The amount of the remaining solvent was analyzed by Particle Induced X-ray Emission (PIXE) on P contained in TBP. PIXE experiments were carried out at a tandem accelerator of Tokyo City University, and 2 MeV H⁺ beam was irradiated on vermiculite powders in vacuumed atmosphere. Peak intensity of P-K α line depended on the washing condition, and the behavior of the amount of change in adsorbed P atom qualitatively agreed with the results of the leaching test. PIXE analysis was able to evaluate the trace amount of remaining solvent in vermiculite, which could not be evaluated by measuring only the eluted solvent using NMR analysis. The cleanup method of the remaining solvent in vermiculite and adsorption behavior will be clarified by PIXE analysis.

1079

Characterization of hourly-collected air-borne particulate matters by in-air micro-PIXE analysis assisted by machine learning

Koki Usui¹, Ryota Kikuchi¹, Sota Nakatsu¹, Takahiro Imayoshi¹, Kimiyo Kumagai², Hiroshi Tago², Masashi Koka³, Naoto Yamada³, Ryohei Yamagata³, Yasuyuki Ishii³, Takahiro Satoh³, Osamu Hanaizumi¹, Wataru Kada¹

¹ Gunma University Faculty of Science and Technology Kiryu-Japan

² Gunma Prefectural Institute of Public Health and Environmental Sciences Atmospheric Environment Maebashi-Japan

³ National Institutes for Quantum Science and Technology (QST) Department of Advanced Radiation Technology Takasaki-Japan

t211d013@gunma-u.ac.jp

Transboundary propagation of air pollutions of Particle Matter (PM) is a global issue and often attracts interests among researchers in terms of long-term health care and risks of human beings. To estimate its origin, the elemental composition of PM is one of the most important key factors. However, it is sometimes hardly accomplished with general-purpose technology for hourly-collected PM samples because of its limited concentrations. On the other hand, our previous trials utilizing micro-PIXE analysis on several hourly-collected samples successfully revealed its elemental compositions. Since trend and changes in elemental compositions might play a key role, consecutive dataset of elemental composition should be obtained by micro-PIXE analysis for better understanding and characterization of PM collected in short term period from atmosphere.

In this study, we employed external (in-air) micro-PIXE system placed at QST Takasaki to analyze PM 2.5 and PM 2.5 - 10 particulate matters (PM) obtained through PM sampler of DKK FPM377B placed at Ohta (36.290° N, 139.381° E). Each spot correspond to each time-bin was separated from the tape and irradiated by 3 MeV H⁺ microprobe with typical scanning area of 400 × 400 μm². Our house-made software allows us to analyze a set of PIXE spectra by utilizing library of Imfit, non-linear least square method, and elemental composition ratios were delivered from the amount of each element in the peak area divided by the L1 norm of each elemental amount, and dimensionality was reduced by principal component analysis. Through micro-PIXE analysis, data set was successfully and continuously obtained through 26 March 2020 00:00 -22:59, 27 March 2020 while the software code automatically identified several outlier data by classification throughout the campaign of the analysis. Results indicated data analysis successfully assisted micro-PIXE analysis to investigate consecutively obtained PM samples with better error correction functions.

1099

Trace-elemental analysis of herbal plant leaves and air particulates using Particle Induced X-ray Emission

Darshpreet Kaur Saini, Todd A. Byers, Cory Nook, Mohin Sharma, Mritunjaya Parashar, Gary A Glass, Bibhudutta Rout

University of North Texas Physics Denton-United States

DarshpreetKaurSaini@my.unt.edu

Tulsi (*Ocimum Sanctum*), Hibiscus (*Hibiscus Rosa-Sinensis*), and Neem (*Azadirachta Indica*) are known to be of great value in the field of medicine. Due to the many health benefits, these leaves offer, the elemental concentrations levels have been investigated in these types of leaves in past decades. Our study is focused not only on the quantitative estimation of the concentration of both major and minor elements but also on the individual elemental mapping and correlation between those elements at different spatial locations. Two samples of each type of leaf were taken and dried by two different methods to maintain their nutritional value to the highest extent. The solid sample of each leaf was used for micro-PIXE and the powdered sample for the broad beam -PIXE analysis. We obtained the elements in low concentrations and correlated some of the major elements for interesting areas. Our study also showed the distribution of elements in fresh and aged leaves of the same sample showing the increase in chlorine concentration in aged leaves thus turning them yellow. The relation between calcium and potassium yielded interesting arguments along with many trace elements playing a vital role in making these leaves fit for pharmaceutical use. Similarly, we have investigated the distributions of various elements in the air particulates collected from polluted urban areas.

1109

Microstructure Patterning for Dielectrophoresis-Based Collection of Microparticles for the Detection of Environmental Microplastics

Hironori Seki¹, Nitipon Puttaraksa¹, Hidetaka Hayashi², Ippei Yagi³, Satoshi Uchida³, Yasuyuki Ishii⁴, Hiroyuki Nishikawa¹

¹ *Shibaura Institute of Technology, 3-7-5 Toyosu, Koto-ku, Tokyo 135-8548, Japan*

² *NPO Ecodesign Promotion Network, Bunkyo-ku, Yayoi 2-11-16, Tokyo 113-8656, Japan*

³ *Tokyo Metropolitan University, 1-1 Minami-Osawa, Hachioji-shi, Tokyo 192-0397, Japan*

⁴ *National Institutes for Quantum Science and Technology, 1233 Watanukimachi, Takasakishi, Gunma 370-1292, Japan*

nishi@shibaura-it.ac.jp

There have been growing concerns about environmental plastics spreading in our environments including soils, rivers, and oceans, which might affect the ecosystem and human health. To understand the distribution and the formation mechanisms of so-called “microplastics”, we need to develop the detection techniques of microparticles ranging in size from micrometers to nanometers. We have been developing techniques to manipulate and collect the micro and nanoparticles such as microbes and metals utilizing dielectrophoresis (DEP). Our devices are typically equipped with microstructures of dielectrics to modulate electric field distribution that induces DEP force which can be switching repulsive and attractive depending on the frequency of applied AC voltage to manipulate micro/nanoparticles [1, 2]. The microstructures of dielectrics such as arrays of pillars and pits were fabricated by proton beam writing (PBW), which is a direct-write, versatile tool for micropatterning.

In this study, we present our study on the trapping effects of micro-sized particles by means of DEP using devices equipped with a single micro pit or arrays of DEP microstructures on 12- μm -thick PMMA fabricated by PBW. As a model of microplastics, we used commercially available polystyrene (PS) particles with diameters of 1 or 5 μm . We patterned the PMMA layer, spin-coated on an indium tin oxide (ITO) layer deposited on polyethylene terephthalate (PET) film. The PBW was performed using a PB writer with protons of beam energy of 1.0 MeV. After patterning the PMMA pit arrays by PBW, we fabricated a microfluidic channel with double-sided adhesive tapes of PET film with a thickness of 100 μm to provide a channel with a dimension of 100 μm in height, 5 mm in width, and 10 mm in length, where water suspension of the PS particles flowed by capillary force. We observed the trapping of the PS particles by DEP at arrays of various patterns, such as circles with diameters less than 50 μm , where the particles were collected not only at the inside and circumference of the circular pits but also at the spaces in between of the pits. We will discuss the trapping mechanisms of the PS particles based on the frequency dependence of applied voltages, and electric field analysis will be made to improve the trapping characteristics for the development of devices to detect environmental microplastics.

[1] Applications of microstructures fabricated by proton beam writing to electric-micro filters, Yusuke Furuta, Hiroyuki Nishikawa, Takahiro Satoh, Yasuyuki Ishii, Tomihiro Kamiya, Ryota Nakao, Satoshi Uchida, Nuclear Instruments and Methods in Physics Research B 267 (2009) 2285, doi:10.1016/j.nimb.2009.03.

[2] Assembling gold nanoparticles by dielectrophoresis with pit arrays on PMMA fabricated by proton beam writing, Taichi Shibuya, Satoshi Uchida, Yasuyuki Ishii, Hiroyuki Nishikawa, Nuclear Inst. and Methods in Physics Research B 456 (2019) 60–63. <https://doi.org/10.1016/j.nimb.2019.06.050>

1073

Chemical sensitivity of MeV-SIMS imaging mass spectrometry

Mirjana Vasić, Boštjan Jenčič, Žiga Barba, Mitja Kelemen, Matjaž Vencelj, Primož Vavpetič, Primož Pelicon

Institute Jožef Stefan, Ljubljana, Slovenia

mirjana.vasic@ijs.si

MeV-SIMS is a technique for chemical mapping of biomolecules in organic tissues [1][2]. Within this study, various concentrations of organic molecules were measured with TOF-MS MeV-SIMS in order to assess the limits of its chemical sensitivity. The samples of selected purified molecular material were diluted in logarithmic steps. In parallel, the same sets of solutions were spiked with NaTFA (sodium trifluoroacetate) 0,5g/100ml. The solutions were deposited on a silicon wafer, dried, and inserted into evacuated experimental chamber. MeV-SIMS measurements were executed with primary ion beams of ^{35}Cl at the energies/charge states of 5 MeV/5+, 7.2 MeV/6+ and 10 MeV/7+. Each sample was measured for 15 minutes on an area of $750\ \mu\text{m} \times 450\ \mu\text{m}$, which yields beam fluence of less than 109 ions/cm². All samples exhibited drastic increase of secondary ion yield after the addition of sodium trifluoroacetate. The results of the non-spiked samples demonstrate excellent chemical sensitivity, which suggests high MeV-SIMS potential for molecular imaging of biological tissue. In addition, the latest results and the feasibility study of chemical sensitivity on the applications of the MeV TOF-SIMS setup, will be presented.

- [1] Y. Nakata, S. Ninomiya, and J. Matsuo, "Secondary ion emission from bio-molecular thin films under ion bombardment," *Nuclear Instruments and Methods in Physics Research Section B: Beam Interactions with Materials and Atoms*, vol. 256, no. 1, pp. 489–492, 2007, doi: <https://doi.org/10.1016/j.nimb.2006.12.073>.
- [2] L. Jeromel et al., "Molecular imaging of human hair with MeV-SIMS: A case study of cocaine detection and distribution in the hair of a cocaine user," *PLOS ONE*, vol. 17, no. 3, pp. e0263338-, Mar. 2022, [Online]. Available: <https://doi.org/10.1371/journal.pone.0263338>

1024

Enhancing the irradiation capabilities of the AIFIRA cell micro-irradiation beamline

Barberet P., Orignac C., E. Torfeh, Devès G., Jouve J., Gobet F., Seznec H.

University of Bordeaux, CNRS, UMR 5797, LP2IB, F-33170 Gradignan, France.

philippe.barberet@u-bordeaux.fr

The AIFIRA facility in Bordeaux is equipped with a microbeam line dedicated to targeted irradiation for radiobiology studies. This beam line is designed to deliver a precise number of ions at the micrometer scales and to observe the cellular response online using time-lapse fluorescence microscopy [1]. Irradiations with low numbers of protons or alpha particles are controlled using thin transmission detectors [2,3].

In recent years, radiobiology studies performed on this beam line have required to extend the available dose range and dose rates. Initially developed to perform experiments at the micrometer scale, we have extended the irradiation features to deliver homogeneous doses on cm² areas using the same end-station. In addition, biophysical studies are currently underway to measure DNA fragmentation and these experiments require to cover a wide range of beam currents, from fA to several hundreds pA. Beam currents above 1 pA can be efficiently measured using Faraday cups and ammeters. We have specifically developed a fast counting system, based on a SiPM (Silicon Photomultiplier) to monitor intensities between 0.1 and 1 pA (i.e. about 10⁶ to 10⁷ ions / second). Using SiPM technology presents the advantage to have a very compact detector that can be permanently inserted on the sample holder. Finally, a precise characterisation of the microbeam using fluorescent nuclear track detectors (FNTD) have been performed. All these methodological developments will be presented.

[1] S. Bourret et al., « Fluorescence time-lapse imaging of single cells targeted with a focused scanning charged-particle microbeam », Nuclear Instruments & Methods in Physics Research Section B-Beam Interactions with Materials and Atoms, vol. 325, p. 27-34, (2014), doi: 10.1016/j.nimb.2014.02.004.

[2] G. Muggioli et al., « Single alpha-particle irradiation permits real-time visualization of RNF8 accumulation at DNA damaged sites », Scientific Reports, vol. 7, p. 41764, (2017), doi: 10.1038/srep41764

[3] P. Barberet et al., « Cell micro-irradiation with MeV protons counted by an ultra-thin diamond membrane », Applied Physics Letters, vol. 111, no 24, p. 243701, (2017), doi: 10.1063/1.5009713

1058

Calibration of the Segmented Annular Silicon Drift Detector

Ioannis Krimitsas¹, Mitja Kelemen², Esther Punzon-Quijorna², Primoz Pelicon²

¹ *University of Ioannina Physics, Athens-Greece*

² *Jozef Stefan Institute Low and Medium Energy Physics Ljubljana-Slovenia*

For particle induced X-ray emission (PIXE) measurements, the solid angle of the detector is one of the most important parameters for fast and effective experiments. By means of high solid angle, the required measuring time is significantly reduced under beam conditions which further reduces the damaging of the samples. To approach the solid angle of 1sr [1], we instead used a segmented annular detector at the micro-beam end station of the Jožef Stefan Institute accelerator laboratory.

The Rococo 2 segmented silicon drift detector consists of an SDD chip with a central hole of 1.8mm. Each segment is protected by a Be window that fits its crescent shape. Every segment has energy resolution of 130eV and is equipped with a pre-amplifier which provides a readout for each segment individually. In order to increase the statistics of the spectra, the GeoPIXE software allows us to fit spectra from all the 4 segments of the detector at once. To use this feature, a detailed description of the detector efficiency and geometry is needed.

The description of the detector was achieved by measuring thin metallic standards with emitted X-rays in the energy range of 1.7 keV to 27 keV. The measurements were performed in 1-1.5 kHz count rate regime and were recorded via the OMDAQ data acquisition system. The validation of the description was done on bulk samples. In the present work, we are going to analyze in detail the whole procedure of describing the detector as well as discuss the final results.

1086

Characterization of fluorescent nuclear track detector based on phosphate glass with silver and europium activator by focused proton microbeam

Wataru Kada¹, Aika Sasaki¹, Nozomu Kosuge¹, Shun Akiyama¹, Sota Orimo¹, Shigetaka Kimura¹, Kazuya Iiduka¹, Yuki Akagami¹, Naoto Yamada², Takahiro Satoh², Osamu Hanaizumi¹, Yasuyuki Ishii²

¹ Faculty of Science and Technology, Gunma University

² National Institutes for Quantum Science and Technology (QST)

kada.wataru@gunma-u.ac.jp

Particle Beam Writing (PBW) technique is a distinctive microfabrication technique with high selectivity of targets. Until now, PBW technique has been applied to microfabrication of polymer materials and defect engineering of wide bandgap semiconductor materials [1,2]. To obtain irradiation deliverables more rapidly, it is desired to accomplish precise beam monitoring techniques which allows us to evaluate the region of interest more rapidly during and more precisely after the irradiation. The Solid-State Nuclear Track Detector (SNTD) is commonly used for such usage to confirm particle irradiation. More recently, the Fluorescent Nuclear Track Detector (FNTD), which can be read-out irradiation position repeatedly, has been developed as an alternative to the SNTD. As a type of FNTD, we are investigating radio-photoluminescence (RPL) phosphate glasses (PG). In general, RPL dosimeters do not emit immediate luminescence, and in-situ evaluation using this material has not been realized. Also, it exhibits strong build-up effects that prevent its usage in real-time monitoring of high energy charged particle beams [3].

In this study, we aimed to engineer RPL phosphate glass as an FNTD and develop a device that enables convenient in-situ observation of PBW irradiation as well as precise post-irradiation pattern visualization through fluorescence. The co-doping of silver (Ag) and europium (Eu) as active centers in a base material composed of sodium metaphosphate (NaPO₃) and aluminum metaphosphate (Al(PO₃)₃) was used to fabricate PGs with an integrating function of FNTD and scintillator. The fabricated PG:Eu,Ag were subjected to PBW microbeam irradiation at QST-Takasaki. After irradiation, the fluorescence of possible silver active centers was observed in the irradiated area using a simple modular microscope (Olympus IX71) equipped with an excitation light source wavelength of 365 - 375 nm.

Scintillation were observed during PBW patterning on PG:Eu,Ag by 3 MeV protons. Fluorescence disappeared from areas other than the irradiation position, indicating that only the sequential irradiation position could be confirmed through scintillation. After the irradiation, PG:Eu,Ag was observed under ultra violet light exposure. The irradiated pattern was clearly observed as the patterns of radio-photoluminescence with spatial resolution of approximately in 1 μ m. The results suggested that we have successfully demonstrated an integration of FNTD with scintillator in same substrate.

Acknowledgements: This work has been partially supported by MEXT/JSPS Grant-in-Aid for Scientific Research. JP21K12522.

[1] W. Kada, et al., Nucl. Instr. and Meth. Sec. B., 348 (2015), pp.218-222, doi: 10.1016/j.nimb.2014.12.041.

[2] H. Kraus et al., Nano Letters, 17(5), (2016), pp. 2865-2870. doi: 10.1021/acs.nanolett.6b05395

[3] T. Kurobori, et al., Jpn. J. Appl. Phys., 57(2018) 106402, doi: 10.7567/JJAP.57.106402.

1107

Characterisation of radiation detectors by IBIC: overview of experiments performed through transnational access at RBI

Jakšić M., D. Cosic, A. Crnjac, S. Fazinić, G. Provas, M. R. Ramos, Z. Siketić, M. Vićentijević,

Ruđer Bošković Institute, Bijenička cesta 54, 10000 Zagreb, Croatia.

jaksic@irb.hr

Performance of over thirty experimental Sessions for external users of the RBI microprobe systems, with an aim to investigate charge transport properties of variety of detector structures, illustrates the strengths and the versatility of the ion microprobe technique IBIC. Experiments were funded in recent years through the transnational access (TA) scheme of the Horizon2020 projects AIDA2020 and RADIATE. Versatility of IBIC is demonstrated by the possibility to choose ions and their respective energies in a way to use appropriate ionization density and ion penetration depth for particular problem. Detectors based on different materials (Si, diamond, SiC, GaN, etc.) were probed to depths from as low as 100 nm (for 140 keV Cu ions in diamond) up to 0.5 mm (for 6 MeV protons in silicon). From very simple planar detector configurations, to complex multipixel detector arrays that may even include regions with charge multiplication, IBIC has shown to be the most suitable technique for resolving issues that limit targeted detector performances. Upgrades of the RBI microprobe systems that have been particularly useful include: possibility to study detectors at temperatures from 40K to 725 K, on-line monitoring of radiation damage, possibility to conduct in-air IBIC measurements, as well as performance of time resolved (e.g. TCT and QTS) experiments. Characteristic examples of external users' experiments will be presented.

Acknowledgement: The study was supported by Horizon2020 projects AIDA 2020 (grant no. 654168) and RADIATE (grant no. 824096).

1037

Bioimaging of single cells with nuclear microscopy: far more than morphology

I. Custódio^{1,2}, L.C. Alves^{1,3}, V. Corregidor^{1,3}, F. Marques^{1,3}, J. Cruz^{2,4}, T. Pinheiro^{1,5}

¹ Departamento de Engenharia e Ciências Nucleares, Instituto Superior Técnico, Universidade de Lisboa, Lisboa, Portugal

² NOVA School of Science and Technology, NOVA University Lisbon, Campus Caparica, 2829-516 Caparica, Portugal

³ C2TN, Centro de Ciências e Tecnologia Nuclear

⁴ LIBPhys—Laboratory of Instrumentation, Biomedical Engineering and Radiation Physics, 2829-516 Caparica, Portugal

⁵ IBB, Instituto de Bioengenharia e Biociências

teresa.pinheiro@tecnico.ulisboa.pt

Nuclear microscopy offers unique possibilities in single cell analysis. By combining common techniques such as, STIM, PIXE and EBS techniques together with ion beam analytical tools, such as OMDAQ2007 and WinDF, cells can be characterized beyond mass and elemental distributions. The depth structure of cells and the depth distribution of endogenous and exogenous elements can be obtained, providing detailed insights into the complex organisation of single cells.

The main goal is to establish biological signatures of single cells that will enable to identify cellular alterations upon exposure to metal complexes quantify the uptake and identify cellular targets.

To define biological patterns, ovarian cancer cell lines A2780, OVCAR3 (cisplatin sensitive) and OVCAR8 (cisplatin resistant) were used. A gold complex¹ which had shown promising biological properties was selected to examine its uptake and depth distribution in treated cells. Single cells were analysed in vacuum at the IST/CTN nuclear microprobe (Oxford Microbeams Ltd., UK) under routine conditions (2.0MeV proton beam of 100pA, and spatial resolution $\sim 3 \times 4 \mu\text{m}^2$). For biological signatures, features such as, cell morphology, elemental compartmentalization and quantitation, and layer structure, were considered. Data was obtained by combining STIM, PIXE and EBS spectral information. Data acquisition, 2D mass and elemental maps, and elemental concentrations were carried out using OMDAQ 2007 software.² To define a high-resolution depth profile structure of the different cell lines, a WinNDF approach combining EBS and PIXE data for multi-layered structured samples was used.³

Results showed that structural details of A2780, OVCAR3 and OVCAR8 were similar, although minor morphological details associated with P and S compartmentalization were detected for OVCAR8. However, after incubation with the gold complex a differential elemental compartmentalization of P, S and K was observed for the three cell lines, which were not correlated with differences in cellular permeability for the gold complex. Altogether, the biological signatures, layer structure, and distribution pattern of gold in the three cell lines launched the basis of a cell inventory that will help identifying possible cellular targets for the studied gold complex. The approach is also very important to define strategies for the identification of modes of action of new metal-based drugs with therapeutic potential.

[1] Costa JP, Sousa SA, Soeiro C, et al. (2021) Synthesis and Characterization of Camphorimine Au(I) Complexes with a Remarkably High Antibacterial Activity towards *B. contaminans* and *P. aeruginosa*. *Antibiotics* 10: 1272.

[2] <http://www.microbeams.co.uk/index.html> (accessed May 2022)

[3] Barradas NP, Jeynes C (2008) Advanced physics and algorithms in the IBA DataFurnace, *NIMB* 266:1875–1879.

1043

Proton irradiation induced changes in Polyvinyl Butyral (PVB) support films for analysis of biomedical samples in the MeV ion microprobeHarry J. Whitlow¹, Gyula Nagy², François Villinger³¹ University of Oslo Department of Physics Oslo-Norway² Uppsala Universitet Tandem Laboratory Uppsala-Sweden³ University of Louisiana at Lafayette New Iberia Research Center New Iberia-United Statesh.j.whitlow@fys.uio.no

Support films are important for analysis in the MeV ion microprobe of biological cell suspensions and tissue sections. Si₃N₄ membranes have been used for cells e.g. [1]. Pioloform® which is a linear random terpolymer with polyvinyl butyral (PVB), polyvinyl alcohol (PVA) and polyacetate (PAC) repeating units (RU). Pioloform has been used by the CIBA group in Singapore and by some of us in Lafayette [2] for supporting tissue sections for analysis with a MeV ion microbeam. PVB has the advantage that is mechanically strong, can be easily mounted on a supporting ring to give a ~0.5 μm self-supporting films containing only C, H and O. PVB is expected to have a high resistance to degradation under irradiation because the repeating unit structure is largely made up of a heterocyclic ring which are generally act as sinks for excitation energy [3]. Recently, we have proposed to use PVB as an internal standard to quantify the major element content of dehydrated tissue sections. Hence, a quantitative understanding of the ion-irradiation degradation of PVB is important. Ion-irradiation induced degradation of PVB will also affect the energy loss contrast in on- and off-axis Scanning Transmission Ion Microscopy (STIM). In this preliminary study, the samples were prepared by dipping a substrate and subsequently floating-off the Pioloform films on deionized water where they were picked up on supporting stainless steel rings. The loss of the constituent elements, H, C and O were measured using 2 MeV protons at the microprobe beamline at the Tandem accelerator Laboratory of the University of Uppsala. This was done by measurement of the H, C and O signals using off-axis Scanning Transmission Ion Microscopy (OA-STIM) at 30° and simultaneously the C and O signals by Rutherford Backscattering Spectrometry (RBS). The GeoPIXE code was used to produce 1D energy spectra. The results revealed a loss of material from the film with increasing fluence. The fluence dependence of the C and O contents measured with RBS and OA-STIM C and RBS were in agreement within the limits of statistical uncertainty. The H and C signal dependence on fluence could be fitted with the sum of an exponential decay and a constant residual content. O-loss exhibited a more complex behavior indicating O-loss through at least two processes. The O/C composition from OA-STIM and RBS, extrapolated to zero fluence corresponded to a composition with one H₂O molecule absorbed per RU.

[1] Ren M., van Kan, J.A, Bettioli A., Lim D., Chan Y. G., Bay. B. H., Whitlow H.J., Osipowicz T., Watt F. (2007); Nano-imaging of single cells using STIM; Nuclear Instrum. Methods B 260; 124.

[2] Whitlow H.J., Deoli, N De Vera A., Morgan K., Villinger F. (2021); Heavy Elements Revealed in Jejunum of Simian Immunodeficiency Virus Infected Monkeys by Microparticle Induced X-Ray Emission; Phys Stat. Sol. A 218; <https://doi.org/10.1002/pssa.202000107>

[3] Chapiro A., (1988); Chemical modification of organic polymers; Nucl. Instrum. Methods B 32:111-114

1057

Artificial Neural Networks for high-resolution 3D imaging

Miguel Furtado^{1,2}, Inês Custódio^{1,3}, Teresa Pinheiro^{1,4}, Rui da Silva^{1,5}, Luís Alves^{1,6}, Victoria Corregidor^{1,6}

¹ Departamento de Engenharia e Ciências Nucleares, Instituto Superior Técnico, Universidade de Lisboa, Lisboa, Portugal

² Departamento de Física, Instituto Superior Técnico, Universidade de Lisboa

³ NOVA School of Science and Technology, NOVA University Lisbon, Campus Caparica, 2829-516 Caparica, Portugal

⁴ IBB, Instituto de Bioengenharia e Biociências

⁵ IPFN, Instituto de Plasmas e Fusão Nuclear

⁶ C2TN, Centro de Ciências e Tecnologias Nucleares

victoria.corregidor@tecnico.ulisboa.pt

Rutherford Backscattering Spectrometry (RBS) spectra, when recorded using a nuclear microprobe, allows visualizing the elemental distribution in 2D maps, to identify the elemental matrix of an unknown sample and the depth profiling of those elements. Using OMDAQ software, each scanned area is acquired as a 256x256 pixel map, each pixel containing all the IBA spectra recorded during the experiment.

A step forward in 3D imaging would be to represent the elemental depth profiling obtained in each pixel of the map. This means to analyse more than 65 thousand RBS spectra, or more than 16 thousand spectra if the maps suffer a 2x2 pixel compression. In any case, the number of RBS spectra to be analyzed requires time and computing resources. To tackle this problem we are developing an artificial neural networks (ANNs) model, which once trained, can handle the analysis of large data sets instantaneously [1]. The potential of ANNs to automatically render depth profiles of several types of samples in a 3D environment will definitely extend the imaging capabilities of nuclear microprobes.

Herein we will report on an ANNs method to perform an automated analysis and classification of RBS spectra recorded during nuclear microscopy analysis of cells exposed to Cu and Au complexes or nanoparticles [2,3]. The 3D visualization of cellular distribution of Cu and Au, were previously obtained using the MORIA software by calculating the energy loss of the RBS spectra [2]. However, MORIA generates a solution for 3D visualization of heavy elements in light sample matrices. The development of an ANN algorithm trained to find a general solution for depth profiling using RBS data, has to be indifferent to sample elemental composition. In this context the results obtained with MORIA are very important in the validation of an ANN model. Challenges as the low statistics of the RBS spectra, the estimated time requirements for training the ANNs, or the visualization of the results will be presented and discussed.

[1] J. Demeulemeester, D. Smeets, N.P. Barradas, A. Vieira, C.M. Comrie, K. Temst, A. Vantomme, (2010) Artificial neural networks for instantaneous analysis of real-time Rutherford backscattering spectra. Nucl Instruments Methods Phys Res Sect B Beam Interact with Mater Atom, 268: 1676-1681. Doi: 10.1016/j.nimb.2010.02.127

[2] M. Vasco, L.C. Alves, V. Corregidor, D. Correia, C. Godinho, I. Sá-Correia, I., A. Bettiol, F. Watt, T. Pinheiro, (2017) 3D map distribution of metallic nanoparticles in whole cells using MeV ion microscopy. Journal of Microscopy, 267: 227-236. <https://doi.org/10.1111/jmi.12561>

[3] Dominelli B, Jakob CHG, Oberkofler J, Fischer PJ, Esslinger E-M, Reich RM, Marques F, Pinheiro T, Correia JDG, Kühn FE. Mechanisms underlying the cytotoxic activity of syn/anti-isomers of dinuclear Au(I) NHC complexes. European Journal of Medicinal Chemistry 2020;203:112576. DOI:10.1016/j.ejmech.2020.112576

1083

At the roots of the multiscale imaging of biological samples: charting the connectivity between kingdoms

Marjana Regvar¹, Matevž Likar¹, Mateja Potisek¹, Paula Pongrac^{1,2}, Jure Mravlje¹, Katarina Vogel-Mikuš^{1,2}, Marijan Nečemer², Mitja Kelemen², Primož Vavpetič², Primož Pelicon²

¹ Biotechnical Faculty, University of Ljubljana, Ljubljana, Slovenia

² Jožef Stefan Institute, Ljubljana, Slovenia

marjana.regvar@bf.uni-lj.si

Plant structures are defined across differing scales. Subcellular organization of nanometer proportions predisposes structural composition at the micro, meso, and macro levels. However, plant tissues are not sterile. In the contrary, they are frequently colonized by organisms from different groups (viruses, bacteria, fungi).

Below the surface, roots of higher plants are colonized by fungi from differing taxonomic groups forming distinct structures called morphotypes. Using light microscopy, we discovered different fungal morphotypes on the willow's (*Salix caprea*) root system from a metal polluted area [1]. Beneficial fungal endophytes are of immense importance for successful phytoremediation [2]. However, not all fungi on plant roots are symbiotic and beneficial. To reveal the contribution of differing morphotypes to plant metabolism, we applied micro-particle-induced X-ray emission (micro-PIXE) for quantitative tissue-specific analysis of elements, thus allowing for discerning metal tolerance mechanisms in plants [3]. Expectedly, both fungal and plant partners had distinct elemental compositions. Even more, tissue-specific elements were found that enabled us to discern diverse plant tissues within a single root.

The structural composition of morphotypes is even more complex than the roots themselves. Scanning electron microscopy coupled with energy-dispersive X-ray spectroscopy (EDS) analysis was applied to allow for a more detailed insight into the morphotype's morphology and composition at the micro scale.

This experiment confirms that micro-PIXE is a suitable technique for charting plant-fungal interactions using quantitative tissue-specific elements analysis and that multiscale elemental analyses are required to improve our understanding of the mechanisms behind inter-kingdom interactions.

- [1] Regvar, M., Likar, M., Piltaver, A., Kugonič, N., & Smith, J. E. (2009). Fungal community structure under goat willows (*Salix caprea* L.) growing at metal polluted site: the potential of screening in a model phytostabilisation study. *Plant and Soil*, 330(1–2), 345–356. <https://doi.org/10.1007/s11104-009-0207-7>
- [2] Regvar, M., Vogel-Mikuš, K., Kugonič, N., Turk, B., & Batič, F. (2006). Vegetational and mycorrhizal successions at a metal polluted site: Indications for the direction of phytostabilisation? *Environmental Pollution (Barking, Essex : 1987)*, 144(3), 976–984. <https://doi.org/10.1016/j.envpol.2006.01.036>
- [3] Vogel-Mikuš, K., Simčič, J., Pelicon, P., Budnar, M., Kump, P., Nečemer, M., Mesjasz-Przybyłowicz, J., Przybyłowicz, W. J., & Regvar, M. (2008). Comparison of essential and non-essential element distribution in leaves of the Cd/Zn hyperaccumulator *Thlaspi praecox* as revealed by micro-PIXE. *Plant, Cell and Environment*, 31(10), 1484–1496. <https://doi.org/10.1111/j.1365-3040.2008.01858.x>

1103

Co-location of lipids, drugs and metal biomarkers using spatially resolved lipidomics with elemental mapping

Holly-May Lewis¹, Catia Cost^{1,2}, Véronique Dartois³, Firat Kaya³, Mark Chambers⁴, Janella de Jesus⁴, Vladimir Palitsin², Roger Webb², Melanie J. Bailey¹

¹ Department of Chemistry, University of Surrey, Guildford, Surrey GU2 7XH, UK

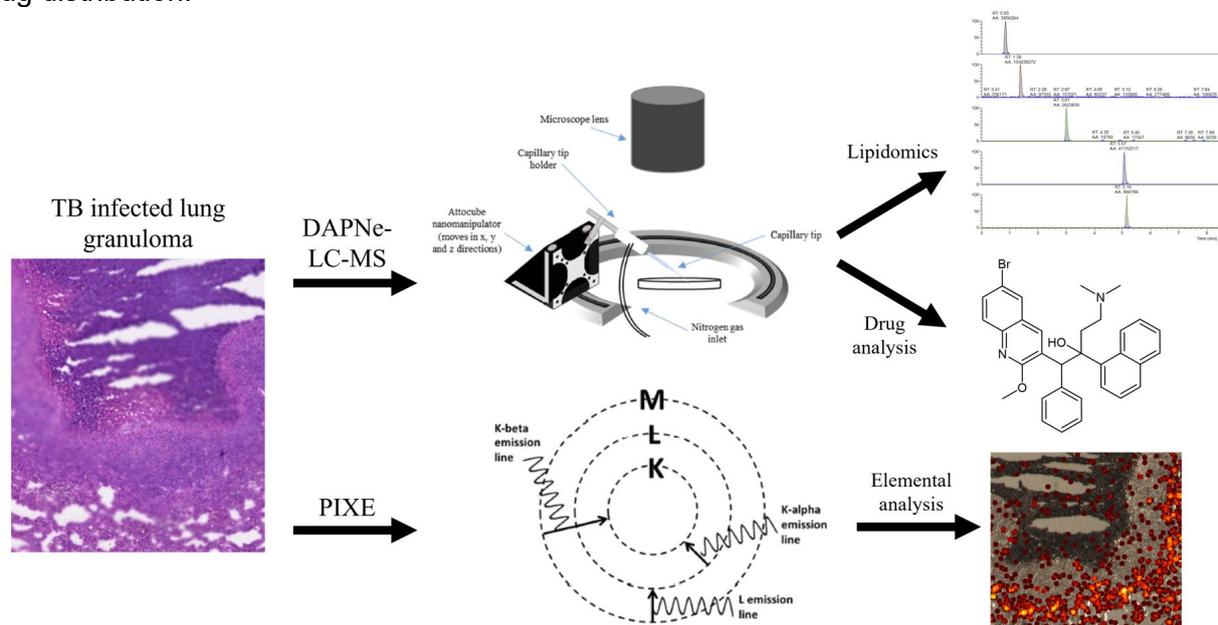
² University of Surrey Ion Beam Centre, Guildford, Surrey GU2 7XH, UK

³ Center for Discovery and Innovation, Hackensack Meridian School of Medicine, Nutley, New Jersey, USA

⁴ Faculty of Health and Medical Sciences, University of Surrey, Guildford, Surrey GU2 7XH, UK

m.bailey@surrey.ac.uk

Elemental imaging is widely used for imaging cells and tissues but rarely in combination with organic mass spectrometry, which can be used to profile lipids and measure drug concentrations. Here we demonstrate how elemental imaging using PIXE and a new method for spatially resolved lipidomics (DAPNe-LC-MS [1,2], based on capillary micro-sampling and liquid chromatography mass spectrometry) can be used in combination to probe the relationship between metals, drugs and lipids in discrete areas of tissues. This new method for spatial lipidomics, reported here for the first time has been applied to rabbit lung tissues containing a lesion (caseous granuloma) caused by tuberculosis infection. We demonstrate how elemental imaging with spatially resolved lipidomics, can be used to probe the association between ion accumulation and lipid profiles and verify local drug distribution.



[1] de Jesus, J.; Bunch, J.; Verbeck, G.; Webb, R. P.; Costa, C.; Goodwin, R. J. A.; Bailey, M. J., Application of Various Normalization Methods for Microscale Analysis of Tissues Using Direct Analyte Probed Nanoextraction. *Analytical Chemistry* **2018**, *90* (20), 12094-12100

[2] Lewis, H.-M.; Webb, R. P.; Verbeck, G. F.; Bunch, J.; de Jesus, J.; Costa, C.; Palitsin, V.; Swales, J.; Goodwin, R. J. A.; Sears, P.; Bailey, M. J., Nanoextraction Coupled to Liquid Chromatography Mass Spectrometry Delivers Improved Spatially Resolved Analysis. *Analytical Chemistry* **2019**, *91* (24), 15411-15417

1108

Towards high spectral AND spatial resolution in a single PIXE system: development of a microbeam line with a microcalorimeter detectorPierre Couture¹, Vladimir Palitsin¹, Kevin Phelan², Geoff Grime¹, Roger Webb¹, Melanie J. Bailey^{1,3}¹ *University of Surrey Ion Beam Centre, Guildford, Surrey GU2 7XH, UK*² *Kaon*³ *Department of Chemistry, University of Surrey, Guildford, Surrey GU2 7XH, UK*m.bailey@surrey.ac.uk

The University of Surrey Ion Beam Centre has recently been awarded funding for a new microcalorimeter X-ray detector for particle induced X-ray emission (PIXE). These detectors can provide 1 eV energy resolution at 5 keV. Single pixel microcalorimeter detectors have been used in conjunction with PIXE before, but to our knowledge, this is the first system, and first multi-pixel detector to be installed on a nuclear microprobe. A resolution of ~1 eV is sufficient to enable the disambiguation of overlapping peaks and has been shown to reduce the minimum detectable limit by an order of magnitude. It is also sufficient to provide information on chemical shifts to provide information on the chemical state of atoms [1]. Our vision is to use this detector to catalyze new applications in several disciplines. For example in biosciences, the system could enable the multiplexed detection of lanthanide tags, which are used to image proteins, or to determine the binding state of bioaccumulated metals. In forensics and environmental science, the detector may be used to provide enhanced discrimination power for particulate materials and in earth sciences it could help to measure the phase partition of rare earth elements used as geothermometers. In this poster, we will report on progress towards the design and installation of a microcalorimeter detector on our microbeam line, for high energy resolution imaging.

[1] Chemical State Analysis Employing Sub-Natural Linewidth Resolution PIXE Measurements of K α lines, M. Kavi, et al., X-Ray Spectrom. 34, 310, (2005)

Through different eyes... Forty years of nuclear microscopy at the micrometre scale

Geoffrey W. Grime

Ion Beam Centre Guildford, United Kingdom

g.grime@surrey.ac.uk

2020 marked the fortieth anniversary of the first published images using ion beam analysis (IBA) at a spatial resolution of 1 micrometre. IBA exploits the reaction products emitted when samples are exposed to a beam of megaelectron volt ions from a small nuclear accelerator. These include light and X-rays from atomic electrons, particles and gamma rays from the nuclei and forward or backward scattered beam particles. These can provide elemental concentrations with high sensitivity, specificity and accuracy. In many cases, depth profiles, structural and chemical information can also be measured. In the late 1970s, our group in Oxford developed the techniques for focusing high energy ion beams to micrometre size diameters and so produced the first imaging nuclear microprobe. Now the technique is available in laboratories across the world and is applied in fields ranging from archaeology to zoology. In this talk, I will outline the background and history of the nuclear microprobe and describe two recent projects carried out at the University of Surrey which highlight the wide range of applications: the reconstruction of the lost image on a weathered stained-glass window and identifying the metal atoms in protein molecules.

MULTIMODAL IMAGING

Chairs: Johanna von Gerichten and Teresa Pinheiro

Invited talk

1100

IBA Imaging Techniques - exploring their potential in forensics as independent tools and within a multimodal approachMarko Barac¹, Katherine Moore¹, Andrijana Filko², Zdravko Siketić¹, Marko Brajković¹, Melanie Bailey³, Andrea Ledić², [Iva Bogdanović Radović¹](mailto:iva@irb.hr)¹Division of experimental physics, Ruđer Bošković Institute, Bijenička 54, 10000 Zagreb, Croatia²Forensic Science Centre "Ivan Vučetić", Ilica 335, 10000 Zagreb – Croatia³Department of Chemistry, University of Surrey, Guildford, Surrey GU2 7XH, UKiva@irb.hr

In recent years, the Laboratory for Ion Beam Interactions has participated in several international projects (COST Action, IAEA CRP) aimed at exploring the potential of Ion Beam Analysis (IBA) imaging techniques and multimodal imaging in solving some difficult problems in forensic science. Here we will present the results obtained so far in the field of analysis of questioned documents. It will be demonstrated how elemental and molecular imaging using proton-induced X-ray emission and secondary ion mass spectrometry with MeV ions (MeV SIMS) can detect the correct order of deposition of different types of inks and toners [1]. MeV SIMS is a relatively new analytical technique in the ion beam community and is at the same time completely unknown to forensic community. Technique detects molecules from uppermost layers of the sample making it suitable for determining the order of deposition. Also, in cooperation with forensic experts from the Ivan Vučetić Center for Forensic Science, several very difficult cases were studied using standard non-destructive forensic techniques (optical techniques, Raman) and MeV SIMS. The studied cases are divided into those in which optical techniques can distinguish the inks used from those that are not completely different from them. In the cases of indistinguishable inks, the mass spectra of the inks used were also found to be very similar, indicating an almost identical chemical composition of the inks used. However, these very small differences in mass spectra in combination with advanced and objective analytical models were sufficient to resolve the correct order of deposition at the intersections in most of the cases studied [2].

[1] Moore KL, Barac M, Brajković M, Bailey MJ, Siketić Z., Bogdanović Radović I., Determination of Deposition Order of Toners, Inkjet Inks, and Blue Ballpoint Pen Combining MeV-Secondary Ion Mass Spectrometry and Particle Induced X-ray Emission. // *Analytical chemistry*, 91 (2019), 20; 12997-13005

[2] Barac M., Filko A., Siketić Z., Brajković M., Ledić A., Radović, Bogdanović Radović I., Comparison of optical techniques and MeV SIMS in determining deposition order between optically distinguishable and indistinguishable inks from different writing tools // *Forensic Science International*, **331** (2022), 111136-111146

1018

Sequential molecular and elemental imaging on a single tissue section using DESI and PIXE

Melanie Bailey

University of Surrey Chemistry Guildford-United Kingdom

m.bailey@surrey.ac.uk

Elemental and molecular imaging play a crucial role in understanding disease pathogenesis but are rarely used in combination. However co-localising elements and metabolites is important to biologists understanding the impact of metallic impurities or bioaccumulated metals on the host. To accurately correlate elemental and molecular markers, it is desirable to perform sequential elemental and molecular imaging on a single-tissue section. However, very little is known about the impact of performing these measurements in sequence.

In this presentation, we highlight some of the challenges and successes associated with performing elemental mapping in sequence with mass spectrometry imaging. Specifically, the feasibility of molecular mapping using the mass spectrometry imaging (MSI) techniques matrix-assisted laser desorption ionization (MALDI) and desorption electrospray ionization (DESI) in sequence with the elemental mapping technique particle-induced X-ray emission (PIXE) is explored. Challenges for integration include substrate compatibility, as well as delocalization and spectral changes. We demonstrate that, further to our published work [1], delocalisation of trace elements can be mitigated through adaption of the DESI method. This allows sequential DESI-PIXE imaging without any compromises to either the DESI or PIXE spectra. This approach will enable research into the impact of metal accumulation to the host metabolism in tissues and should be of broad interest in the biosciences.

1001

Exploring new methods to monitor proton beam damage for sequential elemental and molecular imaging on a single tissue section

C. Costa¹, J de Jesus^{2,3}, C. Nikula³, G. Grime¹, V. Palitsin¹, R. Webb¹, R. J. A. Goodwin^{4,5}, J. Bunch³, M. Bailey^{1,2}

¹ University of Surrey Ion Beam Centre, Guildford, Surrey GU2 7XH, UK

² Department of Chemistry, University of Surrey, Guildford, Surrey GU2 7XH, UK

³ The National Physical Laboratory, Teddington, Middlesex TW11 0LW, UK

⁴ Imaging and Data Analytics, Clinical Pharmacology and Safety Science, R&D, AstraZeneca, Cambridge, UK

⁵ Institute of Infection, Immunity and Inflammation, College of Medical, Veterinary and Life Sciences, University of Glasgow, Glasgow, UK

c.d.costa@surrey.ac.uk

Monitoring the effects of proton beam damage in biological materials is of interest to enable the integration of proton microprobe elemental mapping with molecular imaging modalities and further our knowledge of chemical changes caused to tissues during proton beam cancer therapy. In a recent publication, de Jesus *et al.* [1] reports on performing sequential mass spectrometry imaging (MSI) and ion beam analysis (IBA) on the same tissue sample. Data indicated that irradiating the sample with a proton beam caused measurable changes in the lipid profiles detected between irradiated and non-irradiated regions. Here we describe a novel approach to characterise proton beam damage to lipids in biological tissues, based on mass spectrometry imaging, specifically desorption electrospray ionisation (DESI). The developed methodology is applied to characterise changes to lipid profiles irradiated under different conditions: ambient pressure, high vacuum, beam scan speed and pattern and application of a matrix to the sample. This work shows that performing proton beam irradiation at ambient pressure, as well as the application of an organic matrix prior to irradiation can reduce changes in lipid profiles in tissues.

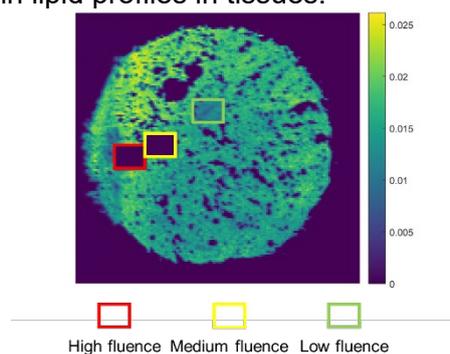


Figure 1: Extracted ion map for m/z 848.557 (tentatively assigned to PC 38:4) from a liver tissue homogenate sample, obtained using DESI following irradiation with a 2.5 MeV proton beam under vacuum, irradiated at low, medium and high fluences.

[1] de Jesus JM, Costa C, Burton A, Palitsin V, Webb R, Taylor A, Nikula C, Dexter A, Kaya F, Chambers M, Dartois V, Goodwin RJA, Bunch J, Bailey MJ (2021) Correlative Imaging of Trace Elements and Intact Molecular Species in a Single-Tissue Sample at the 50 μ m Scale. *Analytical Chemistry* 93 (40):13450-13458. doi: <https://doi.org/10.1021/acs.analchem.1c01927>

Application of segmented annular Silicon Drift Detector for 3-D surface topography reconstruction by micro-PIXE

Ebrahim Gholami Hatam¹, Primož Pelicon², Esther Punzon², Mitja Kelemen^{2,3}, Primož Vavpetič² and Paula Pongrac^{2,4}

¹ Department of Physics, Science faculty, Malayer university, Malayer, Iran

² Jožef Stefan Institute, Jamova 39, SI-1000 Ljubljana, Slovenia

³ Jožef Stefan International Postgraduate School, Jamova cesta 39, 1000 Ljubljana, Slovenia

⁴ Biotechnical Faculty, University of Ljubljana, Jamnikarjeva 101, 1000 Ljubljana, Slovenia

e.gholami@malayeru.ac.ir

Having access to the third dimension of elemental distribution either in the form of surface topography or in the form of height profile is valuable when evaluating the experimental data in ion beam community. Authors, previously, had introduced an innovative approach to reconstruct the surface topography using stereovision of the 2D elemental X-ray map induced by focused MeV proton beams [1-5]. The proposed method using two X-ray spectrometer was restricted to drive the inclination angles just in the lateral direction of the obtained maps. Here, we benefit from the four segment Silicon Drift Detector (SDD), with an annular symmetric geometry mounted at the Jožef Stefan Institute (JSI) microprobe, to reconstruct the roughness height profile both in the lateral and longitudinal direction of the obtained 2D X-ray elemental maps.

We proposed that stereo-PIXE method can be extended to the four-segment detector by considering a set of stereovision maps acquired by individual segment. In a similar manner as in [1], the X-ray intensity disparity from the multi view of the elemental distribution, applying an ideal flat reference model of the sample, was used to infer the normal surface angle and in consequence the gradient of the topography along the planes that intersect the two opposing segments. Consequently, we executed the integration of the height gradient in the two orthogonal directions along the sample surface in order to reconstruct the 3-D sample surface tomography profile. The method is demonstrated on the bulk Ti sample with engraved grid structure.

Acknowledgment: This work was supported by the TNA No. 21002430-ST within the EU H2020 project No. 824096 RADIATE.

- [1] Gholami Hatam E, Pelicon P, Lamehi-Rachti M, et al (2012) Surface topography reconstruction by stereo-PIXE. *J Anal At Spectrom* 27:834-40. doi: 10.1039/C2JA10373G
- [2] Gholami Hatam E, (2012) Surface topography of 1€ coin measured by stereo-PIXE. *Nucl Instruments Methods Phys Res Sect B Beam Interact with Mater Atoms* 306:90-93. doi: 10.1016/j.nimb.2012.12.024
- [3] Gholami Hatam E, (2015) Reconstruction of relief by means of stereo-PIXE set-up for curved target. *Nucl Instruments Methods Phys Res Sect B Beam Interact with Mater Atoms* 348:48-52 doi: 10.1016/j.nimb.2015.01.047
- [4] Gholami Hatam E, (2017) Void and cavity determination in micro-PIXE analysis of composed material using binocular detectors: A computational study. *Nucl Instruments Methods Phys Res Sect B Beam Interact with Mater Atoms* 404:189-92 doi: 10.1016/j.nimb.2017.01.066
- [5] Gholami Hatam E, (2019) The application of stereo scanning transmission ion microscopy (stereo-STIM) imaging in biological specimen. *Nucl Instruments Methods Phys Res Sect B Beam Interact with Mater Atoms* 450: 127-30 doi: 10.1016/j.nimb.2018.11.014

1082

Tartary buckwheat grain as a model for spatially-resolved element and molecular distribution in plants: solving structurally-related biochemistry using multimodal imaging

Paula Pongrac^{1,2}, Boštjan Jenčič¹, Martin Šala³, Katarina Vogel-Mikuš^{1,2}, [Marjana Regvar](mailto:marjana.regvar@bf.uni-lj.si)², Mitja Kelemen¹, Primož Vavpetič¹, Ivan Kreft⁴, Aleš Kladnik², Primož Pelicon¹

¹ Jožef Stefan Institute, Ljubljana, Slovenia

² Biotechnical Faculty, University of Ljubljana, Ljubljana, Slovenia

³ National Institute of Chemistry, Ljubljana, Slovenia

⁴ Nutrition Institute, Ljubljana, Slovenia

marjana.regvar@bf.uni-lj.si

Elements and metabolites in plant tissues are strongly affected by the environment in which they are produced. Homeostatic controls, therefore, exist to neutralize their potential adverse effects that strictly depend on the properties of the structures of target cells and tissues. Micro-particle-induced X-ray emission (micro-PIXE) enables quantitative tissue-specific spatial analysis of nutritionally important and potentially harmful elements in freeze-dried or frozen-hydrated samples with an imaging resolution below 1 μm . Secondary Ion Mass Spectrometry (SIMS) imaging method, referred to as MeV-SIMS [1], is a complementary technique used for molecular imaging of biological tissues where large non-fragmented bio-molecules are to be analyzed. As such, both methods have an excellent potential to help resolve fundamental questions in food quality and safety.

To demonstrate the applicability of these two complementary techniques, we selected Tartary buckwheat (*Fagopyrum tataricum* Gaertn.) grain as a suitable model due to its high tissue diversity resembled in distinct elemental spatial resolution demonstrated previously using micro-PIXE [2] and its large concentrations of antioxidants rutin and quercetin [3]. Both analyses can be performed subsequently at the accelerator facility of Jožef Stefan Institute, Slovenia. Targeted and non-targeted approaches were used. However, the identification of metabolites and their biological interpretations remains challenging. Therefore, it is of utmost importance that these structures remain intact and discernable during sample preparation and imaging. After micro-PIXE, the morphology of the sample was captured using scanning electron microscopy followed by laser-ablation-inductively-coupled plasma MS to determine localisation of Al and Si with better sensitivity. Furthermore, prior to the MeV-SIMS, bright light and UV-excitation microscopies were used to capture morphology of the sample. This example demonstrates Tartary buckwheat grain is a well-suited model for testing several complementary techniques on the same heterogeneous, plant specimen of intermediate thickness.

[1] Nakata Y, Honda Y, Ninomiya S, Seki T, Aoki T, Matsuo J. Yield enhancement of molecular ions with MeV ion-induced electronic excitation. *Appl Surf Sci.* 2008;255:1591–4.

[2] Pongrac P, Vogel-Mikuš K, Jeromel L, Vavpetič P, Pelicon P, Kaulich B, et al. Spatially resolved distributions of the mineral elements in the grain of tartary buckwheat (*Fagopyrum tataricum*). *Food Res Int.* 2013;54:125–31.

[3] Fabjan N, Rode J, Košir IJ, Wang Z, Zhang Z, Kreft I. Tartary buckwheat (*Fagopyrum tataricum* Gaertn.) as a source of dietary rutin and quercitrin. *J Agric Food Chem.* 2003;51:6452–5. doi:10.1021/jf034543e.

DETECTORS

Chairs: Željko Pastuović and Shigeo Matsuyama

Invited talk

1035

Development and characterisation of 3D MEMS technologies for isotropically responsive silicon radiation dosimeters.

Marco Petasecca¹, Owen Brace¹, Jeremy Davis¹, Angela Kok², Marco Povoli², Zeljko Pastuovic³, Anatoly Rosenfeld¹

¹ University of Wollongong Centre for Medical Radiation Physics Wollongong-Australia

² SINTEF Digital / Microsystems and Nanotechnology Oslo-Norway

³ ANSTO Centre for Accelerator Science Sydney-Australia

marcop@uow.edu.au

In recent years, a great deal of research has gone into develop radiation detectors with an isotropic response to radiation fields. Applications such as dosimetry for radiotherapy, space medicine, radioprotection impose scenarios so complex that the current detector technology and instrumentation does not satisfy the required performance. This work presents an overview of our approach, methods and achievements in addressing this technology gap using 3D MEMS technologies. 3D MEMS, successfully adopted in the past for applications such as microdosimetry, can be used to fabricate a detector with an electric field uniformly distributed across the entire sensitive volume, without any passive layer. Such detector would have a response that is invariant in respect to the direction of the radiation. This can be achieved by the use of active edges which consist in the creation of p-n junctions at every edge of the substrate. Two innovative technologies are proposed: a perforated edge detector from SINTEF (Norway) which requires no handling wafer, and the edgeless sensors by VTT (Finland), fabricated with a laterally ion implantation technique. The IBIC microscopy proved again to be an indispensable tool for prototyping semiconductor detectors with complex configurations on the micrometre scale. The perforated edge devices show a basic p+/n/n+ structure. The n-type substrate is 300 μm thick with an area of $5 \times 5 \text{ mm}^2$. The edges are perforated by deep reactive ion etching in various distribution and geometries (N,R,O,V) [1]. The edgeless sensors from VTT are manufactured using a handling wafer and lateral implantation of Boron and Phosphorous ions. The substrate is 10 k $\Omega\text{-cm}$ p-type (samples PP/NP) or n-type (PN/NN), $1.5 \times 1.5 \text{ mm}^2$ and thicknesses of 100 and 500 μm [2]. The sensors have been investigated by IBIC using a high-resolution scanning 5.5 MeV He²⁺ ion microbeam before and after irradiation with a Co-60 gamma source in order to evaluate the effect of accumulated dose on the charge collection efficiency. The effectiveness of the active edge technologies to create a uniform electric field distribution has been quantitatively assessed as a function of the reverse bias applied, the type of substrate and geometries of the trenches. Synopsys TCAD simulations was used for inter-pretation of the IBIC results and they will be presented in full at the conference.

[1] O. Koybasi, et al., Nuclear Instruments and Methods in Physics Research Section A, vol. 953, p. N.PAG, 2020.

[2] M. Petasecca, et al., Medical physics (Lancaster), vol. 42, no. 8, pp. 4708–4718, 2015.

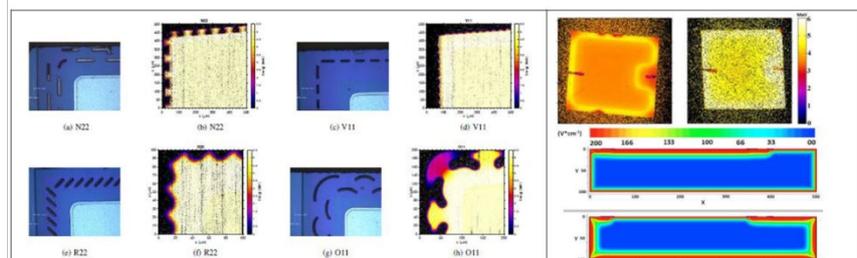


Fig. 1: a) Median maps of the charge collection efficiency obtained with different geometries of the active trenches at the edge of the detector from SINTEF. b) TOP: Median maps of the charge collection efficiency obtained for a PP and NP edgeless combinations; BOTTOM: TCAD derived electric field distribution of the NP edgeless diode (top) and PP edgeless diode (bottom). The simulation shows the weak electric field of the PP structure which justify the lack of CCE observed at the corners of the PP diode in the median maps.

1004

A new concept for an ion beam spot size monitor to evaluate the resolution of low energy micro and nano-beams

Greta Andrini¹, Elena Nieto Hernández², Georgios Provatas³, Marko Brajković³, Andreo Crnjac³, Sviatoslav Ditalia Tchernij², Jacopo Forneris², Valentino Rigato⁴, Matteo Campostrini⁴, Zdravko Siketić³, Milko Jakšić³, Ettore Vittone²

¹ Politecnico di Torino, Istituto Nazionale di Fisica Nucleare - sez. Torino Department of Electronics and Communications Torino-Italy

² University of Turin, Istituto Nazionale di Fisica Nucleare - sez. Torino Physics Department Torino-Italy

³ Ruđer Bosković Institute Laboratory for Ion Beam Interactions Zagreb-Croatia

⁴ Istituto Nazionale di Fisica Nucleare Laboratori Nazionali di Legnaro Legnaro-Italy

greta.andrini@to.infn.it

MeV ion beams are a primary tool in the modification, functionalization and analysis of solid state materials. While the scientific community has recently started to employ the target samples themselves as resources for single ion detection with position sensitivity [1], their exploitation as diagnostic tools for the assessment of ion beam parameters is still under investigation. In the proposed case of study, a custom Si photodiode micromachined via FIB milling is exploited as an integrated beam diagnostic tool for the real-time assessment of the beam spot size of the probe beam. In particular, a dedicated Ion Beam Induced Charge experiment was performed to extract spatial information on the size of a 2MeV Li⁺ ion micro-beam taking advantage of the spatial correlation between the induced charge pulses amplitude and the micro-structures through Charge Collection Efficiency (CCE) measurements. In contrast to the main techniques commonly adopted by the scientific community, such as STIM (Scanning Transmission Ion Microscopy), RBS (Rutherford back-scattering) and PIXE (Particle Induced X-ray Emission), which rely on the imaging of patterned standards to access beam resolution, the proposed approach allows the qualification of the ion beam by the CCE mapping of the very same target of the ion beam analysis, avoiding possible limitations in the accuracy of the beam size estimation due to the need of a separate detection setup [2]. The suitability of the micro-structures to locally modify the functional properties of the device under test, was preliminary monitored by photocurrent confocal microscopy and the comparison with STIM results confirmed the effectiveness of the method, actually exhibiting a better resolution estimate. Additionally, numerical simulations based on the Shockley-Ramo-Gunn model were carried out for data analysis, validating the interpretation of the experimental results as originating from the effects of the charge implanted during the FIB micromachining on the the measured charge induction.

To conclude, emerging fields such as deterministic implantation, ion lithography and micro radiobiology, where the accurate control on the beam size and its resolution plays a crucial role, could benefit from the proposed technique, since it could offer a reliable method to routinely monitor the resolution of ion microbeams processes and experiments.

Assessment of the radiation hardness of 4H-SiC Schottky diodes by IBIC

Ettore Vittone¹, Zeljko Pastuovic², Paolo Olivero¹, Milko Jaksic³

¹ Physics Department University of Torino, and Istituto Nazionale di Fisica Nucleare (INFN), Torino, Italy

² Centre for Accelerator Science, Australian Nuclear Science and Technology Organisation, Lucas Heights, NSW, Australia

³ Ruđer Bošković Institute, Zagreb, Croatia

ettore.vittone@unito.it

We report findings of the charge collection efficiency (CCE) degradation in a 4H-SiC Schottky barrier diode, which was exposed to selective area (patterned) heavy (carbon) ion irradiation with fluences ranging from 2 to 1000 ions/ μm^2 .

The Schottky barrier diode was formed by a Ni/Au metal electrode deposited on a n-type 4H-SiC epitaxial layer grown (50 μm thick) on a n+ substrate. The ohmic contact was a Ti/Pt/Au electrode deposited on the substrate side (C-face).

The cleavage of the diode allowed the exposure of the diode's lateral cross section to ion microbeam irradiation for the lateral IBIC microscopy.

IBIC microscopy was carried out at the Laboratory for Ion Beam Interaction (LIBI) of the Ruder Boskovic Institute in Zagreb (HR), following the guidelines in ref. [1]; we used 4 MeV protons and 20 MeV C ions as probing and damaging ions, respectively.

The widening of the depletion layer as function of the applied bias voltage is in a good agreement with the results extracted from capacitance-voltage characteristics, and the hole diffusion length of ($\sim 5 \mu\text{m}$) in the pristine diode.

The damage induced by the C ions in six different rectangular regions (about $150 \times 70 \mu\text{m}^2$) was evidenced by the CCE mapping resulting from lateral IBIC configuration.

The CCE profiles of the damaged regions show a progressive shrinking of the depletion layer as the damaging fluence increases, which indicate a remarkable perturbation of the local electrostatics landscape, to be attributed to the creation of donor-like defect structures, and/or space charge generation induced by the carbon implantation.

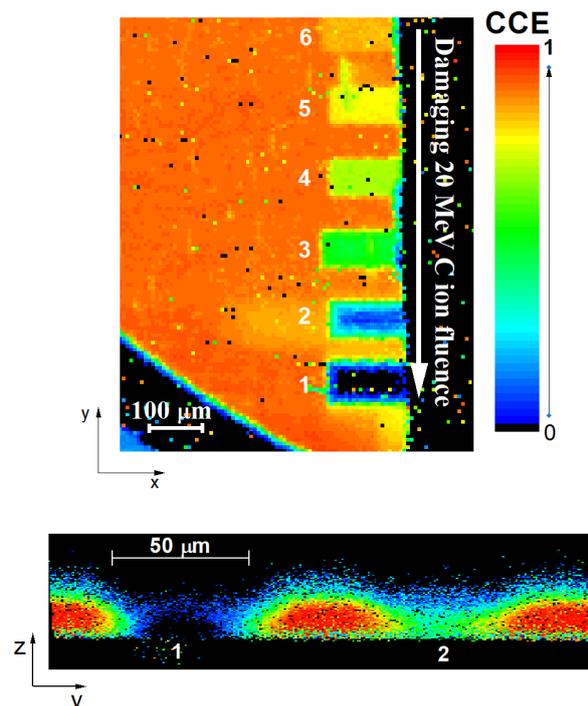


Figure 1: Frontal (top) and lateral (bottom) IBIC map of the damaged region.

[1] The IAEA guidelines for the determination of standardized semiconductor radiation hardness parameters, is the outcome of the Coordinated Research Project F11016 of the International Atomic Agency, Vienna and is to be published in Technical Report Series n. 490.

1062

Evaluation of charge transport and defect dynamics in semiconductors using ion microprobe – new insights and results

Andreo Crnjac¹, Mauricio Rodriguez-Ramos¹, Natko Skukan^{1,3}, Gregor Kramberger², Stjepko Fazinić¹, Milko Jakšić¹

¹ Ruđer Bošković Institute, Division of Experimental Physics, Zagreb, Croatia

² Jožef Stefan Institute, Ljubljana, Slovenia

³ Presently on long term leave to the International Atomic Energy Agency

acrnjac@irb.hr

The examples presented here will demonstrate the unique capability of the ion microprobe to extract information, at both spatial and temporal scales, about the charge transport properties and defect dynamics in semiconductors. This is in particular relevant for characterization of the operation of new generations of solid-state radiation detectors.

The first example is related to the operation of the novel silicon LGAD (low gain avalanche diode) detectors with superior timing resolution due to introduction of the charge multiplication. MeV protons of different energies were used to inject a high density of charge carriers in the device at different distances from the multiplication zones. The induced signal is measured as a function of electric field to quantify the gain factor, which is significantly affected by the charge cloud density, and which is reduced due to the diffusion of charge carriers. The mechanism of the observed gain suppression was fully explained by simulations of charge transport obtained using the TCAD code, which includes both drift and diffusion effects.

The second example is the study of trapping/detrapping phenomena in diamond, another example of the novel radiation detectors. High-purity single-crystal CVD diamond samples metallized with tungsten electrodes have been investigated at elevated temperatures. Focused MeV ions were used, firstly to induce the radiation damage, and secondly for the probing of charge transport properties at elevated temperatures of up to 450 °C. Thermally induced detrapping effect was measured at certain temperatures, by observing a long component ($\sim\mu\text{s}$) in the time structure of the induced charge signal. The energy position (0.53 eV) and other properties of the responsible deep trap were determined. In addition, space-charge-limited regime of charge transport has been studied by monitoring transient current signals in the pristine diamond. Shape analysis of signals collected at different temperatures was used to conclude that volume-polarization due to hole trapping is greatly mitigated at low elevated temperatures. This was attributed to the activation of shallow in-situ defect(s) uniformly distributed in diamond. The importance of these results will be discussed in the framework of diamond detectors employment in high-temperature and high-radiation conditions.

Finally, the last example is related to the study of the so-called dynamic annealing effect, previously observed in Si and SiC irradiated with high-flux pulsed ion beams [1], used to investigate the mechanisms of defect stabilization in millisecond time scales. We report on the ongoing work to spatially map and quantify damage production in pulsed-beam irradiated diamond, using scanning ion microbeam RBS-channeling.

[1] Wallace J B, Charnvanichborikarn S, Bayu Aji L B, Myers M T, Shao L and Kucheyev S O (2015) Radiation defect dynamics in Si at room temperature studied by pulsed ion beams, *Journal of Applied Physics*, 118

INSTRUMENTATION III

Chairs: Gyorgy Vizkelethy and Gyula Nagy

Invited talk III

1096

Present Status of Tohoku Microbeam SystemShigeo Matsuyama, Misako Miwa, Sho Toyama

Department of Quantum Science and Energy Engineering, Tohoku University, 6-6-01-2, Aramaki Aza-Aoba, Aoba-ku, Sendai 980-8579, Japan

Shigeo.matsuyama.a5@tohoku.ac.jp

We have developed two microbeam lines named MB-I and MB-II which could obtain beam spot sizes of less than $1 \times 1 \mu\text{m}^2$ and applied various fields. The microbeam line consists of quadrupole lenses (triplet or Doublet) and the slit-system of micro slits (MS) and divergence-defining slits (DS). These components are mounted on a heavy rigid support with vibration isolation. MS are composed of two adjustable wedge-shaped slits which are made from 5 mm diameter tungsten cylinders. The spacing is adjustable from 0 to 250 μm corresponding to a longitudinal motion of 0-25 mm. The quadrupole lens is manufactured by TOKIN. The bore radius is 5 mm and dimensions of the yoke are 60 mm long \times 220 mm outside diameter. The one-piece magnet poles and yoke was cut as one body from a single iron piece using a numerically controlled machine to reduce sextupole field contamination. Tolerance of the pole dimensions is better than 2 μm . The coils consist of 22 turns of 2 mm thick by 22 mm wide copper plates which are soldered together after assembly. The high field gradient of 85 T/m is obtained at a current of only 40 A and the low current density in the coil effectively reduces temperature rise of the quadrupole lens assembly. The quadrupole lenses are set on stages which allow precise adjustment of translation, tilt and rotation. These components are controlled by LabVIEW based software via programmable logic controller, PLC (FA-M3 Yokogawa Electric). The beam scanner is located downstream of the quadrupole lenses and controlled via compact RIO system (cRIO, National Instruments). The cRIO is composed of ADC, DAC, and input/output modules. with high-speed data processing and collection abilities. The cRIO system is capable of controlling a beam scan via a DAC. Data acquired by the X-ray, charged particle, and SE detectors are also integrated into the system. External ADCs are used for pulse signals from the X-ray or charged particle detectors and is collected through an input/output module (NI9403), and recorded as a list together with an internally processed dataset of the scan position. An automatic beam-focusing system to reduce the experimental configuration time.

The system is routinely used in Tohoku University. The systems are shipped to a private company and a Laboratory.

1087

The dual ion beam microprobe, setup performance and applicationsGeorgios Provatas, Iva Bogdanović Mihalić, Domagoj Cosic, Zdravko Siketić and Milko Jakšić*Laboratory for Ion Beam Interactions, Ruđer Bošković Institute, Zagreb, Croatia*georgios.provat@irb.hr

The Laboratory for Ion Beam Interactions of the Ruđer Bošković Institute (RBI) hosts two tandem accelerators attached to nine beam lines, including the two microbeam end stations. Within the last years, the group has been developing the new dual microbeam (DuMi) experimental end station, aiming to offer the possibility of simultaneously focused ion beams from both accelerators. The setup uses in-house designed magnetic quadrupole triplet lens for focusing the ion beams provided by the 1.0 MV Tandetron accelerator, while the commercial electrostatic microprobe based on the “Russian” quadruplet configuration [1] is used for the high rigidity ions provided by the Tandem Van de Graaff accelerator. In addition, aiming to develop a versatile setup, the cylindrical DuMi chamber provides the possibility of several different working distances, including the short one (7 cm) with high demagnification and submicrometer spatial resolution. Also, the chamber enables the application of most of the IBA techniques, i.e., PIXE, RBS, NRA, PIGE, STIM and IBIC.

In the present contribution, the recent upgrades of the setup will be presented, while its current capabilities in terms of spatial resolution obtained for different ions and focus distances will be demonstrated. Moreover, the authors will focus on the latest applications within the group’s activities (RADIATE, CERIC-ERIC, EuroFusion) carried out at the DuMi chamber. The latter include the application of IBA techniques in cultural heritage artifacts, fusion materials analyses, studies of biological samples, investigation of ^3He induced nuclear reactions, as well as semiconductor detectors studies by means of the IBIC technique. Lastly, the recent applications and the future perspectives of the simultaneous dual ion microbeam use will be discussed.

[1] N.C. Podaru, F.L.van de Hoef, A.Gott dang, D.J.W.Mous, Design and performance of the HVE electrostatic nuclear microprobe, Nucl. Instr. and Meth. B, 306 (2013) 25-28

1011

The beam optics of 50MeV proton microbeam based on cyclotron accelerator

Hongjin Mou, Guanghua Du

Institute of Modern Physics Center of Materials Lanzhou-China

mouhongjin@impcas.ac.cn

High-energy proton have important applications in space science, cancer treatment, biological cells, and other fields. However, the design of a high-energy proton microbeam needs to take into account the limitations of the beam quality of the cyclotron capable of delivering high-energy proton and the environmental irradiation shielding generated by high-energy proton. Here we present the beam optic design of a cyclotron-based 50MeV high-energy proton microbeam with micron probe resolution, using the Russian quadruplet configuration with a low aberration coefficient to focus the ion beam with large emittance, large momentum dispersion stream from the cyclotron, in addition, the Russian quadruplet configuration can be converted to the oxford triplet configuration to achieve better imaging resolution in single ion mode. The effect of intrinsic aberrations, lens aberrations, and lens fringe field on the beam probe of the microbeam is also considered.

1089

Study of chemical effects on HR PIXE spectra of low Z elements with focused ion beamsI. Božičević Mihalić, S. Fazinić, M. R. Ramos, D. D. Cosic*Ruđer Bošković Institute, Bijenička cesta 54, 10000 Zagreb*ibozicev@irb.hr

A decade ago, the first prototype of downsized flat crystal wavelength dispersive X-ray (WDX) spectrometer was designed and constructed for application on microscopic samples on our ion microprobe. The system was used to study high resolution Si $K\alpha$ and $K\beta$ spectra from silicon compounds, including several silicate minerals. In addition, we measured Mg and Al $K\alpha$ high-resolution spectra excited by 3, 4 and 5 MeV He ions of importance to study the influence of multiple ionization satellites on the analysis of spectra from the APXS (Alpha particle X-Ray Spectrometer) installed on Mars Exploration Rovers.

In the last few years upgraded spectrometer was designed, built and installed at the microprobe. The new system is equipped with the improved motorised sample and the diffraction crystal positioning stages. Additional ports on the chamber were added to enable integration of standard PIXE and RBS/NRA detectors. New CCD camera with better efficiency for detection of X-rays above 3 keV was installed. In combination with new diffraction crystals, capabilities for X-ray detection were extended to both low and high X-ray energy regions.

With the upgraded spectrometer we continued to study high resolution PIXE spectra of low Z elements (Al, Mg, P, S, Cl, K and Ca) and their compounds with proton and helium beam excitations. In this presentation the upgraded spectrometer will be described and recent results on its use to study chemical effects on low Z elements and their compounds will be elaborated.

1045

Xantho - a simple basic program for fitting X-ray spectraŽiga Šmit^{1,2}¹ Faculty of Mathematics and Physics, University of Ljubljana, Ljubljana, Slovenia² Jožef Stefan Institute, Ljubljana, Sloveniaziga.smit@fmf.uni-lj.si

During past decades, we have developed several specific codes for evaluation of elemental concentrations, like those for metal alloys, usewear layers on flint tools, differential PIXE and combined PIXE-PIGE analysis of glass. All these codes relied on X-ray intensities, evaluated by generally accessible programs, notably AXIL. In order to have better control on the evaluated intensities we have decided to develop a new code. Its advantage aims to provide minimal typing of commands during the analysis of a series of spectra. The other advantage is using the code with new computer operating systems, which made many older programs not working.

The main decision concerned the choice of background subtraction. In practice, two approaches proved successful for removing the background of the type that is not calculated by a physical model: smoothing with a filter and top-hat transformation. We have decided for the filter smoothing, mainly because of good experience with the AXIL code. The approach we developed is based on a moving-window filter with specific weights (a variant of the Kolmogorov-Zurbenko filter), which is applied on the convex parts of the spectra. The latter are detected by a top-hat transformation, which in effect gives the second derivative of the spectrum. The X-ray peaks are assumed to be Gaussian, only below the silicon absorption edge, the peak shape was conveniently approximated by a sum of two Gaussians at a fixed ratio. K-alpha and K-beta lines can be fitted either individually or as an aggregate. Corrections to their ratio includes absorption in the added absorbers and in the target, as well the counting efficiency of the detector. For L-lines, the aggregates belonging to individual subshells are fitted independently. Individual lines at selected energies can also be defined. Non-linear fitting determines two parameters for energy calibration and two for energy resolution. A parabolic expansion of χ^2 is applied. The spectral region can be divided in separate parts, where the fitting procedure is performed in sequence.

The program was first written in Free Pascal and is run in DOS. For visual inspection of the fitting results, a separate program was written in Lazarus environment. However, the DOS version is only used for development, for on-line fitting the program can be run and commanded through a Lazarus interface. The program further allows automatic analysis of a series of spectra that are generated in mapping experiments.

SPACE

Chairs: Milko Jakšić and Frans Munnik

Invited talk I

1047

A Rad-Hard SRAM Memory Designed in 65~nm CMOS Technology

Jafar Shojaii¹, Valentino Liberali², Luca Frontini², Alberto Stabile², Zeljko Pastuovic³, Stefania Peracchi³, Kamal Gupta⁴, Wei Ern Tan⁵

¹*Swinburne University of Technology*

²*The University of Melbourne*

³*Universita degli Studi di Milano*

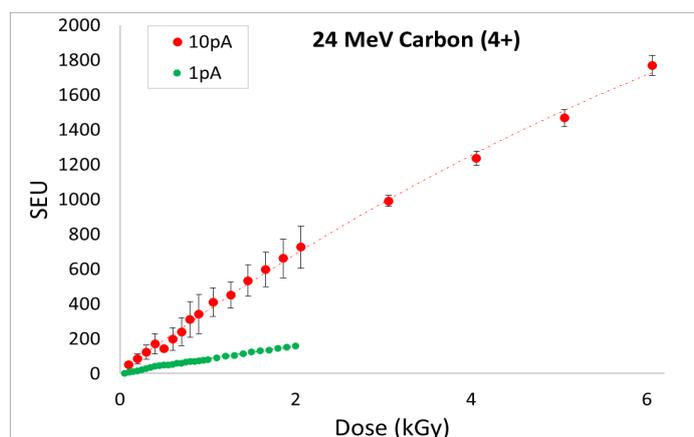
⁴*Australia's Nuclear and Science Technology Organisation (ANSTO)*

⁵*Defence Science and Technology Group, The Department of Defence, Australia*

jshojaii@swin.edu.au

Commercial ICs are usually not designed neither tested for applications in harsh environments, such as in space and high energy physics experiments. Applications in high radiation environments require ICs to be developed by modifying the fabrication process (RHBP: Radiation Hardening By Process), or by adopting design techniques (RHBD: Radiation Hardening By Design) and tested using radiation sources that simulate radiation fields in space or in facilities.

In this work, we present a 32 kbit SRAM Application-Specific Integrated Circuit (ASIC) specifically designed to be radiation hard using RHBD techniques and fabricated using a conventional 65 nm Complementary Metal-Oxide Semiconductor (CMOS) technology. We discuss its design and architecture, fault injection simulation technique for single event upsets (SEU), and test results for SEUs and total ionising dose effects following selective irradiations of a sensitive part of the chip (700 μm x 700 μm) by 5 MeV proton (LET=13.7 keV/ μm =0.059 MeV*cm²/mg) and 24 MeV (LET=836 keV/ μm =3.59 MeV*cm²/mg) C⁴⁺ ion microbeams at the ANSTO Centre for Accelerator Science. The chip showed no SEU sensitivity for irradiation with proton microbeam of 16 pA up to 5 kGy total accumulated dose. On the contrary, the chip showed SEU sensitivity during irradiations with the carbon ion microbeam with particle current in the 1 pA/ion -10 pA/ion range. The SEU number grows approximately linearly with increasing accumulated dose up to 5 kGy, and the SEU number is higher for the higher microbeam current. The chip's failure with many non-random errors in memory cells occurs for total accumulated doses above 500 kGy. The graph below shows the SEU number increasing with the delivered dose, during irradiation with 24 MeV carbon ions microbeam.



1084

Single Ion Localization Microscopy for Imaging of Irradiation Effect in Microelectronics

Jinlong Guo, Guangbo Mao, [Guanghua Du](#)

Institute of Modern Physics, CAS Materials Research Center Lanzhou-China

gh_du@impcas.ac.cn

Cosmic rays in space environment contain high flux heavy ions and protons with energy of tens MeV up to tens GeV. Their ionizing interaction with microelectronics in spacecraft induces single event errors and malfunctions, which is one critical and major cause of in-orbit mission failures. The resolution of the present microbeam facilities for single event effect imaging using high energy heavy ion cannot meet the demand of radiation hardening technique and single event effect study with modern microelectronics with nanoscale fabrication technology. This work targets the development of a new concept of imaging technique for irradiation effect using high energy heavy ions. Based on the high energy heavy ion microbeam facility at HIRFL, single ion scintillation localization microscopy method was developed which allows imaging the single event upset and ion beam induced charge collection with submicron resolution using a slightly focused beam. Such a single ion localization microscopy brings the ion beam imaging technique towards a higher ion energy regime.

New external ion microbeam irradiation facility of ANSTO

Zeljko Pastuovic¹, Stefania Peracchi², Ryan Drury², Nikolas Paneras², David Button², Michael Mann², Justin Davies³, Chris Hall⁴, Ceri Brenner², David Cohen²

¹ ANSTO Centre for Accelerator Science Lucas Heights-Australia

² ANSTO CAS Lucas Heights-Australia

³ ANSTO GATRI Lucas Heights-Australia

⁴ ANSTO Australian Synchrotron Clayton-Australia

zkp@ansto.gov.au

This paper presents a new accelerator capability for space research at the Centre for Accelerator Science of the Australia's Nuclear Science and Technology Organisation (ANSTO). The External Ion MicroBeam Irradiation Facility (EBIF) is dedicated to 1) the radiation testing of electronic components for space qualification to support an accelerated space industry in Australia and 2) the radiobiological studies on living cells for applications towards space travel and radiation therapy (reported in another paper). The EBIF is an upgrade of the existing ANTARES heavy ion microprobe beamline with the Oxford Microbeams triplet lens system (EM/Q2=120 MeV amu/e2) attached to the 10 MV FN Van de Graaff accelerator [1]. A chamber for the external beam inclosure with a safety drawer housing a micromanipulator for a target positioning was designed and built in-house, to satisfy the radiation and biological safety and regulatory requirements. It is capable of handling larger size (100 mm by 100 mm) electronic boards hosting test chips with an accuracy of 0.01 mm in 3D and a complex interrogation system otherwise unsuitable for operation in vacuum during irradiation. The microbeam is extracted from vacuum into the ambient through a 1 μm thin and 6 mm by 6 mm large SiN window for irradiations at atmospheric pressure and room temperature. A current measurement in the pA range which corresponds to dose rate measurement in Gy/s range is performed using a transition Faraday cup system in vacuum. A particle detector in STIM geometry is used for a dose rate measurement in mGy/s range for irradiation of cells in the single ion regime (1 kHz to 20 kHz). Total Ionizing Dose (TID) and Single Event Upset (SEU) studies of electronic components and chips can be performed by irradiations with protons and a selection of light and heavy ions having the energy up to 100 MeV and the LET in the 0.02 to 46 MeV*cm²/mg (or 5.0 to 1.1*10⁴ keV/ μm) range, suitable for the simulation of space radiation environments under laboratory conditions (Fig. 1). We present the experimental testing protocol and first results of the SEU and TID radiation tests of SRAM and logic gate ICs exposed to 9 MeV H ions and 36 MeV C ions microbeams in the external chamber with the in-house designed and built electronic readout system and control, interrogation and logging software. Lethal irradiation doses in the order of a few kGy can be delivered in minutes (protons) or seconds (carbon), whereas irradiations with gamma rays require hours within at the ANSTO cobalt-60 gamma irradiation facility. The delivered dose is calculated by GEANT4 software, where we modelled the energy deposited in the chip placed in the external chamber.

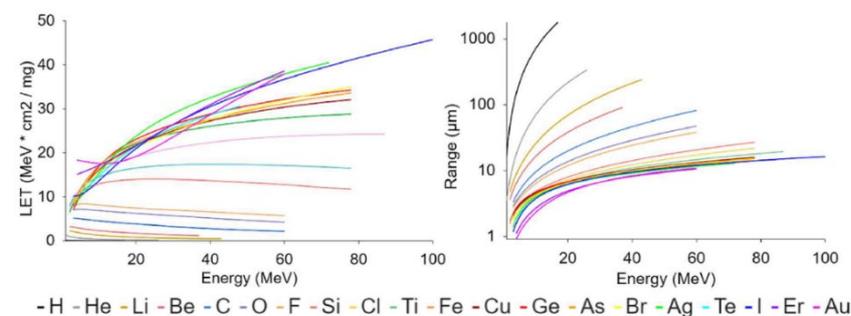


Figure 1. LET and Range of ions achievable with the ANTARES accelerator.

1075

GEANT4 model to calculate the radiation dose absorbed by a custom target on the ANTARES EBIF beamline

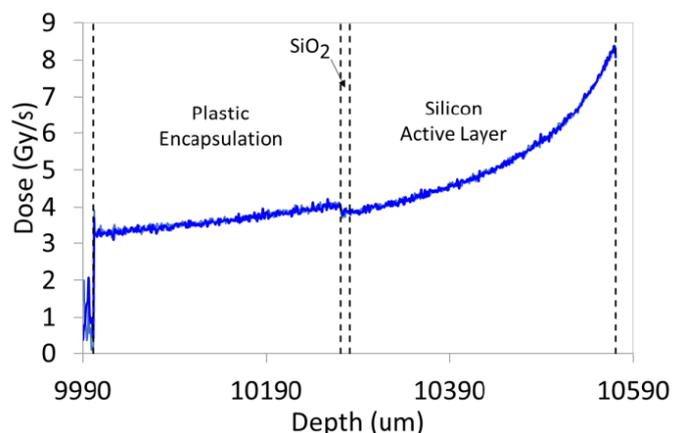
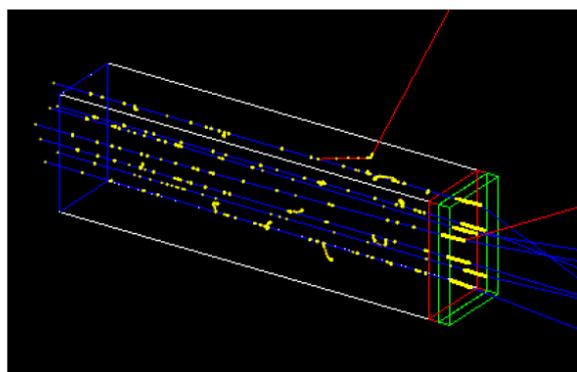
Stefania Peracchi¹, Jesse Williams², Susanna Guatelli², [Zeljko Pastuovic¹](mailto:zjkp@ansto.gov.au)

¹ Australia's Nuclear Science and Technology Organisation Centre for Accelerator Science Lucas Heights-Australia

² University of Wollongong Centre for Medical Radiation Physics Wollongong-Australia

zjkp@ansto.gov.au

We present a GEANT4 model developed specifically for the calculation of deposited energy and radiation dose during irradiation of a custom target on the ANTARES External Beam Irradiation Facility (EBIF) beamline of CAS. For a high accuracy dose calculation we have taken into account 1) a realistic propagation of the ion beam through all impinging materials defined by composition and dimensions, 2) a beam cross-section, and 3) all types of ion and secondary particle interactions with matter including tracing of all impacted particles and radiation. Each interaction of ion projectile with target is simulated by a single track with an accuracy of 10 nm. The energy deposited by both primary ion projectiles and secondary particles is stored along the whole geometry. The model is highly flexible to easily adapt to any experimental condition: for example, by changing the beam cross-section and the target area, we can select the best suitable flux and beam current to achieve a specific dose rate at a particular depth in the target of interest. LET and dose rate profile in all materials through which the ion beam passes is calculated from deposited energy along the track. We demonstrate the model in a real case of 9 MeV proton micro-beam extracted from vacuum through a 1 μm thin Si_3N_4 window for irradiation of a SRAM chip positioned 10 mm behind the window in air. The chip consists of a 270 μm thick thinned down plastic encapsulation, a 10 μm thick SiO_2 and 300 μm Silicon active layer. The calculated LET and dose rate profile allowed us to select a beam current of 5 pA to raster scan on a 2.3x2.3 mm² chip area in order to deliver the total dose of 6.7 kGy (with a dose rate of 3.8 Gy/s) at 10 μm depth in the SiO_2 , and a total dose of 14.0 kGy (with a dose rate of 8.0 Gy/s) at 300 μm depth in the Silicon active layer.



S. Agostinelli, et al "Geant4 - a simulation toolkit," Nuclear Instruments and Methods in Physics Research Section A: Accelerators, Spectrometers, Detectors and Associated Equipment, vol. 506, no. 3, pp. 250-303, 2003

1016

Characterization of ion microbeams (H^+ , He^{2+} , C^{3+} , O^{3+}) and a new detection system on the MIRCOC facility

Kévin Lalanne, Christelle Adam-Guillermin, François Vianna

IRSN, LMDN, Cadarache, France,

kevin.lalanne@irsn.fr

Ions microbeam are important in several fields, in particular in the improvement, identification and prevention of side effects resulting from the use of ionizing radiation, especially for therapeutic purposes in radiotherapy and more particularly in hadrontherapy. To study this field, the Institute for Radiological protection and Nuclear Safety (IRSN), in Cadarache (France), is equipped with the MIRCOC facility, whose main element is an ion microbeam dedicated to targeted irradiation of living biological samples with a given number of ions. The facility was commissioned at the end of 2018 [1]. It is based on a 2 MV Tandetron™ electrostatic accelerator manufactured by HVEE [2]. Before reaching the biological samples, the ion beam is focused in the microbeam line, reaching a diameter of less than 1 μm in vacuum, and then extracted in air by a silicon nitride extraction window (Si_3N_4). The first effects of the irradiations can be visualized, in real time, using an epi-fluorescence microscope placed in front of the microbeam extraction. This microbeam can deliver four types of ions: Proton (H^+), Helium (He^{2+}), Carbon (C^{3+}) and Oxygen (O^{3+}).

A first study was performed to determine the beam spot size for all the ions available on MIRCOC on CR39 track detector and on cells. With CR39, the beam spot size can be evaluated by measuring the impact diameter of the ions after a chemical etching. With cells, the use of time-lapse imaging of fluorescent protein recruitment is a fast and reliable method to directly visualize the early consequences of the microbeam irradiation [3]. A beam spot size of $2.2 \pm 0.3 \mu\text{m}$ for H^+ , $2.6 \pm 0.2 \mu\text{m}$ for He^{2+} , $3.4 \pm 0.6 \mu\text{m}$ for C^{3+} and $4.6 \pm 0.7 \mu\text{m}$ for O^{3+} was measured.

A second study focused on the ability to irradiate a target in a biological sample with single ions. To achieve this, a very efficient detection system needs to be used, to count the ions with a 100% accuracy. Given the energies of the ions used on MIRCOC, that prevent them to pass through the biological sample to be counted after, the detection needs to be performed before the sample. When the ions pass through the extraction window, secondary electrons are emitted. These electrons can be collected and converted to a counting signal by a Channeltron [3]. To optimize the detection efficiency, the production yield of secondary electrons can be improved by using deposits of caesium iodine and gold, directly on the vacuum side of the extraction window.

We performed simultaneous measurements with the Channeltron and a reference detector, with different CsI deposit thicknesses (25, 50, 100 and 200 $\mu\text{g}/\text{cm}^2$). We found a detection efficiency of 96,5% and 100,5%, respectively with 100 $\mu\text{g}/\text{cm}^2$ and 200 $\mu\text{g}/\text{cm}^2$ thick CsI deposits for He^{2+} , 98,6% for C^{3+} without CsI and 99,9% for O^{3+} without CsI. Further measurements must be performed for He^{2+} with intermediate CsI deposit thicknesses to have an optimal detection efficiency.

[1] F. Vianna et al. Characterization of MIRCOC, IRSN's new ion microbeam dedicated to targeted irradiation of living biological samples, *NIM B*, 515: (2022)

[2] V. Gressier et al. New IRSN facilities for neutron production, *NIM A*, 505: 370-373 (2003)

[3] S. Bourret et al. Fluorescence time-lapse imaging of single cells targeted with a focused scanning charged-particle microbeam, *NIM B B* 325 (2014)

[4] M. Cholewa et al. Preparatory experiments for a single ion hit facility at GSI. *NIM B*. 210: 296-301 (2003)

1039

Cell radiation sensitivity – a step closer to understanding different effects of radiation on humans

Melanie Ferlazzo¹, Nicholas Howell¹, Ryan Middleton¹, Guo Jun Liu¹, Nicolas Foray², Stefania Perrachi³, Zeljko Pastuovic³

¹ ANSTO Human Health Lucas Heights-Australia

² INSERM U1296 Lyon-France

³ ANSTO Center for Accelerator Science Lucas Heights-Australia

Radiation exposure is a major limiting factor for long duration manned space flights. Radiation protection standards assume that individuals are equally resistant to ionizing radiation. However, for over a century, there is evidence that humans do not respond equally to radiation. Studies of secondary effects post-radiotherapy have shown a great variability among individuals [1]. Also, large discrepancies among astronauts after the same flight were observed [2]. We have shown that the delay in the nucleoshuttling of the ATM protein may cause a lack of double strand break (DSB) recognition, incomplete DSB repair and radiosensitivity in fibroblast cell lines derived from patients suffering from genetic disease or post-radiotherapy [3-6]. Interestingly, the model of the ATM nucleoshuttling was shown to be relevant not only for low-dose and repeated exposures [7], but also for high-LET particles [8], which renders this model compatible with space radiation exposure scenarios. Lastly, this model could lead to a novel approach for radiation protection, consisting of interventions to accelerate ATM nucleoshuttling [9]. Here we present the first results of radiosensitivity studies of fibroblast cell cultures in the 0.1 – 2.0 Gy radiation dose range using a focused raster-scanned external ion microbeam of a new dedicated facility for irradiation of thin biological samples in ambient at ANSTO Centre for Accelerator Science.

- [1] Berthel E et al., What Does the History of Research on the Repair of DNA Double-Strand Breaks Tell Us? A Comprehensive Review of Human Radiosensitivity. *Int J Mol Sci.* 2019;20(21):5339. Published 2019 Oct 26. doi:10.3390/ijms20215339
- [2] Testard I et al., *International journal of radiation biology* 70 (4):403-411
- [3] Granzotto A et al., *International journal of radiation oncology, biology, physics* 94 (3):450-460. doi:10.1016/j.ijrobp.2015.11.013
- [4] Belkacemi Y et al., *International journal of radiation oncology, biology, physics* 96 (3):629-636. doi:10.1016/j.ijrobp.2016.05.027
- [5] Pereira S, *International journal of radiation oncology, biology, physics* 100:353-360
- [6] Vogin G et al., *International journal of radiation oncology, biology, physics* 101 (3):690-693. doi:10.1016/j.ijrobp.2018.03.047
- [7] Devic C et al., *International Journal of Low Radiation* in press
- [8] Maalouf M et al., *International journal of radiation oncology, biology, physics.* doi:10.1016/j.ijrobp.2018.10.011
- [9] Ferlazzo ML et al., *Proc Natl Acad Sci U S A.* 2017 Aug 15;114(33):E6733.

1095

Recent upgrade of the radiobiology beamline at the Center for Ion Beam Applications for single proton irradiation at live cellsYang Chengyuan¹, Mi Zhaohong², Guo Zikun¹, Lim Zong Qing¹, Choo Run Kang Neville³, Andrew Anthony Bettiol^{1,4}¹ Department of Physics, National University of Singapore, 2 Science Drive 3, Singapore 117542, Singapore² Department of Physics, Fudan University, Handan Road 220, Shanghai 200433, China³ College of Design and Engineering, National University of Singapore, 9 Engineering Drive 1, Singapore 117575, Singapore⁴ Yale-NUS College, National University of Singapore, 16 College Avenue West, Singapore 138527, Singaporea.bettiol@nus.edu.sg

The radiobiology beamline at the Center for Ion Beam Applications is dedicated to the study of live cells reacting to proton irradiation at a controlled dose. Previously the dose of protons was measured from an average count rate using a Si-surface barrier detector before irradiation. However, the accuracy of this method is subject to beam fluctuation, particularly at a low dose. To achieve precise control of dose at a single proton level, we upgrade the beamline using several techniques. First, we have developed both diamond-based and scintillator-based transmission detectors for counting protons during irradiation. The detectors are placed in the ion path before the cells. For a 2 MeV proton, the energy loss of the detectors is only ~330 KeV and ~160 KeV for the diamond and the scintillator, respectively, which is relatively lower compared with ion energy deposited in cells. In addition, the beam blanking system is upgraded with a fast high-voltage MOSFET switch to achieve a high-speed cut-off of the beam when a certain dose has been reached. The upgraded system allows on and off a 2 MeV proton beam at 16 nanoseconds. Last, we have also upgraded the optical imaging system of the beamline with an EMCCD camera, which enables us to capture fluorescence induced by single protons. These upgrades are of great potential to study the radiobiology of cells under single ion irradiation.

1002

The potentialities of ultrasound as an alternative to chemical etching for proton beam writing micropatterning

Deiverti Bauer¹, Rafaela Debastiani², Cláudia Telles de Souza¹, Lívio Amaral¹, Johnny Ferraz Dias¹

¹ IF-UFRGS Physics Institute Porto Alegre-Brazil

² Karlsruhe Institute of Technology Institute of Nanotechnology Karlsruhe-Germany

We explore the potentialities of using ultrasound waves as a post-irradiation treatment after proton beam writing (PBW) patterning of PTFE. To that end, 2-mm-thick foils of PTFE were irradiated with 2.2 MeV protons with an average current of 50 pA. Straight line structures were patterned on the polymer with a $3.5 \times 3.5 \mu\text{m}^2$ focused proton beam. Post-irradiation polymers were placed in a heat bath at 60 °C and immersed either in distilled water or in a 6 M solution of NaOH under the action of 40 kHz ultrasound waves for developing the patterned structures. The results indicate that distilled water submitted to ultrasound waves is very efficient for removing rough structures created by the proton irradiation and thus providing a good aspect ratio to the PBW microstructures. On the other hand, the use of 6 M NaOH instead of water did not improve the quality of the structures patterned with the proton beam. The results are discussed in terms of the parameters that characterize the interaction of ultrasound waves with the liquid media and the polymer.

[1] D. de Vila Bauer, R. Debastiani, C. Telles de Souza, L. Amaral, J. Ferraz Dias, *J. Appl. Polym. Sci.* 2022, e52407. <https://doi.org/10.1002/app.52407>

[2] C. T. de Souza, E. M. Stori, L. A. Bouffleur, R. M. Papaléo, J. F. Dias, *Appl. Phys. A: Mater. Sci. Process.* 2016, 122, 122.

[3] E. M. Stori, C. T. De Souza, J. F. Dias, *J. Appl. Polym. Sci.* 2016, 133, 1

1006

Proton beam writing of X-ray diffraction gratings using a quadruplet of magnetic quadrupole lenses with individual power suppliesA.G. Ponomarev, H.E. Polozhii, S.V. Kolinko, V.A. Rebrov, V.F. Salivon*Institute of Applied Physics, National Academy of Sciences of Ukraine, 58, Petropavlivska St., 40000 Sumy, Ukraine.*ponom56@gmail.com

To fabricate X-ray diffraction gratings using proton beam writing, it is most efficient to focus the proton beam into a thin line. For such focusing, we used the configuration of the probe-forming system in the form of a separated triplet of magnetic quadrupole lenses. In this case, refocusing was carried out in order to maintain a demagnification close to unity in one of the directions. In the experiment, the disadvantage of such a system appeared due to large positioning aberrations, which did not allow achieving the calculated parameters for the line thickness. For this reason, another variant of the probe-forming system was found based on a quadruplet of magnetic quadrupoles with four independent power supplies, the first two lenses having very low excitation, which reduces positioning aberrations. Such a system in the stigmatic focusing mode has demagnifications $D_x \times D_y = (-71) \times 1.3$ and low chromatic and spherical aberrations.

1021

Fabrication of periodic microstructures on diamond surface with focused swift heavy ions

Maria Dolores Ynsa¹, Pablo Peñuela¹, Gregoire Peysson¹, Mario García-Lechuga², Carlota Ruiz de Galarreta², Gaston Gacia¹

¹ Universidad Autónoma de Madrid Centro de Microanálisis de Materiales Madrid-Spain

² CSIC Instituto de Optica Madrid-Spain

m.ynsa@uam.es

The development of novel, three-dimensional micro-fabrication techniques on diamond would open up new possibilities towards the realisation of diamond-based devices for e.g. x-ray optics applications. However, to date the available technology is unable to overcome the difficulties associated to the high mechanical strength and chemical stability.

In this work, topographic periodic microstructures have been produced on the diamond surface by the effect of implantation of two highly-focused ion beams, carbon and silicon, with energies of several MeV. It is well-known that MeV heavy ion implantation with the key experimental parameters, produces a serious structural damage inside monocrystalline diamond. Once implantation has been carried out, the internal density decreases significantly keeping its surface almost intact. Consequently, the buried damaged diamond volume increases and the increase is passed to the sample surface giving rise to a topography, which depends on the cumulative damage below. Consecutive lines with increasing fluences have been implanted in order to manufacture a saw-tooth profile. The required fluences have been calculated using the nuclear stopping power to produce a determined maximum height and blaze angle of the structure. The patterns have been characterized by optical microscopy and atomic force microscopy and the manufactured structures for each ion have been compared. Our results certify this manufacture method is highly promising for the reliable fabrication of optical and biomedical diamond-based devices.

1042

Design of a collimator-less two-stage acceleration lens for a single-ion-implantation system

Yasuyuki Ishii^{1,2}, Takeru Ohkubo¹, Nobumasa Miyawaki^{1,2}, Kazumasa Narumi^{2,3}, Shinobu Onoda², Yuichi Saitoh^{2,3}

¹ Beam Engineering Section, National Institutes for Quantum Science and Technology, 1233 Watanuki-machi Takasaki Gunma 370-1292, Japan

² Quantum Materials and Applications Research Center, National Institutes for Quantum Science and Technology, 1233 Watanuki-machi Takasaki Gunma 370-1292, Japan

³ Department of Advanced Radiation Technology, National Institutes for Quantum Science and Technology, 1233 Watanuki-machi Takasaki Gunma 370-1292, Japan

ishii.yasuyuki@qst.go.jp

This report shows the design of a focusing lens for a single-ion implantation system (SII). The SII has been developed for the implantation of single-nitrogen-ion with the accuracy of nanometers in a diamond sample to create a nitrogen vacancy color-center (NVC) that functions as a quantum bit. The quantum entanglement using the array of NVCs is expected to lead us to develop a quantum computer. In the SII, single-nitrogen-ion needs to be implanted within 20 nm accuracy in a diamond sample with 100% probability, namely deterministic implantation. We propose a single-ion-implantation system combining Paul trap-type laser cooling device (PTLC) [1] and a focusing lens as the SII. PTLC individually generates single-nitrogen-ions with very low emittance. On the other hand, the focusing lens requires the high demagnification to meet the implantation accuracy of 20 nm. In addition, passing all ions through the lens is also required for the deterministic implantation as well as the shortening of the experimental time of the evaluation of the accuracy.

In this study, a collimator-less electrostatic focusing lens with high demagnification to pass all ions through the lens was designed for the SII. In general, a collimator is installed in front of a focusing lens to restrict a divergence angle of an ion beam injected into the lens. However, the collimator used in the SII to reduce spherical and chromatic aberrations, decimates some ions. Since the decimation leads to non-deterministic implantation, the collimator cannot be used in the SII. On the other hand, a two-stage acceleration lens with high demagnification, which is a kind of electrostatic focusing lens, was developed at QST to form ion nanobeam [2]. The lens is relatively bright as compared with other typical lenses because a divergence angle of outgoing beam can be controlled by the acceleration. In this study, a collimator-less two-stage acceleration lens to be installed for SII was designed on the basis of numerical calculations.

This study is supported by JSPS KAKENHI Grant Numbers JP20H00145, JP20H02673, JP19K12635, and Moonshot R&D Grant Number JPMJMS2062.

[1] Kenji Izawa, Kiyokazu Ito, Hiroyuki Higaki, and Hiromi Okamoto, Controlled Extraction of Ultracold Ions from a Linear Paul Trap for Nanobeam Production (2010), 10.1143/JPSJ.79.124502

[2] Y. Ishii and T. Kojima (2018) Reduction of the divergence angle of an incident beam to enhance the demagnification factor of a two-stage acceleration lens in a gas ion nanobeam system of several tens of keV, <https://doi.org/10.1016/j.nimb.2018.01.013>

1053

Ion beam induced current and ion beam induced charge analysis in GaN core-shell p-n junction microwires

Dirkjan Verheij¹, Marco Peres², Luís Cerqueira Alves³, Milan Vicentijevic⁴, Milko Jaksic⁴, Susana Cardoso¹, Eduardo Alves², Christophe Durand⁵, Joël Eymery⁶, Jorge Fernandes⁷, Katharina Lorenz¹

¹ Instituto de Engenharia de Sistemas e Computadores - Microsistemas e Nanotecnologia INESC MN Lisboa-Portugal

² Campus Tecnológico e Nuclear, Instituto Superior Técnico IPFN Lisboa-Portugal

³ Campus Tecnológico e Nuclear, Instituto Superior Técnico C2TN Lisboa-Portugal

⁴ Ruđer Bošković Institute Laboratory for Ion Beam Interactions Zagreb-Croatia

⁵ Université Grenoble Alpes CEA, IRIG, PHELAGS, NPSC Grenoble-France

⁶ Université Grenoble Alpes CEA, IRIG, MEM, NRS Grenoble-France

⁷ Instituto de Engenharia de Sistemas e Computadores – Investigação e Desenvolvimento INESC ID Lisboa-Portugal

Gallium nitride (GaN) nano- and microwires have gained increasing interest due to their unique geometry and flexibility, and their superior crystalline quality in comparison to their thin-film counterparts. GaN is also known for its high radiation hardness, owed to the large displacement energy of the atoms in its crystal lattice and efficient dynamic annealing properties, making it an interesting material for electronic space applications.

In this work, single GaN core-shell p-n junction microwires with a length of 25 ± 5 μm and a diameter of 1-2 μm have been processed into radiation detectors and characterized using nuclear microprobe techniques. By taking advantage of the small lateral dimension of the focused ion beam and the ability to control the area of irradiation with precision, we can measure the ion beam induced current signal when irradiating the different regions of the detector. Typically using focused 2 MeV protons and beam currents in the range of 50 pA to 100 pA the CTN experimental setup allows to obtain PIXE and RBS maps and at the same time perform electrical measurements. Initial PIXE maps are used to precisely define the position of the small dimension sensors and then select the specific region we want to irradiate. This means that we can measure the electrical signals induced when irradiating the p-n junction and the n-GaN extremity of the wire independently and compare their contribution to the response of the detector. Besides this, it is also possible to analyze the evolution of the detector's reverse bias leakage current and ion beam induced current in function of the irradiation fluence to better define its radiation hardness. Results show that GaN radiation detectors withstand high beam fluences that would strongly degrade any Si-based device.

Further microwire electrical characterization can be accomplished when using fA beam currents as the ones usually applied in ion beam induced charge (IBIC) experiments. However, using proton beams on these thin GaN detectors would require a very high sensitivity IBIC system. Profiting from the capabilities of the tandem accelerator facility at RBI that also includes a nuclear microprobe beam line, the signal to noise ratio of the locally developed high sensitivity IBIC system can be further improved by irradiating the sensors using different ions (e.g. Cu, Si, C) and energies, then allowing to measure IBIC maps at different applied reverse bias and study the detection efficiency and charge collection efficiency of the sensors.

1061

Depth distribution of Fe in Fe-MOF- 74 thin films

Ana R. Reis¹, Sara Realista¹, C.S.B. Gomes², A.M. Ferreira³, P.A. Martinho¹, Luís Alves^{4,5}, Victoria Corregidor^{4,5}

¹ Centro de Química Estrutural, Institute of Molecular Sciences, Departamento de Química e Bioquímica, Faculdade de Ciências, Universidade de Lisboa, Campo Grande, Ed. C8, 1749-016 Lisboa, Portugal

² LAQV-REQUIMTE, Department of Chemistry, NOVA School of Science and Technology, Universidade Nova de Lisboa, 2829-516 Caparica, Portugal

³ IBB—Institute for Bioengineering and Biosciences and Departamento de Engenharia Química, Instituto Superior Técnico, Universidade de Lisboa, Av. Rovisco Pais, 1049-001 Lisbon, Portugal.

⁴ C2TN, Centro de Ciências e Tecnologias Nucleares

⁵ Departamento de Engenharia e Ciências Nucleares, Instituto Superior Técnico, Universidade de Lisboa

victoria.corregidor@tecnico.ulisboa.pt

Fe-MOF thin films of metal-organic frameworks were synthesized by cathodic electrodeposition using new ligands with the aim of producing new electrocatalysts for energy-related reactions.

These films contain C, O, H and Fe as main constituents, and they were deposited on FTO-coated glass. Several Fe-MOF films, grown with different experimental conditions, were characterized using a 2 MeV proton beam, acquiring the PIXE and the RBS spectra simultaneously.

The 2D compositional maps show that the films partially cover the FTO surface, being the thickness and the Fe distribution dependent on the growth conditions.

In the PIXE spectra, the concentration of Fe is relatively straightforward to obtain using GUPIXWin software, however, there is an overlap in the low energy region regarding the Sn-L lines (from the FTO layer) and the Ca-K and K-K lines (from the glass substrate). Other challenges encountered during the analysis of the RBS spectra will be discussed.

1071

Ion Microprobe analysis of wear processes in ta-C coatings and contact areas on the counter bodies.Frans Munnik¹, Lars Lorenz^{2,3}, Fabian Härtwig^{2,3}, Matthias Krause¹

¹ Helmholtz-Zentrum Dresden-Rossendorf, Institute of Ion Beam Physics and Materials Research, Dresden, Germany

² Institute of Manufacturing Science and Engineering, Technische Universität Dresden, Germany

³ Fraunhofer Institute for Material and Beam Technology IWS, Dresden, Germany

f.munnik@hzdr.de

Solid lubricants, like ta-C (hydrogen-free tetrahedral amorphous carbon) coatings, are an active area of research to replace liquid lubricants. This substitution is important because of the negative environmental impact and high material consumption of liquid lubricants. The influence of soft metal counter bodies on the unlubricated friction behaviour of hydrogen-free carbon coatings has mostly been studied for doped a-C coatings so far. All these studies show that low friction and wear can only be achieved if a tribolayer is formed to protect the contact. Even with a formed tribolayer, its composition is crucial for the frictional behaviour, making the investigation of this composition essential. A study currently underway aims to identify friction-induced surface changes like material loss of the coating, material transfer between the counter body and the coating, or the formation of a tribolayer.

The current work presents Ion Beam Analysis methods to deliver laterally and depth-resolved element analysis of the wear track on the coating and the contact area of the counter bodies (CB). In a first test, a ta-C coating has been subjected to pin-on-disk tests with various metallic and ceramic CBs. He and H ion microbeams have been used to scan over the tracks and the contact areas of the CBs. Both RBS and PIXE have been used and first results are presented. It is shown that, in this case, RBS yields the more useful information. Both, a 2 MeV He ion beam and a 3 MeV H ion beam provide valuable results. The advantages of each type of ion beam depend on the sample and the information needed. As shown in this work, RBS with a 2 MeV He ion beam is useful to determine the transfer layer of a (soft) metal CB to the ta-C coating, whereas 3 MeV H RBS can be used to determine the presence of C and O on the CB because of the increased non-Rutherford cross-sections for these elements.

1076

Calculation Study for the selective ion extraction from an ion source with Paul-trap-type laser cooling device

Nobumasa Miyawaki¹, Yasuyuki Ishii¹, Yousuke Yuri¹, Kazumasa Narumi¹, Kento Muroo², Kiyokazu Ito², Hiromi Okamoto²

¹ National Institutes for Quantum Science and Technology Takasaki Advanced Radiation Research Institute Takasaki-Japan

² Hiroshima University Graduate School of Advanced Science and Engineering Higashi-Hiroshima-Japan

miyawaki.nobumasa@qst.go.jp

The selective extraction of a single molecule nitrogen ion (N₂⁺) with very low emittance from a linear-Paul-trap ion source (LPT-IS) for a single-ion implantation system (SII) has been studied by three-dimensional multiparticle simulations. The SII that is the combination of the LPT-IS and an electrostatic focusing lens¹ in the QST Takasaki has been developed to create an array of nitrogen vacancy color centers (NVCs) at intervals of 20 nm or less in a diamond specimen. The NVC array has been proposed to realize the quantum entanglement used in solid-state quantum information devices. In the LPT-IS, several nitrogenions are cooled to a temperature close to absolute zero by the interaction of calcium ions (Ca⁺s) cooled by Doppler-laser-cooling technique², namely “sympathetic cooling“, so that an arrangement of N₂⁺ and Ca⁺ is formed by sympathetic cooling. The distribution of N₂⁺ extracted from LPT-IS is expected to have very low emittance. However, N₂⁺s are extracted together with Ca⁺s from the LPT-IS. Therefore, only the extraction of a single N₂⁺ is required without deteriorating the emittance at the SII.

In this study, the conditions to extract only a single N₂⁺ from the arrangement of N₂⁺ and Ca⁺ has been investigated by the simulation of multi-particle motion in the three-dimensional electric field. The result of the simulations shows that the single N₂⁺ with low emittance can be extracted by increasing the voltage of the extraction side electrode at the optimal timing and magnitude while the arrangement of N₂⁺ and Ca⁺ was passing through the electrode of the LPT-IS. The obtained emittance of the single N₂⁺ is used in the design of electrostatic acceleration lenses.

This study is supported by JSPS KAKENHI Grant Numbers JP20H00145, and Moonshot R&D Grant Number JPMJMS2062.

1017

Status report on the Atomki nanoprobe setup

I. Rajta¹, Z.T. Gaál^{1,2}, I. Vajda¹, P. Hajdu¹, M. Szarka¹, P. Herczku¹, G.U.L. Nagy^{1,3}

¹ Atomki, Debrecen, Hungary

² University of Debrecen, Hungary

³ Uppsala University, Sweden

rajta@atomki.hu

Since the initial setup of our nanoprobe that we have reported in Guildford, we have extended the Tandetron Laboratory with three new ion sources (two multicusp for proton and helium beams, and a cesium sputter source for heavy ions), a 90-degree analyzing magnet and associated high-energy extension. This way the final layout was achieved that was originally planned.

The object distance of the nanoprobe is as long as 12 m, and the high brightness provided by the multicusp source allows sufficient beam current even with a very low beam divergence that is caused by the long object distance vs. limited collimator slits. The fact that the switching magnet is located after the object slits makes sure that the ions that are scattered on the slit edges thus lose energy are bent away from the target chamber, and do not cause beam halo.

In the initial setup we have reached 200 nm spot size for low current mode, and 600 nm for high current mode. Based on preliminary ion optics calculations, we expect sub-100 nm spot size for the low current mode and sub-300 nm for the high current mode with the new laboratory layout.

However, during the re-installation process of the nanoprobe, we encountered several problems that lead to the degradation of the beam size. These problems involved possible mechanical vibrations from the rearranged mechanical workshop. The longer object distance made the beam path dependence on ion energy much larger thus we have decided to cover as much as possible of the beamline with mu-metal (Co-Netic, Magnetic Shielding Corp.). We measured that the vertical component of the Earth's magnetic field, which is about 435 mG (43.5 nT) in Debrecen, can be reduced to well below 10 mG (1 nT). Our calculations show that this will reduce the relocation of the collimator slits from about 2 mm in the horizontal direction to about only 100 μ m when changing beam energy or using heavy ions, but it also helps to reduce the effects of possible stray magnetic fields. We also found instabilities in some of the electrical components which caused lateral beam vibrations, contributing to the degradation of the resolution, which we could localize using the double-focusing property of the analyzing magnet.

In this presentation we show how we diagnosed the encountered problems and we also show the solutions of how we eliminated or reduced their effects.

I. Rajta, G.U.L. Nagy, I. Vajda, S.Z. Szilasi, G.W. Grime, F. Watt: First resolution test results of the Atomki nuclear nanoprobe. Nucl. Instr. Meth. B 449 (2019) 94-98. doi: 10.1016/j.nimb.2019.03.056

1029

Stopping power measurement for protons with MeV energies in diamond

Matija Matijević, Zdravko Siketić, Andreo Crnjac, Mauricio Rodriguez Ramos

Ruđer Bošković Institute Laboratory for ion beam interactions Ivanić-Grad-Croatia

mmatijevi@yahoo.com.hr

In recent years, interest in high-purity diamond crystals has been growing due to their application in various fields ranging from high-energy physics (particle detectors) to radiation therapy (dosimeters) and quantum computing (NV centres). Precise control of the energy deposited in the material by MeV proton beams, resulting from accurate knowledge of the energy loss per unit path (stopping power), is a key parameter in all the aforementioned applications of diamond. The characterization of stopping power can be done by measuring the energy loss ΔE of a monoenergetic beam passing through a thin target and knowing the thickness of the target Δx . With this information, it is possible to estimate the stopping power of the proton beam when the ionization profile is approximately flat along the trajectory of the incident ion: $S(E) \approx \Delta E/\Delta x$. To measure the stopping power, a single-crystal CVD diamond was thinned to a thickness of a few micrometres by Ar/O₂ plasma etching [1] and prepared as a self-supporting membrane, which was then exposed to a proton beam with energies between 1.6 and 6 MeV in the microbeam vacuum chamber of the RBI accelerator facility. The thickness of the membrane was determined by two different methods: indirectly by measuring the absorption of X-rays in the membrane produced by particle induced X-ray emission (PIXE), and directly from images of the membrane edge taken with a scanning electron microscope (SEM). Using these two methods, the thickness was estimated to be (3.5 ± 0.2) μm . The energy loss was measured using scanning transmission ion microscopy (STIM) and the obtained results were compared with the values obtained from Monte Carlo simulations in the SRIM package [2] and with the experimental results of Fearick & Sellschop [3].

[1] Pomorski M, Caylar B, Bergonzo, P (2013) Super-thin single crystal diamond membrane radiation detectors. Appl Phys Lett 103: 112106. doi: <https://doi.org/10.1063/1.4821035>

[2] Ziegler JE, Ziegler MD, Biersack JP (2010) SRIM – The stopping and range of ions in matter. Nucl Instruments Methods Phys Res Sect B Beam Interact with Matter Atoms 268: 1818-1823. doi: <https://doi.org/10.1016/j.nimb.2010.02.091>

[3] Fearick RW, Sellschop JPF (1980) Energy loss of light ions in diamond. Nucl Instruments Methods 168: 51-55. doi: [https://doi.org/10.1016/0029-554X\(80\)91230-6](https://doi.org/10.1016/0029-554X(80)91230-6)

1052

Arduino controlled sample positioning stage and automatic data acquisition using OMDAQ3

Manuel Fortunato¹, Norberto Catarino², Luis Alves^{1,3}, Victoria Corregidor^{1,3}, Rui Coelho da Silva^{2,3}

¹ C2TN, E.N.10, Instituto Superior Técnico, Universidade de Lisboa, 2695-066 Bobadela, Portugal

² IPFN, E.N.10, Instituto Superior Técnico, Universidade de Lisboa, 2695-066 Bobadela, Portugal

³ DECN, E.N.10, Instituto Superior Técnico, Universidade de Lisboa, 2695-066 Bobadela, Portugal

icalves@ctn.tecnico.ulisboa.pt

In this work it is described a simple, effective and low-cost system for actuating a stepper-motor driven x-y stage based on an Arduino Nano board together with a stepper-motor power driver module (Geckodrive G540) with positioning control and automatic data acquisition under OMDAQ3 environment. The Arduino board is connected to a computer through an USB port making the device of universal use for any type of computer without the need of added internal cards. For robustness and ease of connection to the G540 a 3D printed compact box was produced to accommodate both the Arduino board and DB25 terminal. Most importantly the driving software operates under the OMDAQ3 environment, taking advantage of built-in capabilities but requiring the development (or alteration of available OMDAQ3 source codes) and compilation of specific DLL files. With code written in C++ the DLL files were created using easily accessible Embarcadero's C++ Builder Community Edition.

Apart from being a low cost system and having the perspective of a long-time compatibility with computer devices (USB specifications are expected to hold for some years) the most interesting characteristic is its integration with the OMDAQ software in charge of data acquisition in a large number of Nuclear Microprobes.

The mentioned system was successfully used in our external beam setup (1 x 1 mm² exit nozzle window dimensions) for the irradiation of easel painting coupons containing lead white pigments. The experiment and further analysis required sample irradiated areas of 8x8 mm² with accurate accumulated beam charge per unit area in order to determine exposure thresholds for minimizing or inhibiting beam irradiation alterations.

1078

Development of High Voltage Stabilization System for Nanobeam Analysis

Misako Miwa, Shigeo Matsuyama, Sho Toyama, Yuta Sato, Yohei Kikuchi

Tohoku University Department of Quantum Science and Energy Engineering Sendai-Japan

misako.miwa.c7@tohoku.ac.jp

Tohoku University has constructed a microbeam line system using a doublet system and achieved a current of 300 pA with an object size of $40 \times 10 \mu\text{m}^2$ which is equivalent to a beam size of $1 \mu\text{m} \times 1 \mu\text{m}$ [1]. For further high precision ion beam analysis, we are developing a nano ion beam system to converge the beam spot size to a nanometer. One of the technical challenges for nano ion beams is to reduce chromatic aberration and improve beam brightness. In the current microbeam line system at Tohoku University, an energy analysis system consisting of a slit and an electromagnet is placed upstream of the micro-slit that determines the object size and defines the energy width of the ion beam. Furthermore, a slit of the energy analysis system is used for slit feedback control[3]. However, in this system, beam loss occurs as the beam passes through the energy analysis system, causing a decrease in beam brightness. So a voltage control system that maintains the ion beam energy resolution in the 10^{-5} range without a slit feedback system was constructed as follows. First, a Capacitor Pick Off (CPO) plate was attached to the left and right sides of the terminal deck as well as to the center of the terminal deck, and a frequency analysis of voltage fluctuation was performed. The results showed that there were strong fluctuations around 2Hz and 5Hz, but this fluctuation was found to be due to the vibration of the generator on the terminal deck. To eliminate this effect, the voltage feedback system was changed to a feedback system using a High Voltage Divider (HVD), which is less sensitive to the vibration of the terminal deck. As a result, the ripple component of this frequency was greatly reduced. However, the HVD is less sensitive to the fluctuation component around 1 Hz, which is caused by the degradation of the vacuum tube that makes up the oscillation circuit part of the dynamitron accelerator, and the HVD is unable to suppress the fluctuation. So by adding the gain-adjusted CPO signal to the feedback signal, we were able to suppress fluctuations in this frequency range. Furthermore, by adding the CPO signal via the I/V conversion circuit which is equivalent to the differential signal of the CPO, feedback could be applied to fast fluctuations. As described above, $\Delta E/E = 6 \times 10^{-5}$ was achieved by voltage control using the HVD and high-sensitivity CPO signals, and the effect of chromatic aberration of the ion beam on the beam size was approximately 80 nm. The reduction of brightness in passing through the energy analysis system consisting of an analyzing magnet and a slit, which was used to guarantee the energy width, has been improved. It contributes greatly to the improvement of the brightness of the nano ion beam system and the microbeam.

1080

Study of beam induced carbon deposition using a dual microbeam setupToni Dunatov, Milko Jakšić, Georgios Provatas, Tonči Tadić*Ruđer Bošković Institute Department of Experimental Physics Zagreb-Croatia*

The deposition of carbon containing molecules onto samples is an effect which has long been known to occur in ion beam applications as well as in scanning electron microscopy. More recently it has become an issue with the use of ion irradiation to emulate neutron radiation damage in nuclear materials. A significant uptake of carbon in the irradiated region can change the material properties studied, and measures must be taken to reduce this phenomenon. The effect is also present to a lesser extent in other ion beam analysis (IBA) applications, where it can cause errors in the quantification of carbon and oxygen. In this work we examine the carbon deposition using the dual microbeam setup recently commissioned at RBI. This setup enables on-line monitoring of the deposition process. One microbeam is used to irradiate a small region of the sample with large current densities of heavy ions typical for the nuclear material irradiation experiments. The other microbeam is used to measure the carbon content using one of the available IBA techniques in the scattering chamber. Since this analysis is done simultaneously at both irradiated and unirradiated regions, errors induced by the measurement process are minimized.

1088

Total-IBA data analysis with DT2 and NDF, a new interface

Victoria Corregidor^{1,2}, Gonzalo Fonseca^{1,3}, Cristina Chaves^{1,3}, Luís Alves^{1,2}, M. Alexandra Barreiros⁴, Miguel Reis^{1,2,3}

¹ C2TN, Centro de Ciências e Tecnologias Nucleares

² Departamento de Engenharia e Ciências Nucleares, Instituto Superior Técnico, Universidade de Lisboa, Lisboa, Portugal

³ Ad Fisicoteca, R. Pedro Vaz Henriques, nº 7, 2560-256 Torres Vedras, Portugal

⁴ Laboratório Nacional de Energia e Geologia, UME, Estrada do Paço do Lumiar, 22, 1649-038 Lisboa, Portugal

victoria.corregidor@tecnico.ulisboa.pt

In this work, the authors reanalyse data already published [1] that were obtained using the WinNDF code [2], considering the “Total-IBA” concept. The new data analysis is done using the DT2 code for PIXE spectra fitting and NDF code for RBS spectra fitting through the recent developed software interface, “Analytical Spectrometry Software Environment for Total-IBA” (AdF_ASSET). The example chosen for this work consider different situations that can be found in the IBA data analysis, for example the use of different types of beams (particles and energy) to analyze the same samples, in this case the active layer used for perovskites solar cells. The new software offers versatility, a user friendly interface and, more important, it integrates independent software platforms to analyse dedicated spectra and considers additional effects such as the secondary X-ray fluorescence. As a result, the time-consuming for analysis is reduced providing similar results that previously obtained.

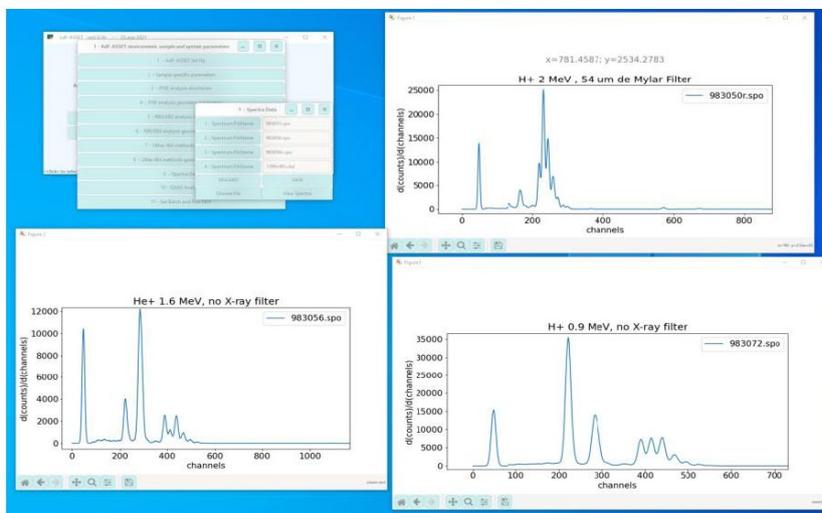


Fig.1: Visualising three PIXE spectra at the same time using the AdF_ASSET interface.

[1] M.A. Barreiros, L.C. Alves, M.J. Brites, V. Corregidor, (2017) Depth profile by Total IBA in perovskite active layers for solar cells, Nucl Instruments Methods Phys Res Sect B Beam Interact with Mater Atom, B, 404: 211-218 doi: 10.1016/j.nimb.2017.01.019

[2] N.P. Barradas, C. Jeynes, R.P. Webb (1997) Simulated annealing analysis of Rutherford backscattering data Applied Physics Letters, 71: 291-293. doi: 10.1063/1.119524

1093

Nuclear microprobe application in electrochemistry

Tao Yu¹, Huanlu Xue¹, Xin Liu¹, Xiaoyue Li², Hongjin Mou², Shimei Wang¹, Hailei Zhang¹, Renjun Jin¹, Wei Zhang¹, Hao Shen¹, Guanghua Du²

¹ Key Laboratory of Nuclear Physics and Ion-beam Application, Institute of Modern Physics, Fudan University, Shanghai 200433, China

² Institute of Modern Physics, Chinese Academy of Sciences, Lanzhou 730000, China

haoshen@fudan.edu.cn

The interface between the electrolyte solution and the solid widely exist in the natural environment, biological systems and industrial products. The solid-liquid interface between the 1 mol/L BaCl₂ solution and the Al electrode is analyzed in vacuum by micro-PIXE and RBS. The results show that an electric double layer structure of Ba²⁺ ions is formed at the interface. The concentration of Ba²⁺ ions decreases exponentially with depth. This conclusion verifies the theoretical model of the GCS electric double layer structure from the aspect of the distribution of ion. In addition, ion beam analysis can also analyze the changes of ions near the electrode with time. During the formation of the double layer, the compact layer is relatively stable, and ion attraction mainly occurs in the diffusion layer and deeper region. After applying different bias to the Al electrode, the depth distribution of the ions in electrolytic cell is also investigated. Such information is helpful for electrochemistry.

1097

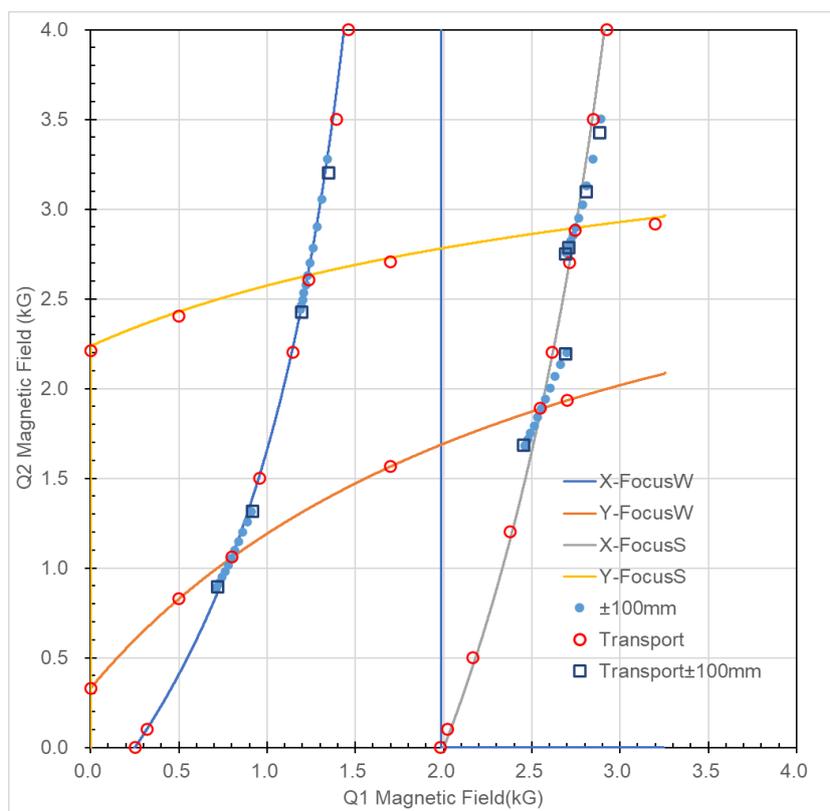
Development of focal Guide System for Microbeam formation

Shigeo Matsuyama, Misako Miwa, Sho Toyma, Tomihiro Kamiya

Department of Quantum Science and Energy Engineering, Tohoku University, 6-6-01-2, Aramaki Aza-Aoba, Aoba-ku, Sendai 980-8579, Japan

Shigeo.matsuyama.a5@tohoku.ac.jp

We have developed an automatic beam focusing system to reduce the experimental configuration time. The system involves a two-stage process of contrast and phase-difference detection that includes an automated minimization algorithm for astigmatism. The contrast method focused a microprobe to approximately $1 \mu\text{m}^2$ within 30 minutes without the need for manual control when rotational misalignment was not present, if the initial beam size is ca. $10 \times 10 \mu\text{m}^2$. It is not difficult to reduce the beam size to $10 \times 10 \mu\text{m}^2$ for the experienced user, but not easy for novice users or an untuned system. In this study, we developed focal guide system based on the thin lens approximation and the relation between focal length and magnetic field. Typical results for four quadrupole lens system are shown. The curves indicate relationships of the magnetic field strengths when one of the X- or Y axes is in focus. The focal point is the intersection of the focal lines. In this system four focal points are seen. The relation between magnetic field strength and focal depth is also shown. The present calculation is consistent with those obtained using the Transport code. The system is combined with the automatic beam focusing system.



MICROMODIFICATION

Chairs: Maria Dolores Ynsa and Luís Alves

Invited talk

1113

3D Lithography with fast protons: Proton beam writing a historic overview and outlookJeroen A. van Kan, Rudy Pang

Centre for Ion Beam Applications, Department of Physics, National University of Singapore, Singapore 117542, Singapore

phyjavk@nus.edu.sg

As protons are slowed down in materials they mainly interact with the substrate electrons, much like the incoming electrons in electron beam lithography (EBL). The big difference though is that as a proton is about 1800 times heavier than an electron, it will transfer typically a small amount of energy (~ 10 eV) to each electron it interacts with. This low energy transfer has as a direct consequence that a proton beam has a larger and straighter penetration in materials with more even energy deposition along its path compared to electron beams. Therefore using proton beams with energies ranging from keVs up to MeVs can provide unique ways to perform resist lithography and materials modification.

To exploit the unique interactions of fast protons with materials, researchers realized in the 1970s that masked exposure of resist materials can produce unique structures with high throughput and high resolution. Until the 1990s the technology to focus proton beams to submicron spot sizes was not very well developed. The introduction of improved focusing systems for light ion beams as well as the development of accelerator technology, spurred the development of proton beam writing (PBW) i.e. using focused proton beams in a direct write fashion for lithography. This led to the production of three-dimensional, high aspect ratio nanostructures with vertical, smooth sidewalls and low line-edge roughness. Typical applications can be found in the area of micro and nanofluidics, nanoimprint lithography, tissue engineering and optics.

The main limitation of wider implementation of focused proton beams in areas like PBW is the poor brightness of proton sources compared to electron beam sources. The introduction of a Nano Aperture Ion Sources (NAIS) is expected to support sub 10 nm proton beams with high currents, creating unique opportunities for PBW at significantly smaller footprint.

1027

Ionization and displacement damage effects in high-voltage vertical GaN diodes

G. Vizkelethy, W. R. Wampler, A. Armstrong, G. Pickrell, B. P. Gunning, K. E. Kropka

Sandia National Laboratories, Albuquerque, NM, USA

gvizkel@sandia.gov

Gallium-nitride (GaN) is the leading material to replace silicon and silicon-carbide in power electronics applications. Its large bandgap and large displacement threshold energy promises inherent radiation hardness against both ionization and displacement damage. In this talk, we examine the effect of displacement damage on the voltage required for impact ionization and the influence of ionizing radiation on the effective doping in the drift region.

We have investigated the effects of radiation on high-voltage (~1.8 kV) vertical GaN diodes manufactured at Sandia National Laboratories (SNL) using a nuclear microprobe and electron beam irradiation. Devices were irradiated with 1 MeV proton beam to create localized displacement damage. Ion Beam Induced Charge (IBIC) measurement was performed during and after the irradiations. We found that the onset of impact ionization was independent of the amount of damage, in this case ~ 500 V. The charge collection efficiency (CCE) below the impact ionization limit decreased with increasing damage as expected due to carrier capture and recombination at defects. Above the impact ionization limit the CCE increased with increasing displacement damage, which was attributed to trap assisted impact ionization enhancement. A simple model of IBIC was used to estimate the carrier capture rates by fitting the CCE dependence on the irradiation fluence below the impact ionization limit to the model.

Carbon is unintentionally incorporated in GaN diodes grown by metal-organic vapor epitaxy, and C increases the breakdown voltage by compensating n-type dopants. In most cases the concentration of C is not known, only the net doping. Theory predicts that during ionizing irradiation the negatively charged carbon captures holes, which leads to increased space charge and decreased breakdown voltage. We used a 70 keV electron beam to study this effect and to avoid complications due to displacement damage. Using capacitance vs. time measurements immediately after the irradiation at various temperatures, we determined the Si and C concentrations and the rate coefficient for hole capture by negatively charged carbon and the activation energy for hole emission by neutral carbon.

Sandia National Laboratories is a multi-mission laboratory managed and operated by National Technology and Engineering Solutions of Sandia LLC, a wholly owned subsidiary of Honeywell International Inc., for the U.S. Department of Energy's National Nuclear Security Administration under contract DE-NA0003525. This paper describes objective technical results and analysis. Any subjective views or opinions that might be expressed in the paper do not necessarily represent the views of the DOE or the U.S. government.

1034

Application of focused hydrogen ion beam (FHIB) on Microelectronics Fabrication

Hidetaka Hayashi

EcoDesign Promotion Network Head Office Shisui-machi-Japan

hhayashi@cba.att.ne.jp

Ionizing hydrogen molecule we can get proton and molecular type ions composed by plural protons such as H_2^+ (two protons) and H_3^+ (three protons). Accelerating these ions in a linear accelerator each ions get same kinetic energy. As the velocity is reduced by the number of protons in an ion. These ions are easily separated by mass separator. The velocity of proton defines the penetration depth into target material. This ion specific depth is very useful to form multi-level structure in material. The multi-level structure is extremely important in microelectronics. In microelectronics many miniature components are assembled in very limited space and even more the structural base is formed to get mechanical, electrical and optical functions. We will demonstrate important examples in microelectronic application. The first example is freestanding comb supported by frame structure. The comb is processed by H_3^+ beam and Frame is processed by H^+ beam. Those two ions are accelerated mixed in 1MV linear accelerator and mass separated. The other example is component container formed on flexible base film. These two examples are universal structures in microelectronic and micro-mechatronic application.

1092

Study on the Single Event Effect of PAVLOV Neuron Chip with Microbeam

Guangbo Mao^{1,3}, Jiale Quan², Jinlong Guo¹, Wenjing Liu¹, Ruqun Wu¹, Jing Zhao¹, Cheng Shen¹, Hongjin Mou¹, Guanghua Du¹

¹ Institute of Modern Physics, CAS: Nanchang Rd.509, Lanzhou, Gansu Prov., China 730000

² Institute of Microelectronics, CAS: Beitucheng West Rd.3, Beijing, China 100029

³ Lanzhou University: Tianshui South Rd.222, Lanzhou, Gansu Prov., China 730000

gh_du@impcas.ac.cn

Introduction

Artificial intelligence (AI) systems have very important application prospects in military and aerospace fields such as target recognition, on-orbit perception, automatic control and deep space exploration. Because the device architecture and operation mode of AI chips are different from traditional chips, it is necessary to study the influence of SEE, the most important irradiation effect in devices, on system reliability. In this work, a neuron chip, named PAVLOV, has been studied by simulation and microbeam experiments, trying to obtain the SEE soft error distribution and, moreover, to analyze the law of signal propagation.

Description of the Work

The PAVLOV neuron chip was designed and manufactured by the Institute of Microelectronics of the Chinese Academy of Sciences. First, the sensitive areas on the chip were obtained through simulations conducted by Cadence. Then, the laser microbeam and high energy heavy ion microbeam were used to irradiate the sensitive areas respectively. The chips were opened and thinned before the experiments to ensure that the laser photons and heavy ions could penetrate the device layer. The output signals were monitored to detect the SEE event, and at the same time the irradiation position was recorded by the scintillation imaging system. In the irradiation experiments, no SEE event was detected, indicating that the PAVLOV chip has excellent anti-irradiation performance. Some reasons have been taken out and discussed to explain the experiment results, and the unique operation mode of this neuron chip is the main factor.

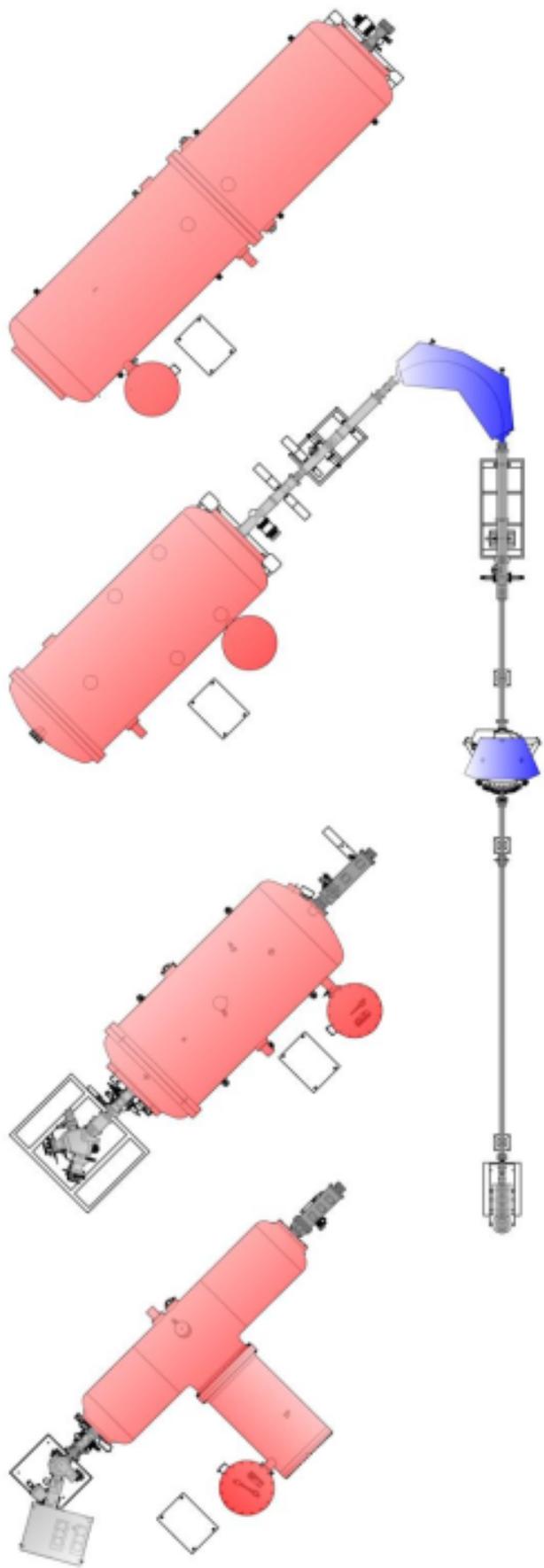
Conclusion

The PAVLOV neuron chip has excellent anti-irradiation performance because the different device architecture and operation mode.

SPONSORS

STATE OF THE ART SINGLETRON™ OR TANDETRON™ BASED μ-BEAM SYSTEMS

'The choice is yours....'



3-6 A.m ⁻² .rad ⁻² .eV ⁻¹	10-20 A.m ⁻² .rad ⁻² .eV ⁻¹	15-50 A.m ⁻² .rad ⁻² .eV ⁻¹	15-50 A.m ⁻² .rad ⁻² .eV ⁻¹
"T"-shape Tandetron	Coaxial Tandetron	Coaxial Singletron	In-line Singletron
Duoplasmatron source	Multi-cusp source	RF source	RF source



HIGH VOLTAGE ENGINEERING EUROPA B.V.

Amsterdamseweg 63, 3812 RR, Amersfoort, P.O. Box 99, 3800 AB Amersfoort, The Netherlands
 Phone: +31-33-4619741. Fax: +31-33-4615291. Trade register Amersfoort nr. 31014544
 E-mail: info@highvolteng.com – Web: www.highvolteng.com

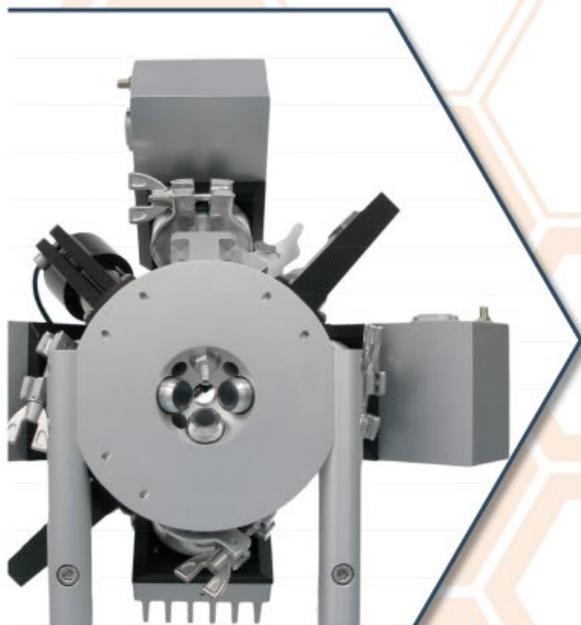


RAYSPEC

X - RAY SPECTROSCOPY

- Compatible with most PIXE chambers including Oxford Microbeam
- Detectors designed for all environments;
 - Air
 - Vacuum
 - He Flush
- Active areas from 10 to 170mm² per channel
- Full range of x-ray window options;
 - Beryllium
 - Polymer
 - Silicon Nitride
 - Graphene

Single and Multi-Sensor SDD Detectors



- Passively Cooled (fan and LN₂ free)
- DX200 Digital pulse processor available
- All designs customisable to meet requirements;
 - Tube Length
 - Flange type
 - Slide
 - Custom Geometry
 - etc...

Contact us to discuss your options

Tel: +44 (0) 1628 533060
Email: sales@rayspec.co.uk
Web: www.rayspec.co.uk

Issue 1—0820

MICRO BEAM LINE SYSTEM

WITH AUTOMATIC BEAM FOCUSING SYSTEM

MICRO BEAM LINE

HAKUTO has started selling the Japanese-made microbeamline system.

This system was developed at Tohoku University and is used in Japan in combination with 1.7MV accelerator manufactured *by National Electrostatics Corp.*

Accurate composition and density analysis of minute areas is possible with a microbeam line that can focus high-speed ion beams down to a minimum of $1\ \mu\text{m}\phi$.

In addition, the unique automatic beam focusing system greatly reduces beam adjustment work, making it possible to complete the adjustment within an hour.

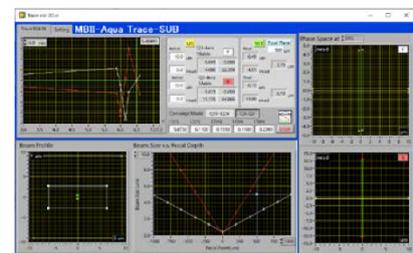
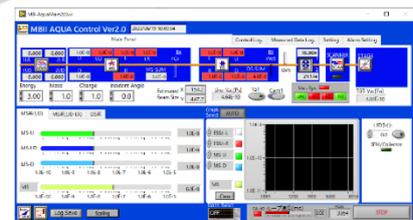
AUTOMATIC BEAM FOCUSING SYSTEM

Tohoku-University developed an automatic beam-focusing system to reduce the experimental configuration time for a submicrometer-scaled(*) beam probe of MeV ions with various analytical applications.

Parasitic aberration due to misalignment and astigmatism must be eliminated or minimized to obtain an ideal beam spot size of less than $1 \times 1\ \mu\text{m}^2$, because astigmatism from excitation error and axial misalignment broaden the beam.

The system involves a two-stage process of contrast and phase-difference detection that includes an automated minimization algorithm for astigmatism.

The contrast method focused a proton microprobe to approximately $1\ \mu\text{m}^2$ within 30 min, without the need for manual control when rotational misalignment was not present, while the phase-difference method successfully reduced the rotational error of lenses.



(References: Nuclear Instruments and Methods in Physics Research B 496 (2021) 1–8)

Features

- ☒ Beam spot size $\geq 1\ \mu\text{m}$ (*submicrometer-scaled depend on accelerator)
(Object: $10 \times 40\ \mu\text{m}^2$ / Divergence: $0.2 \times 0.2\ \text{mrad}^2$)
- ☒ Compact beamline length: 7m (from Object to TGT)
- ☒ Automatic beam-focusing system (Set up: 30min for $1\ \mu\text{m}$)
- ☒ User-friendly software system
- ☒ Possible to be upgraded and customized an existing system

* Please visit our booth or WEB page for more details !



(SYSTEM PRODUCTS COMPANY)

Head office: 1-13, Shinjuku 1-Chome, Shinjuku-Ku, Tokyo 160-8910 TEL: +81-3-3225-8052

Email: G5@hakuto.co.jp WEB: <https://g5-hakuto.jp/index.html>



MIRION
TECHNOLOGIES



Canberra
Packard



DETECTORS FOR CHALLENGING APPLICATIONS

MIRION IS THE LEADING PROVIDER OF INNOVATIVE AND COST-EFFECTIVE NUCLEAR MEASUREMENT SOLUTIONS USED TO MAINTAIN SAFETY, ASSESS THE HEALTH OF NUCLEAR FACILITIES AND SAFEGUARD THE PUBLIC AND THE ENVIRONMENT.

Since 1968, Mirion has also been committed to the development, manufacturing and service of unique specialty detectors for international scientific experiments and specialty designs.

Driven by diverse needs in fundamental and applied research applications, a range of technologies has been developed over many years that enables Mirion to maintain its technological leadership in semiconductor detector development.

Mirion has been supplying detectors and instrumentation used in cutting-edge materials analysis, physics, and space studies to some of the world's leading industries and research institutes. Mirion's dedicated R&D structure allows us to deliver innovative nuclear detection systems based on a comprehensive exploration of all available and emerging technologies.

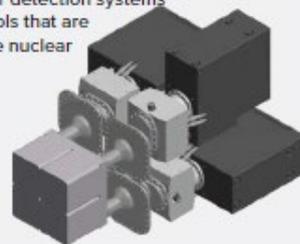
Our passion for fully understanding the needs of our customers is key to our ability to provide the best solutions to contribute to their success.

State of the art breakthrough technologies developed by Mirion include:

- Array of several detectors in a unique cryostat
- Encapsulation and Ultra High Vacuum (UHV) sealing
- Segmentation of detector electrodes

These versatile technologies are not only the tools with which Canberra™ nuclear detection systems are built, but also the tools that are building the future of the nuclear industry.

Complex First Electrically-Cooled Clover Array Detector



NeoDry Series Compact & Aircooled Dry Pump

An air cooled vacuum pump for low cost of ownership, long life & long maintenance cycle.
Fits right in for industrial application such as analytical, R&D laboratory equipment.



MANY ADVANTAGES OVER ROTARY VANE AND SCROLL PUMPS

DE.KASHIYAMA.COM



CLEAN MULTI-STAGE ROOTS PUMP
NO OIL VAPOR, NO PARTICLE GENERATION, NO PTFE TIP SEAL DUST



AVG. OF 6 YEARS MAINTENANCE-FREE OPERATION FOR CLEAN GAS USAGE
PERFORMANCE OF OUR PUMP OVER 10 YEARS ON THE MARKET BASED ON A REVIEW OF OUR RECORDS



OPTIMAL BACKING PUMP FOR UHV APPLICATIONS
LOW BASE PRESSURE, HIGH COMPRESSION FOR LIGHT GASES



HIGH WATER VAPOR CAPACITY OF UP TO 600G/H
AND OPTIONAL SPECIAL COATED VERSION FOR CHEMICAL RESISTANCE



VARIOUS CHOICES WITH MARKET-PROVEN RELIABILITY
6 MODELS FROM 7 TO 300 M³/H WITH HIGH RELIABILITY FOR A VARIETY OF SYSTEMS

Kashiyama
Vacuum Solutions

Kashiyama Europe GmbH
Leopoldstrasse 244
80807 Munich, Germany
Tel + 49 (0)89 208039 455
de.kashiyama.com



Instro d.o.o.
Preglov trg 11
1000 Ljubljana, Slovenija
Tel +386 (0)40 243 755

Established in 1986, Oxford Microbeams Ltd is the world's leading supplier of high energy ion micro-beam equipment and software, with over 40 systems sold in 5 continents.

OM is an approved supplier for the International Atomic Energy Agency [IAEA].

High precision magnetic quadrupole lenses
Precision slits • High stability power supplies
Beam scanning systems • Target chambers • External beam systems • Data acquisition electronics • Proton beam writing systems • Cell irradiation systems • High rigidity focusing system for MeV-SIMS • Fully integrated data acquisition, processing and control software • Customised designs

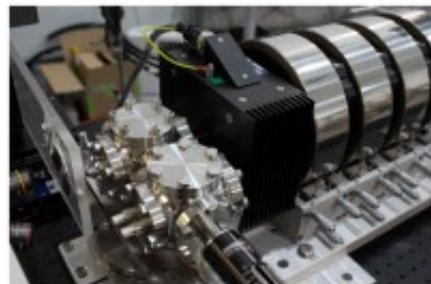
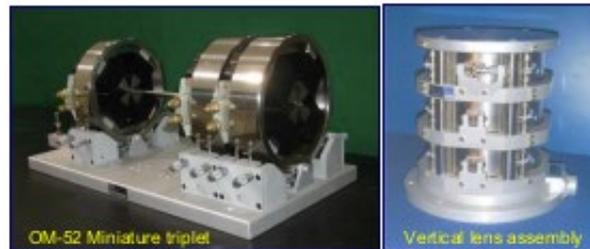
Application areas:

- PIXE and PIXE mapping
- RBS and RBS mapping
- Proton Radiobiology
- MeVSIMS mapping
- Targeted single ion irradiation
- Proton beam writing
- External beams for cultural heritage studies
- Scanning Transmission Ion Microscopy
- Heavy ion microbeams (to 150 MeV.amu/q²)
- Ionoluminescence microscopy
- Elastic Recoil Detection Analysis
- Ion induced secondary electron imaging
- Direct-write Ion Beam implantation and patterning of materials
- Channeling Contrast microscopy
- Ion Beam Induced Charge microscopy

Performance of OM systems:

OM2000 Oxford triplet endstation:
300 x 450 nm at 50pA (2MeV protons).
900 x 900 nm at 1 nA (2.5MeV protons)

Oxford triplet configuration of OM-52 lenses:
Spot sizes of 20 x 25nm have been achieved for low current applications, and 20nm high aspect ratio structures have been written using proton beam writing.



Radiobiology Endstation using OM post lens scan coil and Oxford triplet (photo courtesy of CIBA, Singapore)



OM DAQ3 Data acquisition and control software

Now with interfaces for

- High speed digital pulse processors
- High speed TDC for ToF MeVSIMS applications

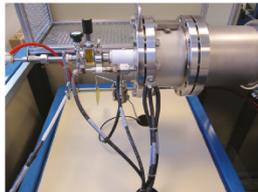




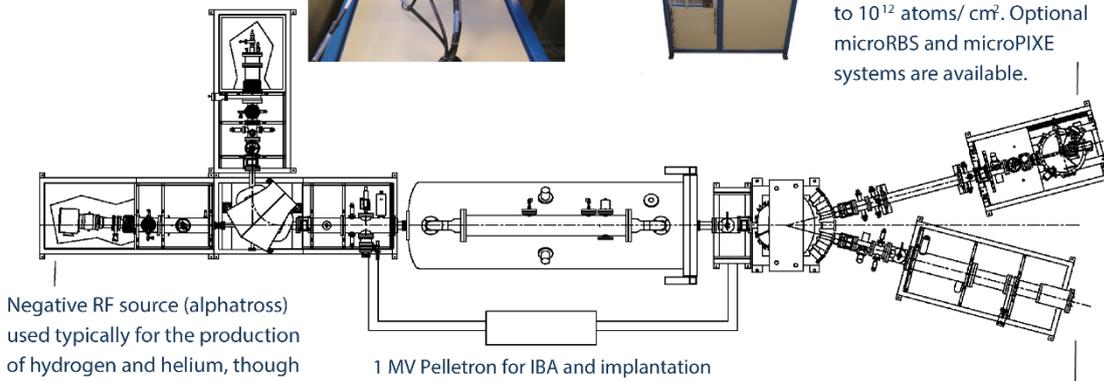
How Science BREAKS THROUGH

NEC offers research grade implantation and Ion Beam Analysis chambers in one system
– systems can include heavy ion sources for implantation and light ion sources for IBA

SNICS ion source capable of producing all negative ions across the periodic table except noble gases



Analysis endstation that can include detector for RBS, Channeling, ERD, PIXE, PIGE, NRA, and IBIL. Offers monolayer depth resolution and sensitivity to 10^{12} atoms/cm². Optional microRBS and microPIXE systems are available.



Negative RF source (alphatross) used typically for the production of hydrogen and helium, though can also produce beams from other gases such as oxygen and nitrogen

1 MV Pelletron for IBA and implantation



Single and multi-wafer implant chambers are available as well as custom chambers based on user specifications. Typical implantation range from 10^{12} to 10^{17} atoms/cm²

How are samples affected or changed when interacting with ion beams?

To find out, NEC offers:

- Open Air ion implantation systems for beam energies in the 50 to 500 keV range.
- Single-ended or tandem accelerators for beam energies from 10's of keV to 10's of MeV.
- High temperature (800° C) and low temperature implant chambers.

Contact NEC

 www.pelletron.com

 nec@pelletron.com

 +1 (608) 831-7600

 7540 Graber Road
Middleton, WI 53562-0310 USA

Need High Pumping Speed?



The Most Reliable Hybrid Bearing Turbopump HiPace® 80 Neo



Your added value

- Minimal vibration thanks to patented Laser Balancing technology
- High pumping speed and highest compression for all gases
- Ultra-compact design with maximum performance
- Extended thermal working range
- Durable, cost-effective and virtually maintenance-free

SCAN d.o.o. Preddvor
info@scan.si
Pfeiffer Vacuum Austria GmbH
office@pfeiffer-vacuum.at

PFEIFFER  **VACUUM**
Your Success. Our Passion.


www.pfeiffer-vacuum.com